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Issued date FCC ID

: February 19, 2014 : 2ABS4-WHD0070

Revised date

: February 28, 2014

RADIO TEST REPORT

Test Report No.: 10068267S-H

Applicant

Hitachi Maxell, Ltd.

Type of Equipment

Wireless Display Module

Model No.

WHD0070-D103

FCC ID

2ABS4-WHD0070

Test regulation

FCC Part15 Subpart C: 2013

Test result

Complied

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- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with the limits of the above regulation.
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- 5. This test report must not be used by the customer to claim product certification, approval, or endorsement by any agency of the Federal Government.
- 6. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.

Date of test:

November 10, 2013 to February 10, 2014

Tested by:

Shinichi Takano Engineer of WiSE Japan, UL Verification Service

Approved by:

Toyokazu Imamura Leader of WiSE Japan, UL Verification Service





The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.

There is no testing item of "Non-accreditation".

UL Japan, Inc.

Shonan EMC Lab.

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REVISION HISTORY

Original Test Report No.: 10068267S-H

Revision	Test report No.	Date	Page revised	Contents
- (Original)	10068267S-H	February 19, 2014	-	-
1	10068267S-H	February 28, 2014	13	Correction of typo (10.3 Test conditions)
		•		

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SECTION 1: Customer information

Company Name : Hitachi Maxell, Ltd.

Address : 292 Yoshida-cho, Totsuka-ku, Yokohama-shi, Kanagawa, 244-0817 Japan

Telephone Number : +81 50 3152 1784 Facsimile Number : +81 45 866 5936 Contact Person : Hiroyuki Urata

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Wireless Display Module

Model Number : WHD0070-D103

Serial Number : Refer to 4.2 in this report.

Rating : DC5V Country of Mass-production : China

Condition of EUT : Engineering prototype

(Not for Sale: This sample is equivalent to mass-produced items.)

Receipt Date of Sample : November 5, 2013

Modification of EUT : No modification by the test lab.

2.2 Product description

Model: WHD0070-D103 (referred to as the EUT in this report) is a Wireless Display Module.

Clock frequency(ies) in the system : 19.2MHz, 20MHz

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Radio specification:

Equipment type : Transceiver

Frequency of operation *1) : 2.4GHz: 2412-2462MHz (IEEE 802.11b, 11g, 11n (HT20))

2422-2452MHz (IEEE 802.11n (HT40))

5GHz (W52): 5180-5240MHz (IEEE 802.11a, 11n (HT20))

5190-5230MHz (IEEE 802.11n (HT40))

5GHz (W58): 5745-5825MHz (IEEE 802.11a, 11n (HT20))

5755-5795MHz (IEEE 802.11n (HT40))

Bandwidth : 20MHz (IEEE 802.11a/b/g/n), 40MHz (IEEE 802.11n)

Channel spacing : 5MHz (2.4GHz),

20MHz (IEEE 802.11a, 11n (HT20, 5GHz)), 40MHz (IEEE 802.11n (HT40, 5GHz))

Type of modulation : DSSS, OFDM Antenna type *2) : PCB Antenna

Antenna connector type : U.FL ITU code : D1D, G1D Operation temperature range : 0 to +40 deg.C *1) Refer to the test report 10068267S-I for FCC 15.407.

*2) The EUT has 3-type of antenna. One of the antennas is connected to the product.

No.	Antenna	Antenna model	Antenna	2.4G gain	5G gain	Cable length	Remark
	Brand		type	(dBi)	(dBi)	(mm)	
1	Hitachi	WHD0070-A300	PIFA	0.49	1.77	300	-
2	Hitachi	WHD0070-A400	PIFA	0.34	1.09	400	-
3	Hitachi	WHD0070-A500	PIFA	-0.76	1.09	500	-

The testing has been performed using WHD0070-A300 which has the highest antenna gain.

FCC 15.31 (e) / 212

The RF Module has its own regulator. The RF Module is constantly provided voltage (DC3.3V, DC1.2V, DC1.8V) through the regulator regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC 15.203 / 212

The EUT has a unique coupling/antenna connector (U.FL). Therefore the equipment complies with the requirement.

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^{*} The EUT does not perform simultaneous transmission of 2.4GHz and 5GHz Wireless LAN.

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SECTION 3: Test specification, procedures & results

3.1 Test specification

Test specification : FCC Part 15 Subpart C: 2013,

final revised on September 30, 2013 and effective October 30, 2013

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators

Section 15.207 Conducted limits

Section 15.209 Radiated emission limits, general requirements

Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz,

and 5725-5850MHz

3.2 Procedures & Results

Item	Test Procedure *1)	Specification	Remarks	Deviation	Worst Margin	Results
Conducted emission	ANSI C63.10:2009	FCC 15.207	-	N/A	20.8dB Freq.: 28.96700 MHz Detection: Average Phase: L1 Mode: Tx 2412MHz IEEE 802.11n (HT20), CDD	Complied
6dB bandwidth	ANSI C63.10:2009	FCC 15.247 (a)(2)	Conducted	N/A		Complied
Maximum peak output power	ANSI C63.10:2009	FCC 15.247 (b)(3)	Conducted	N/A	* See data	Complied
Out of band emission & Restricted band edges	ANSI C63.10:2009	FCC 15.109, 15.247 (d) & 15.209	Conducted / Radiated	N/A	1.1dB Freq.: 78.935MHz Polarization: Vertical Detection: Quasi-Peak Mode: Tx 2412MHz IEEE 802.11n (HT20), CDD	Complied
Power density	ANSI C63.10:2009	FCC 15.247 (e)	Conducted	N/A	* See data	Complied

Note: UL Japan's EMI Work Procedures No.13-EM-W0420 and 13-EM-W0422.

Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Worst Margin	Results	
Occupied Bandwidth (99%)	ANSI C63.10:2009, RSS-Gen 4.6.1	-	Conducted	-	-	
Note: UL Japan's Work Procedures No. 13-EM-W0420 and 13-EM-W0422						

^{*} Other than above, no addition, exclusion nor deviation has been made from the standard.

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^{*1)} These tests were also referred to KDB 558074 v03 r01 (FCC), "Guidance for Performing Compliance

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3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Item	Frequency range	No.1 SAC*1/SR*2 (±)	No.2 SAC/SR (±)	No.3 SAC/SR (±)
Conducted emission (AC Mains) LISN	150kHz-30MHz	3.6 dB	3.6 dB	3.5 dB
Radiated emission	9kHz-30MHz	3.7 dB	3.7 dB	3.6 dB
(Measurement distance: 3m)	30MHz-300MHz	4.8 dB	5.0 dB	4.8 dB
	300MHz-1GHz	5.0 dB	5.0 dB	4.8 dB
	1GHz-15GHz	4.9 dB	4.9 dB	4.9 dB
Radiated emission	15GHz-18GHz	5.7 dB	5.6 dB	5.6 dB
(Measurement distance: 1m)	18GHz-40GHz	5.2 dB	4.3 dB	4.3 dB

^{*1:} SAC=Semi-Anechoic Chamber

Conducted emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Antenna port conducted test

Power measurement uncertainty above 1GHz for this test was: (±) 1.5dB

Spurious emission (Conducted) measurement (below 1GHz) uncertainty for this test was: (±) 1.6dB

Spurious emission (Conducted) measurement (1G-3GHz) uncertainty for this test was: (±) 1.4dB

Spurious emission (Conducted) measurement (3G-18GHz) uncertainty for this test was: (±) 2.8dB

Spurious emission (Conducted) measurement (18G-26.5GHz) uncertainty for this test was: (±) 2.5dB

Bandwidth measurement uncertainty for this test was: (±) 5.4%

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^{*2:} SR= Shielded Room is applied besides radiated emission

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3.5 Test location

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Telephone number : +81 463 50 6400 Facsimile number : +81 463 50 6401 JAB Accreditation No. : RTL02610

	FCC Registration No.	IC Registration No.	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
☐ No.1 semi-anechoic chamber	697847	2973D-1	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
☑ No.2 semi-anechoic chamber	697847	2973D-2	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
☑ No.3 semi-anechoic chamber	697847	2973D-3	12.7 x 7.7 x 5.35	12.7 x 7.7	5m
☐ No.4 semi-anechoic chamber	-	-	8.1 x 5.1 x 3.55	8.1 x 5.1	=
☐ No.1 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	=
☐ No.2 shielded room	-	-	6.8 x 4.1 x 2.7	6.8 x 4.1	=
☑ No.3 shielded room	-	-	6.3 x 4.7 x 2.7	6.3 x 4.7	-
☐ No.4 shielded room	-	-	4.4 x 4.7 x 2.7	4.4 x 4.7	=
☑ No.5 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
☐ No.6 shielded room	-	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
☐ No.7 shielded room	-	-	2.76 x 3.76 x 2.4	2.76 x 3.76	-
☐ No.1 measurement room	-	-	2.55 x 4.1 x 2.5	-	-

3.6 Test setup, Test data & Test instruments

Refer to APPENDIX 1 to 3.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating mode

.1 Operating mode						
Test item	Mode	Tested frequency	Worst data mode *1)			
Conducted emission	Transmitting IEEE 802.11n (HT20),	2412MHz	PN9, MCS2			
Radiated emission	CDD *4)	5745MHz	PN9, MCS0			
(below 1GHz) *2)						
Radiated emission	Transmitting IEEE 802.11b	2412MHz, 2437MHz, 2462MHz	PN9, 1Mbps			
(above 1GHz) *5)	Transmitting IEEE 802.11g	2412MHz, 2437MHz, 2462MHz	PN9, 6Mbps			
	Transmitting IEEE 802.11n (HT20), CDD *4)	2412MHz, 2437MHz, 2462MHz	PN9, MCS2			
	Transmitting IEEE 802.11n (HT40), CDD *4)	2422MHz, 2437MHz, 2452MHz	PN9, MCS0			
	Transmitting IEEE 802.11a	5745MHz, 5785MHz, 5825MHz	PN9, 6Mbps			
	Transmitting IEEE 802.11n (HT20), CDD *4)	5745MHz, 5785MHz, 5825MHz	PN9, MCS0			
	Transmitting IEEE 802.11n (HT40), CDD *4)	5755MHz, 5795MHz	PN9, MCS0			
Other items	Transmitting IEEE 802.11b	2412MHz, 2437MHz, 2462MHz	PN9, 1Mbps			
	Transmitting IEEE 802.11g	2412MHz, 2437MHz, 2462MHz	PN9, 6Mbps			
	Transmitting IEEE 802.11n (HT20), SISO	2412MHz, 2437MHz, 2462MHz	PN9, MCS2			
	Transmitting IEEE 802.11n (HT20), CDD *4)	2412MHz, 2437MHz, 2462MHz	PN9, MCS2			
	Transmitting IEEE 802.11n (HT20), SDM (MIMO) *3)	2412MHz, 2437MHz, 2462MHz	PN9, MCS10			
	Transmitting IEEE 802.11n (HT40), SISO	2422MHz, 2437MHz, 2452MHz	PN9, MCS0			
	Transmitting IEEE 802.11n (HT40), CDD *4)	2422MHz, 2437MHz, 2452MHz	PN9, MCS0			
	Transmitting IEEE 802.11n (HT40), SDM (MIMO) *3)	2422MHz, 2437MHz, 2452MHz	PN9, MCS8			
	Transmitting IEEE 802.11a	5745MHz, 5785MHz, 5825MHz	PN9, 6Mbps			
	Transmitting IEEE 802.11n (HT20) SISO	5745MHz, 5785MHz, 5825MHz	PN9, MCS0			
	Transmitting IEEE 802.11n (HT20), CDD *4)	5745MHz, 5785MHz, 5825MHz	PN9, MCS0			
	Transmitting IEEE 802.11n (HT20), SDM (MIMO) *3)	5745MHz, 5785MHz, 5825MHz	PN9, MCS8			
	Transmitting IEEE 802.11n (HT40) SISO	5755MHz, 5795MHz	PN9, MCS0			
	Transmitting IEEE 802.11n (HT40), CDD *4)	5755MHz, 5795MHz	PN9, MCS0			
	Transmitting IEEE 802.11n (HT40), SDM (MIMO) *3)	5755MHz, 5795MHz	PN9, MCS8			

^{*1)} The worst condition was determined based on the test result of Maximum Peak Output Power.

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^{*2)} Test operating mode was determined as follows according to "Section 1 of 6 802.11 a/b/g/n testing- Managing Complex Regulatory Approvals - "of TCB Council Workshop October 2009.

^{*3)} As this transmitter has SDM (MIMO) mode for only MCS8 to MCS15, we need not to consider array gains.

^{*4)} The EUT has CDD mode for MCS0 to MCS7. Directional gain is below 6dB, if correlation gain is considered.

^{*5}) CDD mode was selected in SISO / CDD / SDM (MIMO) for IEEE 802.11n (HT20) and IEEE 802.11n (HT40), based on the test result of Maximum Peak Output Power.

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EUT has the power settings by the software as follows;

Test software: MTool.exe, ver. 1.0.0.9

Power settings:

2.4GHz: IEEE 802.11b: 54, IEEE 802.11g: 48, IEEE 802.11n (HT20): 48, IEEE 802.11n (HT40): 48

5GHz: IEEE 802.11a: 50, IEEE 802.11n (HT20): 50, IEEE 802.11n (HT40): 50

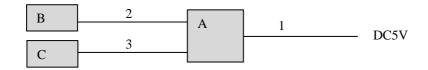
Measured antenna port:

Total and an						
	Single output	Multi output				
	(IEEE 802.11a, 11b, 11g, 11n SISO)	(IEEE 802.11n CDD, 11n SDM(MIMO))				
Maximum peak output	- Antenna 0	Antenna 0 + Antenna 1				
power	- Antenna 1					
Radiated emission	- Antenna 0 or Antenna 1 *1)	Antenna 0 + Antenna 1				
Other tests	- Antenna 0 or Antenna 1 *1)	Antenna 0 or Antenna 1 *1)				

^{*1)} The worse antenna port was determined based on the test result of Maximum Peak Output Power.

Justification: The system was configured in typical fashion (as customer would normally use it) for testing.

4.2 Configuration and peripherals



^{*} Test data was taken under worse case conditions.

Description of EUT and support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Wireless Display Module	WHD0070-D103	*1)	Askey Computer Corp.	EUT
В	Planar Inverted F Antenna	WHD0070-A300	1	Askey Computer Corp.	EUT
C	Planar Inverted F Antenna	WHD0070-A300	2	Askey Computer Corp.	EUT

^{*1)} Conducted / Radiated emission: C0:D9:62:FF:E6:F4, Other test: C0:D9:62:FF:E6:DA

List of cables used

No.	Cable Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	USB	2.1	Shielded	Shielded	-
2	Antenna	0.3	Shielded	Shielded	-
3	Antenna	0.3	Shielded	Shielded	-

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SECTION 5: Conducted emission

5.1 Operating environment

Test place : See test data (APPENDIX 1)
Temperature : See test data (APPENDIX 1)
Humidity : See test data (APPENDIX 1)

5.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 1.5m, raised 0.8m above the conducting ground plane.

The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity.

The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals was aligned and was flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from LISN.

Each EUT current-carrying power lead, except the ground (safety) lead, was individually connected through a LISN to the input power source. All unused 50ohm connectors of the LISN were resistively terminated in 50ohm when not connected to the measuring equipment.

Photographs of the set up are shown in APPENDIX 3.

5.3 Test conditions

Frequency range : 0.15 - 30MHz EUT position : Table top

5.4 Test procedure

The AC Mains Terminal Continuous disturbance Voltage had been measured with the EUT within a Shielded room. The EUT was connected to a Line Impedance Stabilization Network (LISN) via DC power supply.

An overview sweep with peak detection has been performed.

The measurements had been performed with a quasi-peak detector and if required, a CISPR average detector.

The conducted emission measurements were made with the following detection of the test receiver.

Detection Type : Ouasi-Peak/ CISPR Average

IF Bandwidth : 9kHz

5.5 Results

Summary of the test results: Pass

Refer to APPENDIX 1.

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SECTION 6: 6dB bandwidth & Occupied bandwidth (99%)

Test procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.

The test was measured based on Method 8.1 Option 1 and 8.2 Option 2 of "Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

Summary of the test results: Pass

Refer to APPENDIX 1.

SECTION 7: Maximum peak output power

Test procedure

The Maximum Peak Output Power was measured with a power meter connected to the antenna port.

The test was measured based on Method 9.1.3 PKPM1 of "Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

Summary of the test results: Pass

Refer to APPENDIX 1.

SECTION 8: Out of band emissions (Antenna port conducted)

Test procedure

The Out of Band Emissions was measured with a spectrum analyzer connected to the antenna port.

In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement. In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.

Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart. (9kHz-150kHz:RBW=200Hz, 150kHz-30MHz:RBW=10kHz)

Summary of the test results: Pass

Refer to APPENDIX 1.

SECTION 9: Peak power density

Test procedure

The peak power density was measured with a spectrum analyzer connected to the antenna port.

Instrument used : Spectrum Analyzer RBW / VBW : 3kHz / 9.1kHz

The test was measured based on Method 10.2 PKPSD of "Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

Summary of the test results: Pass

Refer to APPENDIX 1.

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SECTION 10: Radiated emission

10.1 Operating environment

Test place : See test data (APPENDIX 1)
Temperature : See test data (APPENDIX 1)
Humidity : See test data (APPENDIX 1)

10.2 Test configuration

EUT was placed on a urethane platform of nominal size, 0.5m by 0.5m, raised 0.8m above the conducting ground plane. Photographs of the set up are shown in APPENDIX 3.

10.3 Test conditions

Frequency range : 30MHz - 40GHz

EUT position : Table top

10.4 Test procedure

The Radiated Electric Field Strength intensity has been measured on a semi-anechoic chamber with a ground plane and at a distance of 3m (below 15GHz) / 1m (above 15GHz) (Refer to Figure 1). Measurements were performed with quasi-peak, peak and average detector. The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detection.

Frequency	30-1000MHz	1-40GHz		20dBc
Detection type	Quasi-Peak	Peak	Average *1)	Peak
IF Bandwidth	120kHz	RBW: 1MHz	RBW: 1MHz	RBW: 100kHz
		VBW: 3MHz	VBW: 3MHz	VBW: 300kHz
			Detector: RMS	

^{*1)} Average Power Measurement was measured based on 12.2.5 of "Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

The carrier levels and noise levels were confirmed at each position of X, Y and Z axes to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Worst case:

2.4GHz band

Subject	Antenna polarization	Carrier	Spurious				
	_		Below 1GHz	1-2.8GHz	2.8-25GHz		
Module	Horizontal	Y	Y	Y	Z		
Antenna		X	X	X	Y		
Module	Vertical	Y	Y	Y	Y		
Antenna		Z	X	Z	Z		

5GHz band

Subject	Antenna polarization	Carrier	Spurious				
			Below 1GHz	1-6.4GHz	6.4-40GHz		
Module	Horizontal	Y	Y	Y	Y		
Antenna		Y	X	Y	X		
Module	Vertical	Y	Y	Y	Y		
Antenna		Z	X	Z	X		

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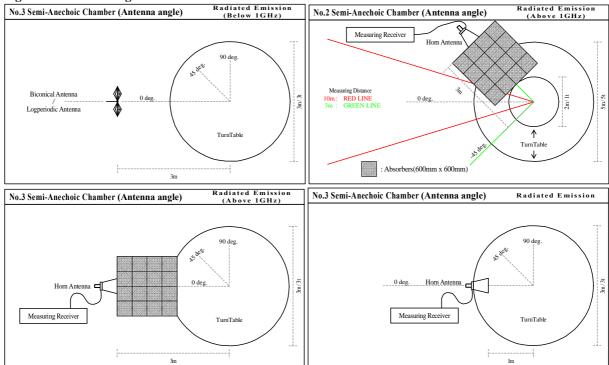
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Figure 1. Antenna angle



10.5 Band edge

Band edge level at 2390MHz and 2483.5MHz is below the limits of FCC 15.209 and band edge level at 2400MHz, 5725MHz and 5850MHz is below the 20dBc. Refer to the data.

10.6 Results

Summary of the test results: Pass

* No noise was detected above the 3rd order harmonics.

Refer to APPENDIX 1.

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6dB bandwidth
Maximum peak output power
Radiated emission
Spurious emission (Antenna port conducted)
Peak power density
Occupied bandwidth

APPENDIX 2: Test instruments

Test instruments

APPENDIX 3: Photographs of test setup

Conducted emission Radiated emission Pre-check of the worst position

UL Japan, Inc. Shonan EMC Lab.

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DATA OF CONDUCTED EMISSION TEST

UL Japan, Inc. Shonan EMC Lab. No.3 Shielded Room

Date: 2013/11/26

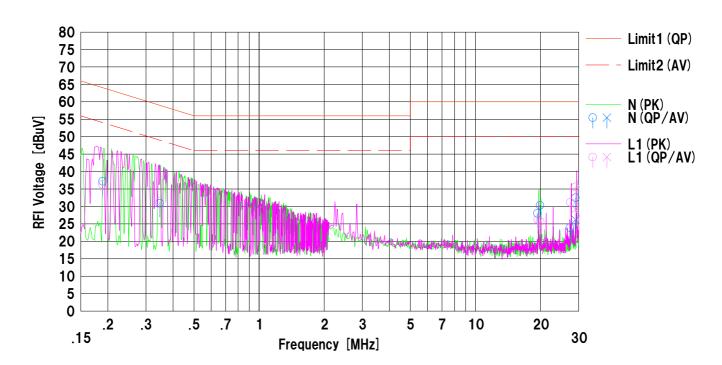
Company Kind of EUT Tx,11n (HT20),CDD,2412MHz : Hitachi Maxell, Ltd. Mode

Wireless Display Module Order No. 100682678 : DC 5V : 25deg.C / 42%RH Model No. WHD0070-D103 Power

Temp./Humi. Serial No. C0:D9:62:FF:E6:F4 Remarks

 $\begin{array}{l} Limit1: FCC \ 15C \ (15.207) \ QP \\ Limit2: FCC \ 15C \ (15.207) \ AV \end{array}$

Engineer : Tatsuya Arai



	5	Rea	ding	0.5	Res	ults	Lin	nit	Mar	gin		
No.	Freq.	<qp></qp>	<av></av>	C.Fac	<qp></qp>	<av></av>	<qp></qp>	<av></av>	<qp></qp>	<av></av>	Phase	Comment
\square	[MHz]	[dBuV]	[dBuV]	[dB]	[d Bu V]	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]		
1	0.18921	24.5		12.7	37.2		64.0	54.0	26.8		N	
2	0.34726	18.2		12.7	30.9		59.0	49.0	28.1		N	
3	19.33900	14.5		13.5	28.0		60.0	50.0	32.0		N	
4	19.88990	16.7		13.6	30.3		60.0	50.0	29.7		N	
5	27.37700	10.1		13.8	23.9		60.0	50.0	36.1		N	
6	28.97700	18.6	12.3	13.9	32.5	26.2	60.0	50.0	27.5	23.8	N	
7	0.18921	23.6		12.7	36.3		64.0	54.0	27.7		L1	
8	0.34726	18.8		12.7	31.5		59.0	49.0	27.5		L1	
9	19.37950	12.6		13.6	26.2		60.0	50.0	33.8		L1	
10	19.92150	12.1		13.6	25.7		60.0	50.0	34.3		L1	
11	27.53600	17.4		13.8	31.2		60.0	50.0	28.8		L1	
12	28.96700	21.7	15.3	13.9	35.6	29.2	60.0	50.0	24.4	20.8	L1	

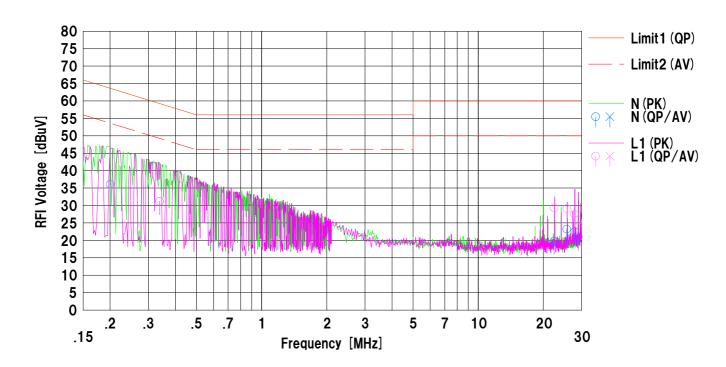
DATA OF CONDUCTED EMISSION TEST

UL Japan,Inc. Shonan EMC Lab. No.3 Shielded Room Date: 2013/11/26

: Hitachi Maxell, Ltd. Mode

: Tx,11n (HT20),CDD,5745MHz : 10068267S : DC 5V : 25deg.C / 42%RH Company Kind of EUT Model No. Wireless Display Module WHD0070 - D103 Order No. Power C0:D9:62:FF:E6:F4 Temp./Humi. Serial No. Remarks

Limit1: FCC 15C (15.207) QP Limit2: FCC 15C (15.207) AV **Engineer** : Tatsuya Arai



	Freq.	Rea	ding	C.Fac	Res	ults	Lin	nit	Mai	rgin		
No.		<qp></qp>	<av></av>		<qp></qp>	<av></av>	<qp></qp>	<av></av>	<qp></qp>	<av></av>	Phase	Comment
	[MHz]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]		
1	0.20027	23.4		12.7	36.1		63.5	53.5	27.4		N	
2	0.33880	18.5		12.7	31.2		59.2	49.2	28.0		N	
3	22.41700	6.2		13.6	19.8		60.0	50.0	40.2		N	
4	25.60800	9.5		13.7	23.2		60.0	50.0	36.8		N	
5	27.93379	8.7		13.8	22.5		60.0	50.0	37.5		N	
6	28.97117	7.1		13.9	21.0		60.0	50.0	39.0		N	
7	0.20027	23.3		12.7	36.0		63.5	53.5	27.5		L1	
8	0.33880	18.5		12.7	31.2		59.2	49.2	28.0		L1	
9	22.44850	15.7		13.6	29.3		60.0	50.0	30.7		L1	
10	25.65200	15.4		13.7	29.1		60.0	50.0	30.9		L1	
11	27.79150	13.7		13.8	27.5		60.0	50.0	32.5		L1	
12	28.83250	11.8		13.9	25.7		60.0	50.0	34.3		L1	

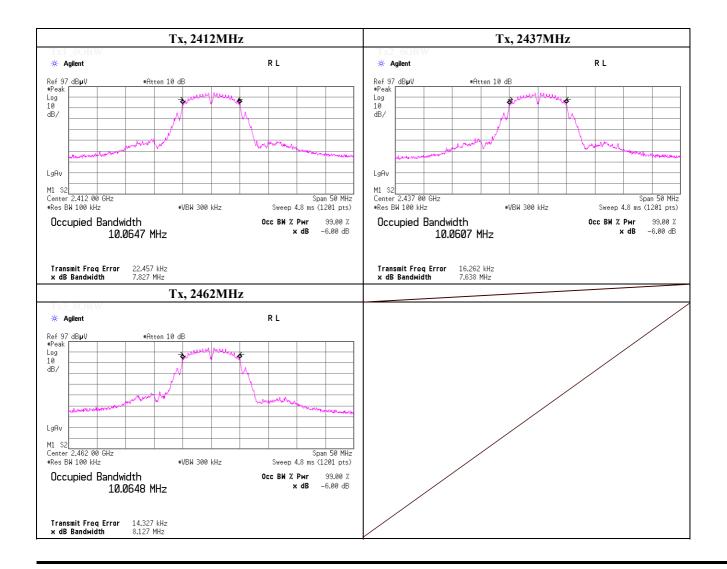
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013
Temperature / Humidity 22deg.C , 31%RH
Engineer Shinichi Takano

Mode Tx, IEEE802.11b, PN9, worst antenna port 0, worst data mode 1Mbps

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
2412.0000	7.827	> 0.500
2437.0000	7.638	> 0.500
2462.0000	8.127	> 0.500



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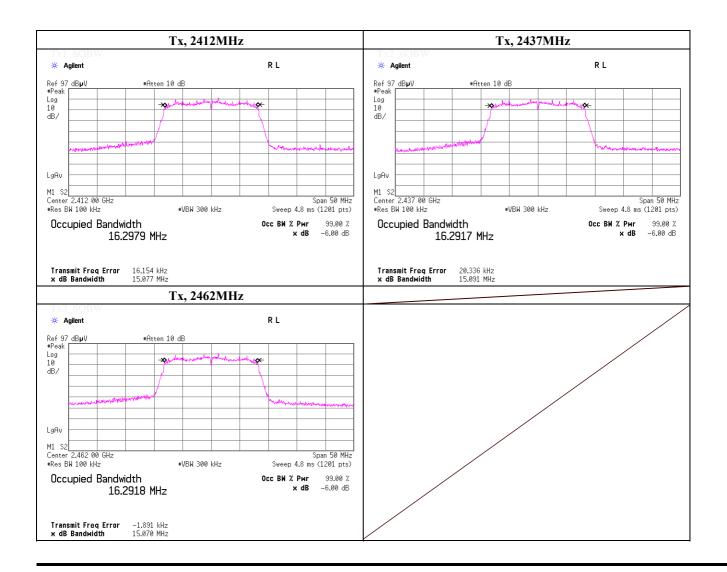
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013
Temperature / Humidity 22deg.C , 31%RH
Engineer Shinichi Takano

Mode Tx, IEEE802.11g, PN9, worst antenna port 0, worst data mode 6Mbps

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
2412.0000	15.077	> 0.500
2437.0000	15.091	> 0.500
2462.0000	15.070	> 0.500



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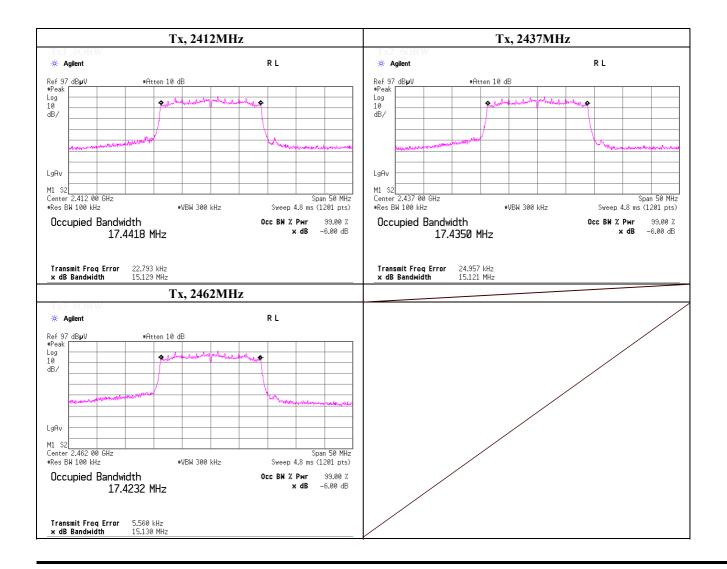
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Mode Tx, IEEE802.11n(HT20), SISO, PN9, worst antenna port 0, worst data mode 2(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
2412.0000	15.129	> 0.500
2437.0000	15.121	> 0.500
2462.0000	15.130	> 0.500



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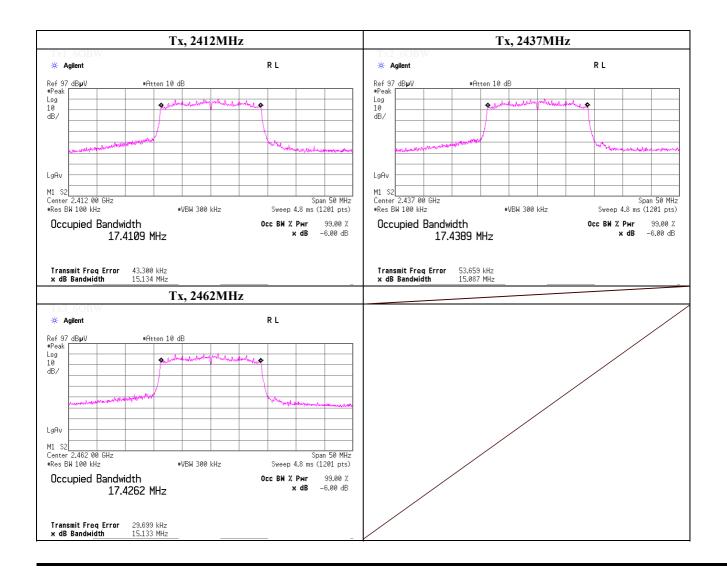
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 2(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
2412.0000	15.134	> 0.500
2437.0000	15.087	> 0.500
2462.0000	15.133	> 0.500



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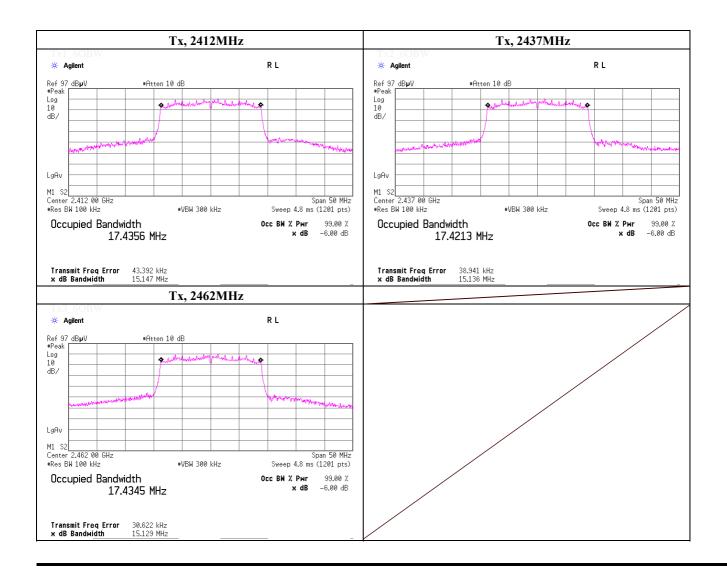
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 10(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
2412.0000	15.147	> 0.500
2437.0000	15.136	> 0.500
2462.0000	15.129	> 0.500



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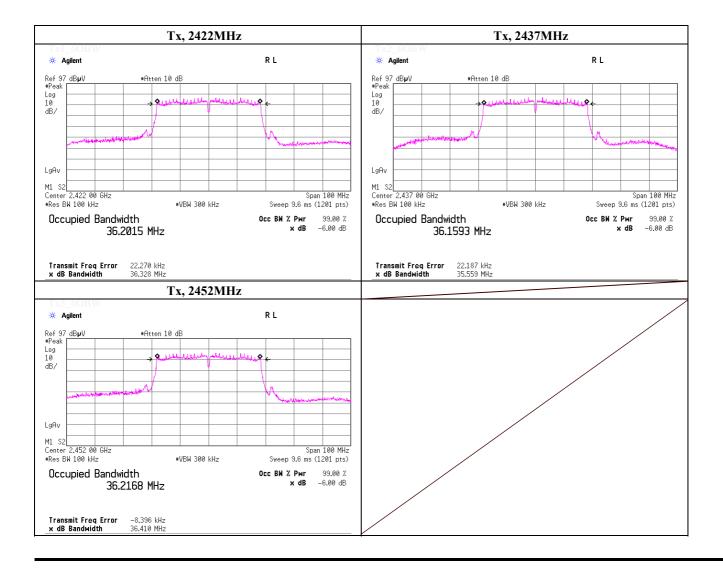
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT40), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
2422.0000	36.328	> 0.500
2437.0000	35.559	> 0.500
2452.0000	36.410	> 0.500



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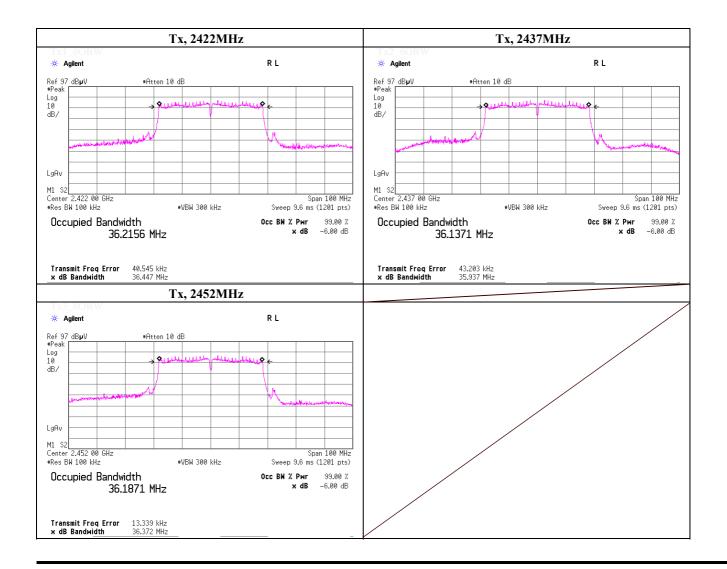
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT40), CDD, PN9, antenna port 0, worst data mode 0(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
2422.0000	36.447	> 0.500
2437.0000	35.937	> 0.500
2452.0000	36.372	> 0.500



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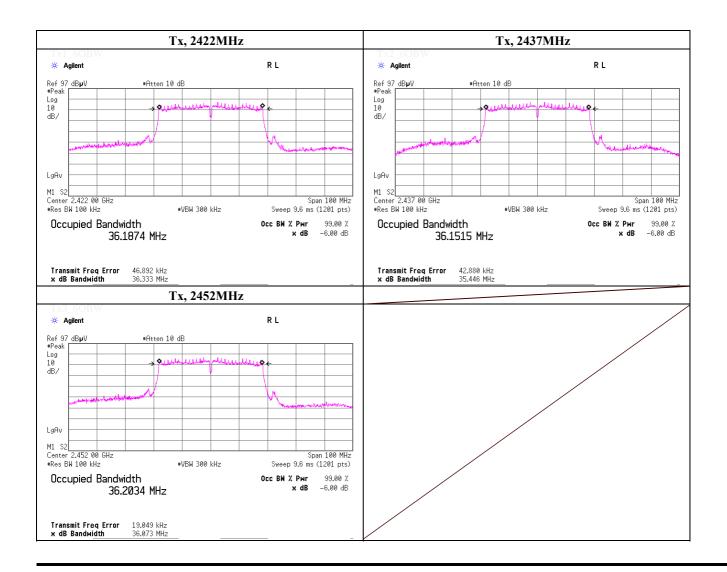
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT40), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
2422.0000	36.333	> 0.500
2437.0000	35.446	> 0.500
2452.0000	36.073	> 0.500



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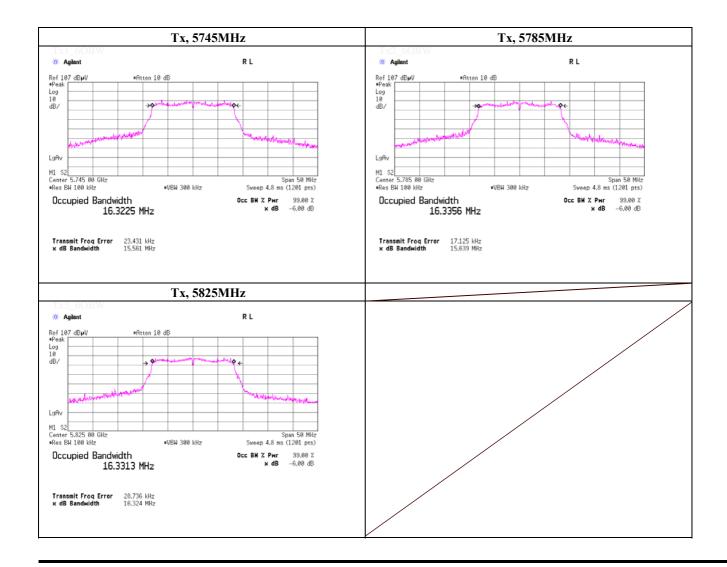
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 20, 2013
Temperature / Humidity 22deg.C , 33%RH
Engineer Akio Hayashi

Mode Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
5745.0000	15.561	> 0.500
5785.0000	15.639	> 0.500
5825.0000	16.324	> 0.500



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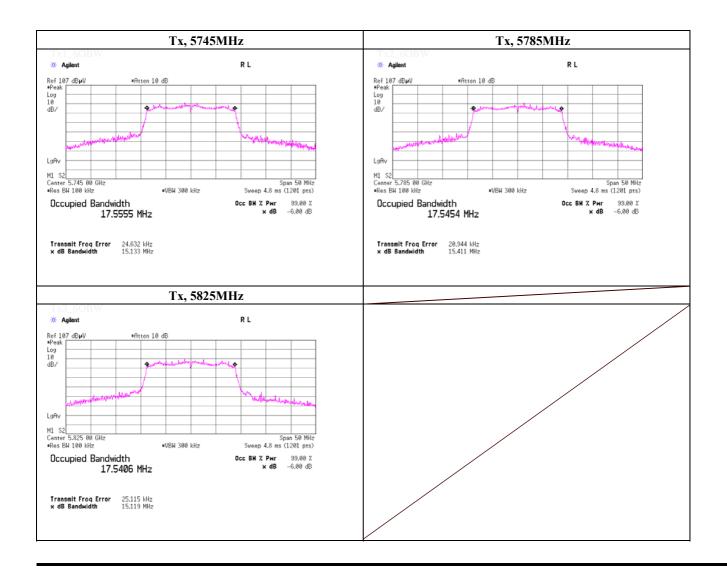
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 20, 2013
Temperature / Humidity 22deg.C , 33%RH
Engineer Akio Hayashi

Mode Tx, IEEE802.11n (HT20), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
5745.0000	15.133	> 0.500
5785.0000	15.411	> 0.500
5825.0000	15.119	> 0.500



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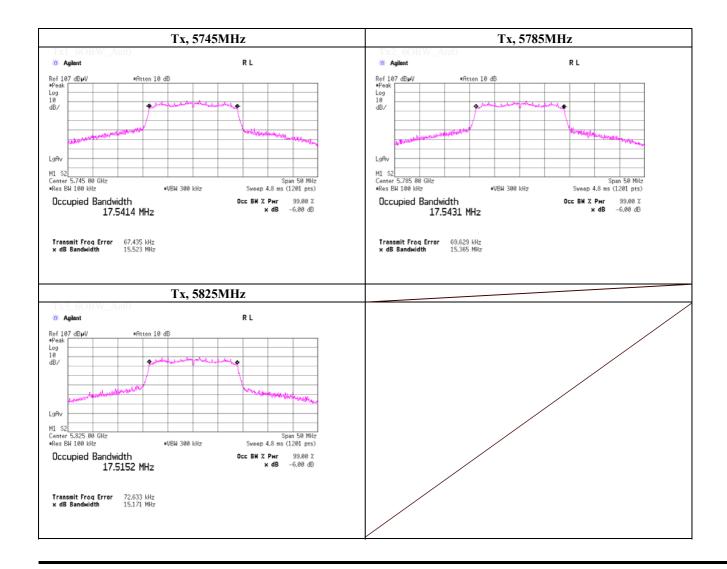
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 20, 2013
Temperature / Humidity 22deg.C , 33%RH
Engineer Akio Hayashi

Mode Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 0(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
5745.0000	15.523	> 0.500
5785.0000	15.365	> 0.500
5825.0000	15.171	> 0.500



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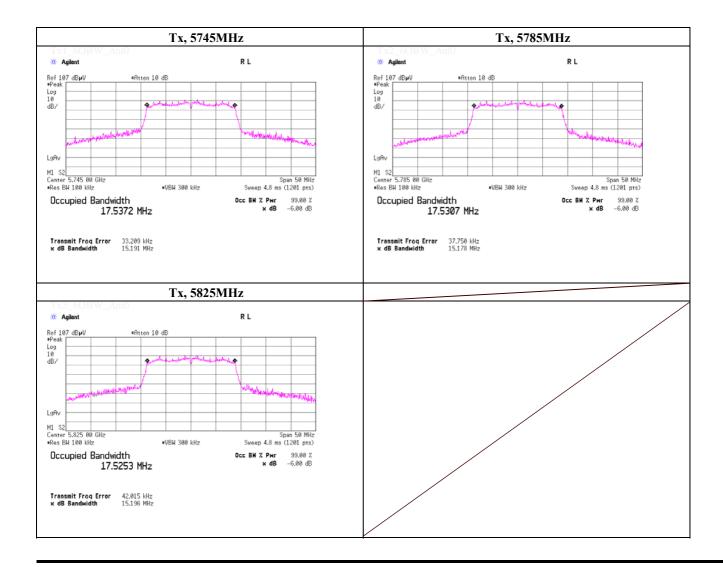
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 20, 2013
Temperature / Humidity 22deg.C , 33%RH
Engineer Akio Hayashi

Mode Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
5745.0000	15.191	> 0.500
5785.0000	15.178	> 0.500
5825.0000	15.196	> 0.500



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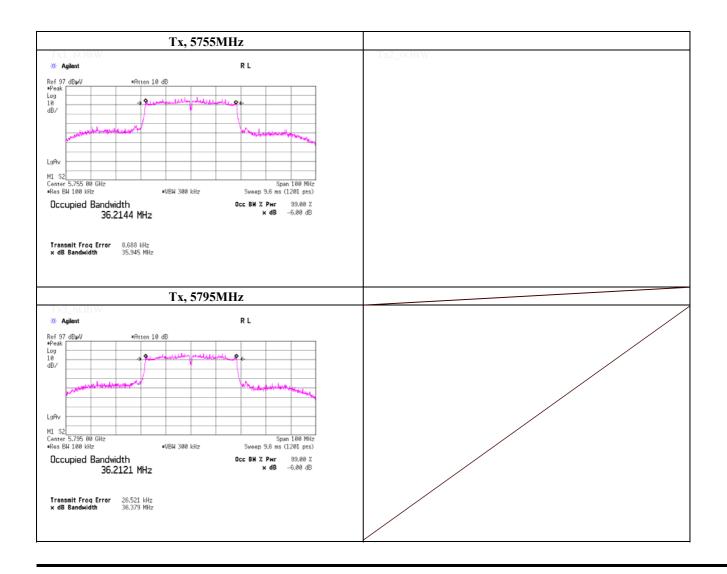
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 20, 2013
Temperature / Humidity 22deg.C , 33%RH
Engineer Akio Hayashi

Mode Tx, IEEE802.11n (HT40), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
5755.0000	35.945	> 0.500
		> 0.500
5795.0000	36.379	> 0.500



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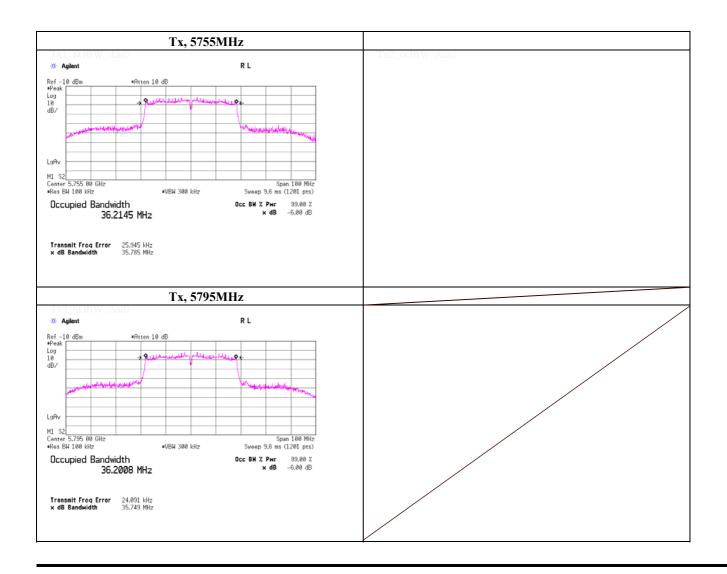
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 20, 2013
Temperature / Humidity 22deg.C , 33%RH
Engineer Akio Hayashi

Mode Tx, IEEE802.11n (HT40), CDD, PN9, antenna port 0, worst data mode 0(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
5755.0000	35.785	> 0.500
		> 0.500
5795.0000	35.749	> 0.500



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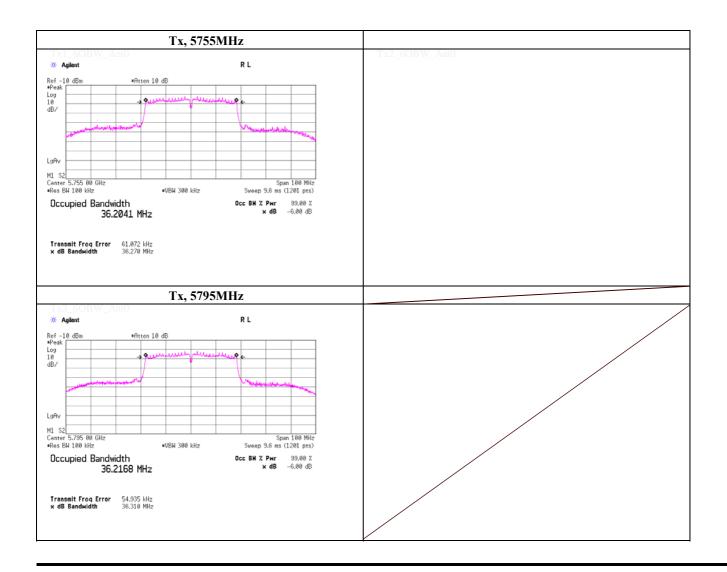
-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 20, 2013
Temperature / Humidity 22deg.C , 33%RH
Engineer Akio Hayashi

Mode Tx, IEEE802.11n (HT40), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)

Freq.	-6dB Bandwidth	Limit
[MHz]	[MHz]	[MHz]
5755.0000	36.270	> 0.500
		> 0.500
5795.0000	36.310	> 0.500



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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013 Temperature / Humidity 22deg.C , 31%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11b, PN9, worst data mode: 1 Mbps worst antenna:

(* P/M: Power Meter with power sensor)

		(1/WL TOWE	with po	wei selisoi)					
Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	Margin	
		Reading	Loss	Loss		_			
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2412.0	-3.59	1.11	20.21	17.73	59.29	30.00	1000	12.27
Mid	2437.0	-3.67	1.10	20.21	17.64	58.08	30.00	1000	12.36
High	2462.0	-3.78	1.11	20.21	17.54	56.75	30.00	1000	12.46

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Pre check] Antenna 0

	Data rate	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Li	mit	Margin	1
			Reading	Loss	Loss						
	[Mbps]	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]	
0	1	2437.0	-3.67	1.10	20.21	17.64	58.08	30.00	1000	12.36	Worst
0	2	2437.0	-3.73	1.10	20.21	17.58	57.28	30.00	1000	12.42	
0	5.5	2437.0	-3.81	1.10	20.21	17.50	56.23	30.00	1000	12.50	
0	11	2437.0	-3.74	1.10	20.21	17.57	57.15	30.00	1000	12.43	

Antenna 1

	Data rate	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	Margin	
			Reading	Loss	Loss		_		_	
	[Mbps]	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
1	1	2437.0	-4.14	1.10	20.21	17.17	52.12	30.00	1000	12.83
1	2	2437.0	-4.28	1.10	20.21	17.03	50.47	30.00	1000	12.97
1	5.5	2437.0	-4.23	1.10	20.21	17.08	51.05	30.00	1000	12.92
1	11	2437.0	-4.31	1.10	20.21	17.00	50.12	30.00	1000	13.00

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

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: +81 463 50 6400 Telephone Facsimile : +81 463 50 6401

$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013 Temperature / Humidity 22deg.C , 31%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11g, PN9, worst data mode: 6 Mbps worst antenna:

(* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	Margin	
		Reading	Loss	Loss					
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2412.0	2.93	1.11	20.21	24.25	266.07	30.00	1000	5.75
Mid	2437.0	2.47	1.10	20.21	23.78	238.78	30.00	1000	6.22
High	2462.0	2.19	1.11	20.21	23.51	224.39	30.00	1000	6.49

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Pre check] Antenna 0

	Data rate	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Limit		Margin	
			Reading	Loss	Loss						
	[Mbps]	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]	
0	6	2437.0	2.47	1.10	20.21	23.78	238.78	30.00	1000	6.22	Worst
0	9	2437.0	2.34	1.10	20.21	23.65	231.74	30.00	1000	6.35	
0	12	2437.0	2.29	1.10	20.21	23.60	229.09	30.00	1000	6.40	
0	18	2437.0	1.82	1.10	20.21	23.13	205.59	30.00	1000	6.87	
0	24	2437.0	1.86	1.10	20.21	23.17	207.49	30.00	1000	6.83	
0	36	2437.0	2.42	1.10	20.21	23.73	236.05	30.00	1000	6.27	
0	48	2437.0	2.01	1.10	20.21	23.32	214.78	30.00	1000	6.68	
0	54	2437.0	1.92	1.10	20.21	23.23	210.38	30.00	1000	6.77	

Antenna 1

	Antenna 1									
	Data rate	Freq.	P/M (Peak)	Cable	Atten.	Result		Limit		Margin
			Reading	Loss	Loss					
	[Mbps]	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
1	6	2437.0	2.20	1.10	20.21	23.51	224.39	30.00	1000	6.49
1	9	2437.0	1.91	1.10	20.21	23.22	209.89	30.00	1000	6.78
1	12	2437.0	1.93	1.10	20.21	23.24	210.86	30.00	1000	6.76
1	18	2437.0	1.86	1.10	20.21	23.17	207.49	30.00	1000	6.83
1	24	2437.0	1.73	1.10	20.21	23.04	201.37	30.00	1000	6.96
1	36	2437.0	2.39	1.10	20.21	23.70	234.42	30.00	1000	6.30
1	48	2437.0	1.67	1.10	20.21	22.98	198.61	30.00	1000	7.02
1	54	2437.0	1.58	1.10	20.21	22.89	194.54	30.00	1000	7.11

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n(HT20), SISO, PN9, 2 (MCS) worst data mode: worst antenna:

(* P/M: Power Meter with power sensor)

-	(1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1												
	Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Limit		Margin			
			Reading	Loss	Loss								
I		[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]			
I	Low	2412.0	2.72	1.11	20.21	24.04	253.51	30.00	1000	5.96			
I	Mid	2437.0	2.39	1.10	20.21	23.70	234.42	30.00	1000	6.30			
I	High	2462.0	2.12	1.11	20.21	23.44	220.80	30.00	1000	6.56			

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Pre check] Antenna 0

											_
	Mode	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Li	mit	Margin	
			Reading	Loss	Loss						
	(MCS)	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]	
0	0	2437.0	2.36	1.10	20.21	23.67	232.81	30.00	1000	6.33	1
0	1	2437.0	2.25	1.10	20.21	23.56	226.99	30.00	1000	6.44	
0	2	2437.0	2.39	1.10	20.21	23.70	234.42	30.00	1000	6.30	Worst
0	3	2437.0	2.02	1.10	20.21	23.33	215.28	30.00	1000	6.67	
0	4	2437.0	1.92	1.10	20.21	23.23	210.38	30.00	1000	6.77	
0	5	2437.0	1.85	1.10	20.21	23.16	207.01	30.00	1000	6.84	
0	6	2437.0	1.89	1.10	20.21	23.20	208.93	30.00	1000	6.80	
0	7	2437.0	1.86	1.10	20.21	23.17	207.49	30.00	1000	6.83	

Antenna 1

	111100111111 1	Mitchia 1												
	Mode	Freq.	P/M (Peak)	Cable	Atten.	Result		Limit		Margin				
			Reading	Loss	Loss		_							
	(MCS)	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]				
1	0	2437.0	2.20	1.10	20.21	23.51	224.39	30.00	1000	6.49				
1	1	2437.0	2.21	1.10	20.21	23.52	224.91	30.00	1000	6.48				
1	2	2437.0	2.12	1.10	20.21	23.43	220.29	30.00	1000	6.57				
1	3	2437.0	1.76	1.10	20.21	23.07	202.77	30.00	1000	6.93				
1	4	2437.0	1.70	1.10	20.21	23.01	199.99	30.00	1000	6.99				
1	5	2437.0	1.69	1.10	20.21	23.00	199.53	30.00	1000	7.00				
1	6	2437.0	1.63	1.10	20.21	22.94	196.79	30.00	1000	7.06				
1	7	2437.0	1.76	1.10	20.21	23.07	202.77	30.00	1000	6.93				

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode: 2 (MCS)

Antenna 0 + Antenna 1

Ch	Freq.	Result	Result	Result		Limit		Margin
		Ant 0	Ant 1	Ant 0 + Ant 1				
	[MHz]	[mW]	[mW]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2412.0	248.89	222.33	26.73	471.22	30.00	1000	3.27
Mid	2437.0	243.78	214.78	26.61	458.56	30.00	1000	3.39
High	2462.0	247.17	218.78	26.68	465.95	30.00	1000	3.32

Antenna 0 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Limit		Margin
		Reading	Loss	Loss	_				
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2412.0	2.64	1.11	20.21	23.96	248.89	30.00	1000	6.04
Mid	2437.0	2.56	1.10	20.21	23.87	243.78	30.00	1000	6.13
High	2462.0	2.61	1.11	20.21	23.93	247.17	30.00	1000	6.07

Antenna 1 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Limit		Margin
		Reading	Loss	Loss					
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2412.0	2.15	1.11	20.21	23.47	222.33	30.00	1000	6.53
Mid	2437.0	2.01	1.10	20.21	23.32	214.78	30.00	1000	6.68
High	2462.0	2.08	1.11	20.21	23.40	218.78	30.00	1000	6.60

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Dro obook]

Pre check	K]							_
Mode	Freq.	Rea	ding	Rea	ding	Reading		
		Ante	nna 0	Ante	nna 1	Antenna 0 + 1		
(MCS)	[MHz]	[dBm]	[mW]	[dBm]	[mW]	[dBm]	[mW]	
0	2437.0	2.49	1.77	1.99	1.58	5.26	3.36	1
1	2437.0	2.42	1.75	1.87	1.54	5.16	3.28]
2	2437.0	2.56	1.80	2.01	1.59	5.30	3.39	W
3	2437.0	2.29	1.69	1.79	1.51	5.06	3.20	
4	2437.0	2.11	1.63	1.75	1.50	4.94	3.12	
5	2437.0	2.17	1.65	1.61	1.45	4.91	3.10	
6	2437.0	1.94	1.56	1.58	1.44	4.77	3.00	
7	2437.0	2.08	1.61	1.78	1.51	4.94	3.12	

Vorst

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, worst data mode: 10 (MCS)

Antenna 0 + Antenna 1

Threehild V Threehild I												
	Ch	Freq.	Result	Result		Result		Liı	mit	Margin		
			Ant 0	Ant 1		Ant 0 + Ant 1						
		[MHz]	[mW]	[mW]		[dBm]	[mW]	[dBm]	[mW]	[dB]		
	Low	2412.0	238.78	224.91		26.66	463.69	30.00	1000	3.34		
	Mid	2437.0	228.56	212.81		26.45	441.37	30.00	1000	3.55		
	High	2462.0	233.88	222.33		26.59	456.21	30.00	1000	3.41		

Antenna 0 (* P/M: Power Meter with power sensor)

	· · · · · · · · · · · · · · · · · · ·	•						(1/1111 1 0 11 0	micror with po	wer sensor)
ı	Ch	Freq.	P/M (Peak)	Cable	Atten.	Res	Result		mit	Margin
			Reading	Loss	Loss	ì				
ı		[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
	Low	2412.0	2.46	1.11	20.21	23.78	238.78	30.00	1000	6.22
ı	Mid	2437.0	2.28	1.10	20.21	23.59	228.56	30.00	1000	6.41
	High	2462.0	2.37	1.11	20.21	23.69	233.88	30.00	1000	6.31

Antenna 1 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Limit		Margin
		Reading	Loss	Loss					
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2412.0	2.20	1.11	20.21	23.52	224.91	30.00	1000	6.48
Mid	2437.0	1.97	1.10	20.21	23.28	212.81	30.00	1000	6.72
High	2462.0	2.15	1.11	20.21	23.47 222.33		30.00	1000	6.53

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Dro obook]

Pre check	K]						
Mode	Freq.	Rea	ding	Rea	ding	Rea	ding
		Ante	nna 0	Ante	nna 1	Antenr	na 0 + 1
(MCS)	[MHz]	[dBm]	[mW]	[dBm]	[mW]	[dBm]	[mW]
8	2437.0	1.93	1.56	1.93	1.56	4.94	3.12
9	2437.0	1.71	1.48	1.47	1.40	4.60	2.89
10	2437.0	2.28	1.69	1.97	1.57	5.14	3.26
11	2437.0	1.63	1.46	1.25	1.33	4.45	2.79
12	2437.0	2.23	1.67	0.91	1.23	4.63	2.90
13	2437.0	2.17	1.65	1.26	1.34	4.75	2.98
14	2437.0	1.61	1.45	1.33	1.36	4.48	2.81
15	2437.0	1.69	1.48	1.51	1.42	4.61	2.89

Worst

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT40), SISO, PN9, 0 (MCS) worst data mode: worst antenna:

(* P/M: Power Meter with power sensor)

(· · · · · · · · · · · · · · · · · · ·										
	Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	mit	Margin
			Reading	Loss	Loss	ì		,		
		[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Ī	Low	2422.0	2.27	1.11	20.21	23.59	228.56	30.00	1000	6.41
Ī	Mid	2437.0	1.93	1.10	20.21	23.24	210.86	30.00	1000	6.76
Ī	High	2452.0	2.05	1.10	20.21	23.36	216.77	30.00	1000	6.64

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Pre check] Antenna 0

	7 Timee minu	<u> </u>									
	Mode	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Li	mit	Margin	
			Reading	Loss	Loss						
	(MCS)	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]	
0	0	2437.0	1.93	1.10	20.21	23.24	210.86	30.00	1000	6.76	Worst
0	1	2437.0	1.78	1.10	20.21	23.09	203.70	30.00	1000	6.91	
0	2	2437.0	1.25	1.10	20.21	22.56	180.30	30.00	1000	7.44	
0	3	2437.0	1.57	1.10	20.21	22.88	194.09	30.00	1000	7.12	
0	4	2437.0	1.13	1.10	20.21	22.44	175.39	30.00	1000	7.56	
0	5	2437.0	1.36	1.10	20.21	22.67	184.93	30.00	1000	7.33	
0	6	2437.0	1.18	1.10	20.21	22.49	177.42	30.00	1000	7.51	
0	7	2437.0	1.22	1.10	20.21	22.53	179.06	30.00	1000	7.47	

Antenna 1

	Mode	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	mit	Margin
			Reading	Loss	Loss				_	
	(MCS)	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
1	0	2437.0	1.85	1.10	20.21	23.16	207.01	30.00	1000	6.84
1	1	2437.0	1.91	1.10	20.21	23.22	209.89	30.00	1000	6.78
1	2	2437.0	1.36	1.10	20.21	22.67	184.93	30.00	1000	7.33
1	3	2437.0	1.51	1.10	20.21	22.82	191.43	30.00	1000	7.18
1	4	2437.0	1.48	1.10	20.21	22.79	190.11	30.00	1000	7.21
1	5	2437.0	1.32	1.10	20.21	22.63	183.23	30.00	1000	7.37
1	6	2437.0	1.34	1.10	20.21	22.65	184.08	30.00	1000	7.35
1	7	2437.0	1.37	1.10	20.21	22.68	185.35	30.00	1000	7.32

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT40), CDD, PN9, worst data mode: 0 (MCS)

Antenna 0 + Antenna 1

Ch	Freq.	Result	Result	Result		Limit		Margin
		Ant 0	Ant 1	Ant 0 + Ant 1			_	
	[MHz]	[mW]	[mW]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2422.0	221.31	213.80	26.39	435.11	30.00	1000	3.61
Mid	2437.0	211.84	205.12	26.20	416.95	30.00	1000	3.80
High	2452.0	217.27	210.86	26.32 428.13		30.00	1000	3.68

Antenna 0 (* P/M: Power Meter with power sensor)

· micemina o	•						(1/1111 1 0 11 0	min po	wer sensor)
Ch	Freq.	P/M (Peak)	Cable	Atten.	Re	Result		mit	Margin
		Reading	Loss	Loss	,			_	
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2422.0	2.13	1.11	20.21	23.45	221.31	30.00	1000	6.55
Mid	2437.0	1.95	1.10	20.21	23.26	211.84	30.00	1000	6.74
High	2452.0	2.06	1.10	20.21	23.37	217.27	30.00	1000	6.63

Antenna 1 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Limit		Margin
		Reading	Loss	Loss					
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2422.0	1.98	1.11	20.21	23.30	213.80	30.00	1000	6.70
Mid	2437.0	1.81	1.10	20.21	23.12	205.12	30.00	1000	6.88
High	2452.0	1.93	1.10	20.21	23.24 210.86		30.00	1000	6.76

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Dro obook]

Pre check	K]							_
Mode	Freq.	Rea	ding	Rea	ding	Rea	ding	Ĭ
		Ante	nna 0	Ante	nna 1	Antenr	100 + 1	
(MCS)	[MHz]	[dBm]	[mW]	[dBm]	[mW]	[dBm]	[mW]	
0	2437.0	1.95	1.57	1.81	1.52	4.89	3.08	Worst
1	2437.0	1.93	1.56	1.71	1.48	4.83	3.04	1
2	2437.0	1.82	1.52	1.69	1.48	4.77	3.00]
3	2437.0	1.62	1.45	1.67	1.47	4.66	2.92	
4	2437.0	1.57	1.44	1.62	1.45	4.61	2.89]
5	2437.0	1.48	1.41	1.57	1.44	4.54	2.84	
6	2437.0	1.54	1.43	1.52	1.42	4.54	2.84	
7	2437.0	1.56	1.43	1.54	1.43	4.56	2.86	

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT40), MIMO(SDM), PN9, worst data mode: 8 (MCS)

Antenna 0 + Antenna 1

Ch	Freq.	Result	Result	Result		Limit		Margin
		Ant 0	Ant 1	Ant 0 + Ant 1				
	[MHz]	[mW]	[mW]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2422.0	213.30	207.49	26.24	420.80	30.00	1000	3.76
Mid	2437.0	207.49	197.70	26.08	405.19	30.00	1000	3.92
High	2452.0	209.89	204.17	26.17	414.07	30.00	1000	3.83

Antenna 0 (* P/M: Power Meter with power sensor)

· micemina o	(1/11 1 one literal wan power set								wer sensor)
Ch	Freq.	P/M (Peak)	Cable	Atten.	Re	Result		mit	Margin
		Reading	Loss	Loss					
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2422.0	1.97	1.11	20.21	23.29	213.30	30.00	1000	6.71
Mid	2437.0	1.86	1.10	20.21	23.17	207.49	30.00	1000	6.83
High	2452.0	1.91	1.10	20.21	23.22	209.89	30.00	1000	6.78

Antenna 1 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Limit		Margin
		Reading	Loss	Loss	•				
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	2422.0	1.85	1.11	20.21	23.17	207.49	30.00	1000	6.83
Mid	2437.0	1.65	1.10	20.21	22.96	197.70	30.00	1000	7.04
High	2452.0	1.79	1.10	20.21	23.10 204.17		30.00	1000	6.90

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Dro obook]

[Pre check	(]							
Mode	Freq.	Rea	ding	Rea	ding	Rea	ding	Ĭ
		Ante	nna 0	Ante	nna 1	Antenr	100 + 1	
(MCS)	[MHz]	[dBm]	[mW]	[dBm]	[mW]	[dBm]	[mW]]
8	2437.0	1.86	1.53	1.65	1.46	4.77	3.00	Worst
9	2437.0	1.36	1.37	1.31	1.35	4.35	2.72	
10	2437.0	1.57	1.44	1.44	1.39	4.52	2.83]
11	2437.0	1.39	1.38	1.41	1.38	4.41	2.76]
12	2437.0	1.70	1.48	1.17	1.31	4.45	2.79]
13	2437.0	1.66	1.47	1.02	1.26	4.36	2.73	
14	2437.0	1.23	1.33	1.37	1.37	4.31	2.70	J
15	2437.0	1.12	1.29	1.44	1.39	4.29	2.69	

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11a, PN9, worst data mode: 6 Mbps worst antenna:

(* P/M: Power Meter with power sensor)

ı	Ch	Freq.	P/M (Peak)	Cable	Atten.	Re	Result		mit	Margin
			Reading	Loss	Loss					
		[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
	Low	5745.0	0.32	1.76	20.09	22.17	164.82	30.00	1000	7.83
	Mid	5785.0	0.18	1.75	20.09	22.02	159.22	30.00	1000	7.98
	High	5825.0	-0.19	2.06	20.10	21.97	157.40	30.00	1000	8.03

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Pre check] Antenna 0

	Data rate	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Li	mit	Margin	
			Reading	Loss	Loss						
	[Mbps]	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]	
0	6	5785.0	0.18	1.75	20.09	22.02	159.22	30.00	1000	7.98	Worst
0	9	5785.0	0.12	1.75	20.09	21.96	157.04	30.00	1000	8.04	
0	12	5785.0	0.07	1.75	20.09	21.91	155.24	30.00	1000	8.09	
0	18	5785.0	0.02	1.75	20.09	21.86	153.46	30.00	1000	8.14	
0	24	5785.0	-0.08	1.75	20.09	21.76	149.97	30.00	1000	8.24	
0	36	5785.0	-0.05	1.75	20.09	21.79	151.01	30.00	1000	8.21	
0	48	5785.0	0.01	1.75	20.09	21.85	153.11	30.00	1000	8.15	
0	54	5785.0	0.03	1.75	20.09	21.87	153.82	30.00	1000	8.13	

Antenna 1

		itema i								
	Data rate	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	mit	Margin
			Reading	Loss	Loss				_	
	[Mbps]	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
1	6	5785.0	-1.38	1.75	20.09	20.46	111.17	30.00	1000	9.54
1	9	5785.0	-1.41	1.75	20.09	20.43	110.41	30.00	1000	9.57
1	12	5785.0	-1.48	1.75	20.09	20.36	108.64	30.00	1000	9.64
1	18	5785.0	-1.47	1.75	20.09	20.37	108.89	30.00	1000	9.63
1	24	5785.0	-1.49	1.75	20.09	20.35	108.39	30.00	1000	9.65
1	36	5785.0	-1.50	1.75	20.09	20.34	108.14	30.00	1000	9.66
1	48	5785.0	-1.45	1.75	20.09	20.39	109.40	30.00	1000	9.61
1	54	5785.0	-1.48	1.75	20.09	20.36	108.64	30.00	1000	9.64

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT20), SISO, PN9,worst antenna: worst data mode: 0 (MCS)

(* P/M: Power Meter with power sensor)

		(1/WL TOWE	with po	wei selisoi)					
Ch	Freq.	P/M (Peak)	Cable	Atten.	Re	Result		mit	Margin
		Reading	Loss	Loss					
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	5745.0	0.41	1.76	20.09	22.26	168.27	30.00	1000	7.74
Mid	5785.0	0.13	1.75	20.09	21.97	157.40	30.00	1000	8.03
High	5825.0	-0.24	2.06	20.10	21.92	155.60	30.00	1000	8.08

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Pre check] Antenna 0

	7 Kintennia (,									_
	Mode	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Li	mit	Margin	
			Reading	Loss	Loss						
	(MCS)	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]	
0	0	5785.0	0.13	1.75	20.09	21.97	157.40	30.00	1000	8.03	Worst
0	1	5785.0	0.11	1.75	20.09	21.95	156.68	30.00	1000	8.05	
0	2	5785.0	0.04	1.75	20.09	21.88	154.17	30.00	1000	8.12	
0	3	5785.0	-0.10	1.75	20.09	21.74	149.28	30.00	1000	8.26	
0	4	5785.0	0.07	1.75	20.09	21.91	155.24	30.00	1000	8.09	
0	5	5785.0	-0.13	1.75	20.09	21.71	148.25	30.00	1000	8.29	
0	6	5785.0	0.04	1.75	20.09	21.88	154.17	30.00	1000	8.12]
0	7	5785.0	0.00	1.75	20.09	21.84	152.76	30.00	1000	8.16	

Antenna 1

	Mode	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	mit	Margin
			Reading	Loss	Loss				_	
	(MCS)	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
1	0	5785.0	-1.36	1.75	20.09	20.48	111.69	30.00	1000	9.52
1	1	5785.0	-1.49	1.75	20.09	20.35	108.39	30.00	1000	9.65
1	2	5785.0	-1.52	1.75	20.09	20.32	107.65	30.00	1000	9.68
1	3	5785.0	-1.58	1.75	20.09	20.26	106.17	30.00	1000	9.74
1	4	5785.0	-1.57	1.75	20.09	20.27	106.41	30.00	1000	9.73
1	5	5785.0	-1.56	1.75	20.09	20.28	106.66	30.00	1000	9.72
1	6	5785.0	-1.53	1.75	20.09	20.31	107.40	30.00	1000	9.69
1	7	5785.0	-1.57	1.75	20.09	20.27	106.41	30.00	1000	9.73

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

UL Japan, Inc. Shonan EMC Lab. Test place No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode: 0 (MCS)

Antenna 0 + Antenna 1

Ch	Freq.	Result	Result	Re	Result		Limit	
		Ant 0	Ant 1	Ant $0 + Ant 1$			_	
	[MHz]	[mW]	[mW]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Lov	v 5745.0	167.11	102.80	24.31	269.91	30.00	1000	5.69
Mi	1 5785.0	154.17	101.39	24.07	255.56	30.00	1000	5.93
Hig	h 5825.0	159.22	107.40	24.26 266.62		30.00	1000	5.74

Antenna 0 (* P/M: Power Meter with power sensor)

· micemina o		(1/Mar 1 swel Meter water power							
Ch	Freq.	P/M (Peak)	Cable	Atten.	Res	Result		mit	Margin
		Reading	Loss	Loss	,				
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	5745.0	0.38	1.76	20.09	22.23	167.11	30.00	1000	7.77
Mid	5785.0	0.04	1.75	20.09	21.88	154.17	30.00	1000	8.12
High	5825.0	-0.14	2.06	20.10	22.02	159.22	30.00	1000	7.98

Antenna 1 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Limit		Margin
		Reading	Loss	Loss	ı				
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	5745.0	-1.73	1.76	20.09	20.12	102.80	30.00	1000	9.88
Mid	5785.0	-1.78	1.75	20.09	20.06	101.39	30.00	1000	9.94
High	5825.0	-1.85	2.06	20.10	20.31 107.40		30.00	1000	9.69

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Dro obook]

Pre check	K]							_
Mode	Freq.	Rea	ding	Rea	ding	Rea	ding	Ī
		Ante	nna 0	Ante	nna 1	Antenr	100 + 1	
(MCS)	[MHz]	[dBm]	[mW]	[dBm]	[mW]	[dBm]	[mW]	
0	5785.0	0.04	1.01	-1.78	0.66	2.23	1.67	Worst
1	5785.0	-0.11	0.97	-1.88	0.65	2.10	1.62	1
2	5785.0	-0.07	0.98	-1.86	0.65	2.14	1.64	
3	5785.0	-0.01	1.00	-1.90	0.65	2.16	1.64	
4	5785.0	0.01	1.00	-1.98	0.63	2.14	1.64]
5	5785.0	-0.02	1.00	-1.95	0.64	2.13	1.63	
6	5785.0	-0.04	0.99	-1.99	0.63	2.10	1.62	
7	5785.0	-0.06	0.99	-1.94	0.64	2.11	1.63	

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

UL Japan, Inc. Shonan EMC Lab. Test place No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, worst data mode: 8 (MCS)

Antenna 0 + Antenna 1

Ch	Freq.	Result	Result	Result		Limit		Margin
		Ant 0	Ant 1	Ant $0 + Ant 1$				
	[MHz]	[mW]	[mW]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	5745.0	158.85	99.08	24.12	257.94	30.00	1000	5.88
Mid	5785.0	152.05	97.95	23.98	250.00	30.00	1000	6.02
High	5825.0	155.96	105.20	24.17	261.15	30.00	1000	5.83

Antenna 0 (* P/M: Power Meter with power sensor)

· micemina o	•						(1/1111 1 0 11 0	min po	wer sensor)
Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	mit	Margin
		Reading	Loss	Loss	ì			_	
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	5745.0	0.16	1.76	20.09	22.01	158.85	30.00	1000	7.99
Mid	5785.0	-0.02	1.75	20.09	21.82	152.05	30.00	1000	8.18
High	5825.0	-0.23	2.06	20.10	21.93	155.96	30.00	1000	8.07

Antenna 1 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Limit		Margin
		Reading	Loss	Loss	•				
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	5745.0	-1.89	1.76	20.09	19.96	99.08	30.00	1000	10.04
Mid	5785.0	-1.93	1.75	20.09	19.91	97.95	30.00	1000	10.09
High	5825.0	-1.94	2.06	20.10	20.22	105.20	30.00	1000	9.78

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Dro obook]

Pre check	K]							_
Mode	Freq.	Rea	ding	Rea	ding	Rea	ding	Ī
		Ante	nna 0	Ante	nna 1	Antenr	100 + 1	
(MCS)	[MHz]	[dBm]	[mW]	[dBm]	[mW]	[dBm]	[mW]	
8	5785.0	-0.02	1.00	-1.93	0.64	2.14	1.64	Worst
9	5785.0	-0.15	0.97	-2.08	0.62	2.00	1.59	1
10	5785.0	-0.04	0.99	-1.97	0.64	2.11	1.63	
11	5785.0	-0.09	0.98	-2.05	0.62	2.05	1.60	
12	5785.0	-0.12	0.97	-2.08	0.62	2.02	1.59]
13	5785.0	-0.08	0.98	-2.24	0.60	1.98	1.58	
14	5785.0	-0.13	0.97	-2.11	0.62	2.00	1.59	
15	5785.0	-0.05	0.99	-2.14	0.61	2.04	1.60	

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT40), SISO, PN9,worst antenna: worst data mode: 0 (MCS)

(* P/M: Power Meter with power sensor)

_		(17th 1 over Meter with power sensor)									
ſ	Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	mit	Margin	
			Reading	Loss	Loss	1					
		[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]	
ĺ	Low	5755.0	-0.17	1.76	20.09	21.68	147.23	30.00	1000	8.32	
	High	5795.0	-0.42	1.75	20.09	21.42	138.68	30.00	1000	8.58	

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Pre check] Antenna 0

	11meemme 0										_
	Mode	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Li	mit	Margin	
			Reading	Loss	Loss						
	(MCS)	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]	
0	0	5755.0	-0.17	1.76	20.09	21.68	147.23	30.00	1000	8.32	Worst
0	1	5755.0	-0.24	1.76	20.09	21.61	144.88	30.00	1000	8.39	
0	2	5755.0	-0.31	1.76	20.09	21.54	142.56	30.00	1000	8.46	
0	3	5755.0	-0.27	1.76	20.09	21.58	143.88	30.00	1000	8.42	
0	4	5755.0	-0.33	1.76	20.09	21.52	141.91	30.00	1000	8.48	
0	5	5755.0	-0.21	1.76	20.09	21.64	145.88	30.00	1000	8.36	
0	6	5755.0	-0.19	1.76	20.09	21.66	146.55	30.00	1000	8.34	
0	7	5755.0	-0.24	1.76	20.09	21.61	144.88	30.00	1000	8.39	

Antenna 1

	Antuna i										
	Mode	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Li	mit	Margin	
			Reading	Loss	Loss		_				
	(MCS)	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]	
1	0	5755.0	-1.82	1.76	20.09	20.03	100.69	30.00	1000	9.97	
1	1	5755.0	-1.86	1.76	20.09	19.99	99.77	30.00	1000	10.01	
1	2	5755.0	-1.85	1.76	20.09	20.00	100.00	30.00	1000	10.00	
1	3	5755.0	-1.95	1.76	20.09	19.90	97.72	30.00	1000	10.10	
1	4	5755.0	-1.88	1.76	20.09	19.97	99.31	30.00	1000	10.03	
1	5	5755.0	-1.87	1.76	20.09	19.98	99.54	30.00	1000	10.02	
1	6	5755.0	-1.91	1.76	20.09	19.94	98.63	30.00	1000	10.06	
1	7	5755.0	-1.86	1.76	20.09	19.99	99.77	30.00	1000	10.01	

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

UL Japan, Inc. Shonan EMC Lab.

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

UL Japan, Inc. Shonan EMC Lab. Test place No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT40), CDD, PN9, worst data mode: 0 (MCS)

Antenna 0 + Antenna 1

	venna v · imvenna i								
Ch	Freq.	Result	Result		Result		Liı	mit	Margin
		Ant 0	Ant 1		Ant $0 + Ant 1$				
	[MHz]	[mW]	[mW]		[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	v 5755.0	146.89	99.77		23.92	246.66	30.00	1000	6.08
Higl	h 5795.0	142.89	91.20		23.69	234.09	30.00	1000	6.31

Antenna 0 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Liı	mit	Margin
		Reading	Loss	Loss					
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	5755.0	-0.18	1.76	20.09	21.67	146.89	30.00	1000	8.33
High	5795.0	-0.29	1.75	20.09	21.55 142.89		30.00	1000	8.45

Antenna 1 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Result		Limit		Margin
		Reading	Loss	Loss					
	[MHz]	[dBm]	[dB]	[dB]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	5755.0	-1.86	1.76	20.09	19.99	99.77	30.00	1000	10.01
High	5795.0	-2.24	1.75	20.09	19.60	91.20	30.00	1000	10.40

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Dro obook]

[Pre check	(]							
Mode	Freq.	Rea	ding	Rea	ding	Rea	ding	
		Ante	nna 0	Ante	nna 1	Antenr	100 + 1	
(MCS)	[MHz]	[dBm]	[mW]	[dBm]	[mW]	[dBm]	[mW]	
0	5755.0	-0.18	0.96	-1.86	0.65	2.07	1.61	Worst
1	5755.0	-0.23	0.95	-1.97	0.64	2.00	1.58]
2	5755.0	-0.34	0.92	-2.01	0.63	1.92	1.55	
3	5755.0	-0.24	0.95	-1.98	0.63	1.99	1.58	
4	5755.0	-0.22	0.95	-2.07	0.62	1.96	1.57	
5	5755.0	-0.28	0.94	-1.99	0.63	1.96	1.57]
6	5755.0	-0.24	0.95	-2.11	0.62	1.94	1.56	J
7	5755.0	-0.26	0.94	-2.09	0.62	1.93	1.56	

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$\underbrace{ \textbf{Maximum Peak Conducted Output Power}}_{(PKPM1)}$

UL Japan, Inc. Shonan EMC Lab. Test place No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Engineer Shinichi Takano

Mode Tx, IEEE802.11n (HT40), MIMO(SDM), PN9, worst data mode: 8 (MCS)

Antenna 0 + Antenna 1

Ch	Freq.	Result	Result	Re	sult	Liı	mit	Margin
		Ant 0	Ant 1	Ant 0 -	+ Ant 1			
	[MHz]	[mW]	[mW]	[dBm]	[mW]	[dBm]	[mW]	[dB]
Low	5755.0	144.21	97.72	23.84 241.94		30.00	1000	6.16
High	5795.0	137.09	86.30	23.49 223.39		30.00	1000	6.51

Antenna 0 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Liı	nit	Margin
		Reading	Loss	Loss	[dDm] [mW]				
	[MHz]	[dBm]	[dB]	[dB]	[dBm] [mW]		[dBm]	[mW]	[dB]
Low	5755.0	-0.26	1.76	20.09	21.59 144.21		30.00	1000	8.41
High	5795.0	-0.47	1.75	20.09	21.37 137.09		30.00	8.63	

Antenna 1 (* P/M: Power Meter with power sensor)

Ch	Freq.	P/M (Peak)	Cable	Atten.	Re	sult	Liı	mit	Margin
		Reading	Loss	Loss	[dRm] [mW]				
	[MHz]	[dBm]	[dB]	[dB]	[dBm] [mW]		[dBm]	[mW]	[dB]
Low	5755.0	-1.95	1.76	20.09	19.90 97.72		30.00	1000	10.10
High	5795.0	-2.48	1.75	20.09	19.36 86.30		36.30 30.00 1000		

Sample Calculation:

Result = Reading + Cable Loss + Atten. Loss

[Dro obook]

Pre check	K]							_
Mode	Freq.	Rea	ding	Rea	ding	Rea	ding	Ī
		Ante	nna 0	Ante	nna 1	Antenr	100 + 1	
(MCS)	[MHz]	[dBm]	[mW]	[dBm]	[mW]	[dBm]	[mW]	
8	5755.0	-0.26	0.94	-1.95	0.64	1.99	1.58	Worst
9	5755.0	-0.33	0.93	-2.06	0.62	1.90	1.55	
10	5755.0	-0.29	0.94	-2.01	0.63	1.94	1.56	
11	5755.0	-0.37	0.92	-2.02	0.63	1.89	1.55	
12	5755.0	-0.42	0.91	-2.08	0.62	1.84	1.53]
13	5755.0	-0.46	0.90	-2.16	0.61	1.78	1.51	
14	5755.0	-0.48	0.90	-2.07	0.62	1.81	1.52	
15	5755.0	-0.44	0.90	-2.11	0.62	1.82	1.52	

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Radiated Emission

No.3 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

Date December 11, 2013 February 10, 2014 26 deg.C, 31 %RH 25 deg.C , 33 %RH Temperature / Humidity Shinichi Takano Engineer Shinichi Takano

Mode Tx, 2412 MHz

Tx, IEEE802.11b, PN9, worst antenna port 0, worst data mode 1Mbps

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	2390.000	PK	46.8	26.8	14.7	38.2	50.1	73.9	23.8	100	123	
Hori.	3216.013	PK	49.8	28.2	6.5	38.1	46.4	73.9	27.5	100	130	
Hori.	4824.000	PK	51.8	31.1	7.9	37.1	53.7	73.9	20.2	100	274	
Hori.	7236.000	PK	44.6	37.1	9.1	39.4	51.4	73.9	22.5	100	0	
Hori.	2390.000	AV	36.4	26.8	14.7	38.2	39.7	53.9	14.2	100	123	
Vert.	2390.000	PK	47.0	26.8	14.7	38.2	50.3	73.9	23.6	100	91	
Vert.	3215.992	PK	48.8	28.2	6.5	38.1	45.4	73.9	28.5	100	96	
Vert.	4824.000	PK	47.9	31.1	7.9	37.1	49.8	73.9	24.1	100	342	
Vert.	7236.000	PK	45.0	37.1	9.1	39.4	51.8	73.9	22.1	100	0	
Vert.	2390.000	AV	35.9	26.8	14.7	38.2	39.2	53.9	14.7	100	91	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Trende II	casar ement vara	e mien aarj	iactor								
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	3216.013	AV	44.6	28.2	6.5	38.1	0.4	41.6	53.9	12.3	
Hori.	4824.000	AV	46.8	31.1	7.9	37.1	0.4	49.1	53.9	4.8	
Hori.	7236.000	AV	36.3	37.1	9.1	39.4	0.4	43.5	53.9	10.4	
Vert.	3215.992	AV	42.3	28.2	6.5	38.1	0.4	39.3	53.9	14.6	
Vert.	4824.000	AV	42.4	31.1	7.9	37.1	0.4	44.7	53.9	9.2	
Vert.	7236.000	AV	36.5	37.1	9.1	39.4	0.4	43.7	53.9	10.2	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz) - Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m) = 9.5dB

20dBc Data Sheet (RBW 100kHz, VBW 300kHz)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	2412.000	PK	92.6	26.8	14.7	38.2	95.9	-	-	
Hori.	2400.000	PK	48.4	26.8	14.7	38.2	51.7	75.9	24.2	
Vert.	2412.000	PK	93.1	26.8	14.7	38.2	96.4	-	-	
Vert.	2400.000	PK	47.4	26.8	14.7	38.2	50.7	76.4	25.7	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m) = 9.5dB

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.3 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

December 11, 2013 Date February 10, 2014 Temperature / Humidity 26 deg.C, 31 %RH 25 deg.C , 33 %RH Engineer Shinichi Takano Shinichi Takano

Tx, 2437 MHz Mode

Tx, IEEE802.11b, PN9, worst antenna port 0, worst data mode 1Mbps

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	3249.345	PK	48.8	28.1	6.5	38.1	45.3	73.9	28.6	100	131	
Hori.	4874.000	PK	50.1	31.3	7.9	37.1	52.2	73.9	21.7	100	277	
Hori.	7311.000	PK	45.4	37.2	9.1	39.4	52.3	73.9	21.6	100	0	
Vert.	3249.355	PK	48.2	28.1	6.5	38.1	44.7	73.9	29.2	100	88	
Vert.	4874.000	PK	47.1	31.3	7.9	37.1	49.2	73.9	24.7	100	342	
Vert.	7311.000	PK	45.3	37.2	9.1	39.4	52.2	73.9	21.7	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	3249.345	AV	43.1	28.1	6.5	38.1	0.4	40.0	53.9	13.9	
Hori.	4874.000	AV	45.5	31.3	7.9	37.1	0.4	48.0	53.9	5.9	
Hori.	7311.000	AV	35.9	37.2	9.1	39.4	0.4	43.2	53.9	10.7	
Vert.	3249.355	AV	42.7	28.1	6.5	38.1	0.4	39.6	53.9	14.3	
Vert.	4874.000	AV	41.4	31.3	7.9	37.1	0.4	43.9	53.9	10.0	
Vert.	7311.000	AV	36.0	37.2	9.1	39.4	0.4	43.3	53.9	10.6	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.2 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

December 11, 2013 Date February 10, 2014 26 deg.C, 31 %RH 25 deg.C , 33 %RH Temperature / Humidity Engineer Shinichi Takano Shinichi Takano

Mode Tx, 2462 MHz

Tx, IEEE802.11b, PN9, worst antenna port 0, worst data mode 1Mbps

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	2483.500	PK	48.0	26.9	14.8	38.1	51.6	73.9	22.3	100	233	
Hori.	3282.000	PK	46.2	28.1	6.5	38.0	42.8	73.9	31.1	100	307	
Hori.	4924.000	PK	49.8	31.6	7.8	37.0	52.2	73.9	21.7	100	267	
Hori.	7386.000	PK	45.4	37.3	9.3	39.4	52.6	73.9	21.3	100	0	
Hori.	2483.500	AV	37.8	26.9	14.8	38.1	41.4	53.9	12.5	100	233	
Vert.	2483.500	PK	48.7	26.9	14.8	38.1	52.3	73.9	21.6	100	198	
Vert.	3282.708	PK	45.2	28.1	6.5	38.0	41.8	73.9	32.1	100	315	
Vert.	4924.000	PK	48.2	31.6	7.8	37.0	50.6	73.9	23.3	100	255	
Vert.	7386.000	PK	45.4	37.3	9.3	39.4	52.6	73.9	21.3	100	0	
Vert.	2483.500	AV	39.8	26.9	14.8	38.1	43.4	53.9	10.5	100	198	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

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Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	3282.000	AV	39.0	28.1	6.5	38.0	0.4	36.0	53.9	17.9	
Hori.	4924.000	AV	45.8	31.6	7.8	37.0	0.4	48.6	53.9	5.3	
Hori.	7386.000	AV	35.6	37.3	9.3	39.4	0.4	43.2	53.9	10.7	
Vert.	3282.708	AV	39.1	28.1	6.5	38.0	0.4	36.1	53.9	17.8	
Vert.	4924.000	AV	43.0	31.6	7.8	37.0	0.4	45.8	53.9	8.1	
Vert.	7386.000	AV	36.3	37.3	9.3	39.4	0.4	43.9	53.9	10.0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.2 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

Date November 26, 2013 February 10, 2014 25 deg.C, 42 %RH 25 deg.C , 33 %RH Temperature / Humidity Shinichi Takano Engineer Hikaru shirasawa

Mode Tx, 2412 MHz

Tx, IEEE802.11g, PN9, worst antenna port 0, worst data mode 6Mbps

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	2384.233	PK	59.4	26.8	14.7	38.3	62.6	73.9	11.3	100	121	
Hori.	2390.000	PK	58.1	26.8	14.7	38.2	61.4	73.9	12.5	100	121	
Hori.	3216.012	PK	51.7	28.2	6.6	41.7	44.8	73.9	29.1	100	253	
Hori.	4824.000	PK	48.7	31.1	7.9	37.1	50.6	73.9	23.3	100	273	
Hori.	7236.000	PK	46.6	37.1	9.1	39.4	53.4	73.9	20.5	100	0	
Hori.	2384.233	AV	42.6	26.8	14.7	38.3	45.8	53.9	8.1	100	121	
Hori.	2390.000	AV	42.5	26.8	14.7	38.2	45.8	53.9	8.1	100	121	
Vert.	2384.409	PK	53.0	26.8	14.7	38.3	56.2	73.9	17.7	100	5	
Vert.	2390.000	PK	54.1	26.8	14.7	38.2	57.4	73.9	16.5	100	5	
Vert.	3215.956	PK	49.3	28.2	6.6	41.7	42.4	73.9	31.5	100	218	
Vert.	4824.000	PK	45.1	31.1	7.9	37.1	47.0	73.9	26.9	100	232	
Vert.	7236.000	PK	45.6	37.1	9.1	39.4	52.4	73.9	21.5	100	0	
Vert.	2384.409	AV	43.5	26.8	14.7	38.3	46.7	53.9	7.2	100	5	
Vert.	2390.000		43.3	26.8	14.7	38.2	46.6	53.9	7.3	100	5	

Result = Reading + Ant.Fac. + Loss (Cable + (Attenuator or Filter) (below 18GHz) - Distance factor (above 15GHz)) - Gain (Amprifier) - Gain (Amp

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Average ii	Average measurement value with duty factor													
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark			
							Factor							
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]				
Hori.	3216.012	AV	47.3	28.2	6.6	41.7	0.4	40.8	53.9	13.1				
Hori.	4824.000	AV	38.4	31.1	7.9	37.1	0.4	40.7	53.9	13.2				
Hori.	7236.000	AV	36.6	37.1	9.1	39.4	0.4	43.8	53.9	10.1				
Vert.	3215.956	AV	43.8	28.2	6.6	41.7	0.4	37.3	53.9	16.6				
Vert.	4824.000	AV	36.1	31.1	7.9	37.1	0.4	38.4	53.9	15.5				
Vert.	7236.000	AV	36.4	37.1	9.1	39.4	0.4	43.6	53.9	10.3				

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

20dBc Data Sheet (RBW 100kHz, VBW 300kHz)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	2412.000	PK	89.3	26.8	14.7	38.2	92.6	-	-	
Hori.	2400.000	PK	51.6	26.8	14.7	38.2	54.9	72.6	17.7	
Vert.	2412.000	PK	89.3	26.8	14.7	38.2	92.6	-	-	
Vert.	2400.000	PK	50.6	26.8	14.7	38.2	53.9	72.6	18.7	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.3 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

Date November 26, 2013 February 10, 2014 25 deg.C, 42 %RH 25 deg.C , 33 %RH Temperature / Humidity Engineer Hikaru shirasawa Shinichi Takano

2437 MHz Mode Tx,

Tx, IEEE802.11g, PN9, worst antenna port 0, worst data mode 6Mbps

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	3249.343	PK	50.3	28.1	6.6	41.7	43.3	73.9	30.6	100	253	
Hori.	4874.000	PK	46.8	31.3	7.9	37.1	48.9	73.9	25.0	100	137	
Hori.	7311.000	PK	45.1	37.2	9.1	39.4	52.0	73.9	21.9	100	0	
Vert.	3249.568	PK	49.9	28.1	6.6	41.7	42.9	73.9	31.0	100	209	
Vert.	4874.000	PK	45.3	31.3	7.9	37.1	47.4	73.9	26.5	100	152	
Vert.	7311.000	PK	45.6	37.2	9.1	39.4	52.5	73.9	21.4	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	3249.343	AV	45.0	28.1	6.6	41.7	0.4	38.4	53.9	15.5	
Hori.	4874.000	AV	37.3	31.3	7.9	37.1	0.4	39.8	53.9	14.1	
Hori.	7311.000	AV	36.0	37.2	9.1	39.4	0.4	43.3	53.9	10.6	
Vert.	3249.568	AV	44.3	28.1	6.6	41.7	0.4	37.7	53.9	16.2	
Vert.	4874.000	AV	35.7	31.3	7.9	37.1	0.4	38.2	53.9	15.7	
Vert.	7311.000	AV	36.3	37.2	9.1	39.4	0.4	43.6	53.9	10.3	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.2 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

Date November 26, 2013 February 10, 2014 25 deg.C, 42 %RH 25 deg.C , 33 %RH Temperature / Humidity Engineer Hikaru shirasawa Shinichi Takano

Mode Tx, 2462 MHz

Tx, IEEE802.11g, PN9, worst antenna port 0, worst data mode 6Mbps

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	2483.500	PK	55.4	26.9	14.8	38.1	59.0	73.9	14.9	100	231	
Hori.	2490.420	PK	52.4	26.9	14.8	38.1	56.0	73.9	17.9	100	231	
Hori.	3282.465	PK	49.9	28.1	6.6	41.7	42.9	73.9	31.0	100	256	
Hori.	4924.000	PK	46.5	31.6	7.8	37.0	48.9	73.9	25.0	100	139	
Hori.	7386.000	PK	44.8	37.3	9.3	39.4	52.0	73.9	21.9	100	0	
Hori.	2483.500	AV	45.3	26.9	14.8	38.1	48.9	53.9	5.0	100	231	
Hori.	2490.420	AV	43.4	26.9	14.8	38.1	47.0	53.9	6.9	100	231	
Vert.	2483.500	PK	56.7	26.9	14.8	38.1	60.3	73.9	13.6	100	196	
Vert.	2490.420	PK	55.8	26.9	14.8	38.1	59.4	73.9	14.5	100	196	
Vert.	3282.670	PK	49.3	28.1	6.6	41.7	42.3	73.9	31.6	100	198	
Vert.	4924.000	PK	46.8	31.6	7.8	37.0	49.2	73.9	24.7	100	256	
Vert.	7386.000	PK	45.3	37.3	9.3	39.4	52.5	73.9	21.4	100	0	
Vert.	2483.500	AV	46.9	26.9	14.8	38.1	50.5	53.9	3.4	100	196	
Vert.	2490.420	AV	46.2	26.9	14.8	38.1	49.8	53.9	4.1	100	196	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

ge	Toruge measurement value with unity factor													
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark			
							Factor							
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]				
Hori.	3282.465	AV	43.6	28.1	6.6	41.7	0.4	37.0	53.9	16.9				
Hori.	4924.000	AV	37.0	31.6	7.8	37.0	0.4	39.8	53.9	14.1				
Hori.	7386.000	AV	35.7	37.3	9.3	39.4	0.4	43.3	53.9	10.6				
Vert.	3282.670	AV	43.4	28.1	6.6	41.7	0.4	36.8	53.9	17.1				
Vert.	4924.000	AV	36.4	31.6	7.8	37.0	0.4	39.2	53.9	14.7				
Vert	7386 000	AV	36.0	37.3	93	39 4	0.4	43.6	53.9	10.3				

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.2 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

Date November 26, 2013 January 25, 2014 25 deg.C, 42 %RH 23 deg.C , 31 %RH Temperature / Humidity Engineer Tatsuya Arai Shinichi Takano

Mode Tx, 2412 MHz

Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode 2(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	390.489	QP	33.1	16.1	9.0	32.0	26.2	46.0	19.8	100	97	
Hori.	2390.000	PK	63.2	26.8	14.7	38.2	66.5	73.9	7.4	100	45	
Hori.	3216.055	PK	50.6	28.2	6.6	41.7	43.7	73.9	30.2	100	146	
Hori.	4824.000	PK	46.9	31.1	7.9	37.1	48.8	73.9	25.1	100	288	
Hori.	7236.000	PK	48.3	37.1	9.1	39.4	55.1	73.9	18.8	118	303	
Hori.	2390.000	AV	45.3	26.8	14.7	38.2	48.6	53.9	5.3	100	45	
Vert.	78.935	QP	57.3	6.3	7.4	32.1	38.9	40.0	1.1	100	106	
Vert.	91.804	QP	56.0	8.5	7.5	32.1	39.9	43.5	3.6	100	167	
Vert.	117.544	QP	44.4	12.7	7.2	32.1	32.2	43.5	11.3	100	148	
Vert.	157.855	QP	42.2	14.8	7.8	32.1	32.7	43.5	10.8	100	162	
Vert.	390.489	QP	33.6	16.1	9.0	32.0	26.7	46.0	19.3	128	170	
Vert.	2390.000	PK	61.8	26.8	14.7	38.2	65.1	73.9	8.8	100	60	
Vert.	3216.055	PK	51.9	28.2	6.6	41.7	45.0	73.9	28.9	102	280	
Vert.	4824.000	PK	47.0	31.1	7.9	37.1	48.9	73.9	25.0	104	355	
Vert.	7236.000	PK	46.3	37.1	9.1	39.4	53.1	73.9	20.8	100	359	
Vert.	2390.000		46.3	26.8	14.7	38.2	49.6	53.9	4.3	100	60	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Tiverage II	tverage measurement value with duty factor													
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark			
							Factor							
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]				
Hori.	3216.055	AV	45.0	28.2	6.6	41.7	0.4	38.5	53.9	15.4				
Hori.	4824.000	AV	38.2	31.1	7.9	37.1	0.4	40.5	53.9	13.4				
Hori.	7236.000	AV	38.3	37.1	9.1	39.4	0.4	45.5	53.9	8.4				
Vert.	3216.055	AV	47.7	28.2	6.6	41.7	0.4	41.2	53.9	12.7				
Vert.	4824.000	AV	37.8	31.1	7.9	37.1	0.4	40.1	53.9	13.8				
Vert.	7236.000	AV	37.5	37.1	9.1	39.4	0.4	44.7	53.9	9.2				

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

20dBc Data Sheet (RBW 100kHz, VBW 300kHz)

	· Sirect	(222 2002	,	·						
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	2412.000	PK	92.9	26.8	14.7	38.2	96.2	-	-	
Hori.	2400.000	PK	58.0	26.8	14.7	38.2	61.3	76.2	14.9	
Vert.	2412.000	PK	94.0	26.8	14.7	38.2	97.3	-	-	
Vert.	2400.000	PK	55.0	26.8	14.7	38.2	58.3	77.3	19.0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.3 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

January 25, 2014 Date November 26, 2013 25 deg.C, 42 %RH 23 deg.C , 31 %RH Temperature / Humidity Engineer Tatsuya Arai Shinichi Takano

2437 MHz Mode Tx,

Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode 2(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	3249.373	PK	48.7	28.1	6.6	41.7	41.7	73.9	32.2	100	318	
Hori.	4874.000	PK	46.2	31.3	7.9	37.1	48.3	73.9	25.6	100	219	
Hori.	7311.000	PK	47.3	37.2	9.1	39.4	54.2	73.9	19.7	100	236	
Vert.	3249.373	PK	50.6	28.1	6.6	41.7	43.6	73.9	30.3	110	268	
Vert.	4874.000	PK	45.8	31.3	7.9	37.1	47.9	73.9	26.0	100	254	
Vert.	7311.000	PK	47.3	37.2	9.1	39.4	54.2	73.9	19.7	117	359	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	3249.373	AV	42.6	28.1	6.6	41.7	0.4	36.0	53.9	17.9	
Hori.	4874.000	AV	37.1	31.3	7.9	37.1	0.4	39.6	53.9	14.3	
Hori.	7311.000	AV	37.6	37.2	9.1	39.4	0.4	44.9	53.9	9.0	
Vert.	3249.373	AV	45.4	28.1	6.6	41.7	0.4	38.8	53.9	15.1	
Vert.	4874.000	AV	36.8	31.3	7.9	37.1	0.4	39.3	53.9	14.6	
Vert.	7311.000	AV	37.6	37.2	9.1	39.4	0.4	44.9	53.9	9.0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.2 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

January 25, 2014 Date November 26, 2013 25 deg.C, 42 %RH 23 deg.C , 31 %RH Temperature / Humidity Engineer Tatsuya Arai Shinichi Takano

Mode Tx, 2462 MHz

Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode 2(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	2483.500	PK	58.4	26.9	14.8	38.1	62.0	73.9	11.9	100	49	
Hori.	3282.722	PK	48.1	28.1	6.6	41.7	41.1	73.9	32.8	100	248	
Hori.	4924.000	PK	46.3	31.6	7.8	37.0	48.7	73.9	25.2	100	224	
Hori.	7386.000	PK	45.3	37.3	9.3	39.4	52.5	73.9	21.4	108	95	
Hori.	2483.500	AV	47.6	26.9	14.8	38.1	51.2	53.9	2.7	100	49	
Vert.	2483.500	PK	61.9	26.9	14.8	38.1	65.5	73.9	8.4	100	34	
Vert.	3282.722	PK	49.7	28.1	6.6	41.7	42.7	73.9	31.2	100	270	
Vert.	4924.000	PK	48.0	31.6	7.8	37.0	50.4	73.9	23.5	100	256	
Vert.	7386.000	PK	47.7	37.3	9.3	39.4	54.9	73.9	19.0	100	175	
Vert.	2483.500	AV	47.4	26.9	14.8	38.1	51.0	53.9	2.9	100	34	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	3282.722	AV	41.0	28.1	6.6	41.7	0.4	34.4	53.9	19.5	
Hori.	4924.000	AV	37.5	31.6	7.8	37.0	0.4	40.3	53.9	13.6	
Hori.	7386.000	AV	37.1	37.3	9.3	39.4	0.4	44.7	53.9	9.2	
Vert.	3282.722	AV	43.3	28.1	6.6	41.7	0.4	36.7	53.9	17.2	
Vert.	4924.000	AV	38.3	31.6	7.8	37.0	0.4	41.1	53.9	12.8	
Vert.	7386.000	AV	38.2	37.3	9.3	39.4	0.4	45.8	53.9	8.1	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.3 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

Date November 26, 2013 January 25, 2014 25 deg.C, 42 %RH 23 deg.C , 31 %RH Temperature / Humidity Engineer Tatsuya Arai Shinichi Takano

Mode Tx, 2422 MHz

Tx, IEEE802.11n (HT40), CDD, PN9, worst data mode 0(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	2377.000	PK	57.3	26.8	14.7	38.3	60.5	73.9	13.4	100	48	
Hori.	2390.000	PK	61.3	26.8	14.7	38.2	64.6	73.9	9.3	100	48	
Hori.	3229.369	PK	50.0	28.1	6.6	41.7	43.0	73.9	30.9	100	144	
Hori.	4844.000	PK	45.6	31.2	7.9	37.1	47.6	73.9	26.3	100	266	
Hori.	7386.000	PK	44.3	37.3	9.3	39.4	51.5	73.9	22.4	100	0	
Hori.	2377.000	AV	47.6	26.8	14.7	38.3	50.8	53.9	3.1	100	48	
Hori.	2390.000	AV	48.5	26.8	14.7	38.2	51.8	53.9	2.1	100	48	
Vert.	2377.000	PK	58.6	26.8	14.7	38.3	61.8	73.9	12.1	100	81	
Vert.	2390.000	PK	69.0	26.8	14.7	38.2	72.3	73.9	1.6	100	81	
Vert.	3229.369	PK	50.9	28.1	6.6	41.7	43.9	73.9	30.0	100	241	
Vert.	4844.000	PK	44.1	31.2	7.9	37.1	46.1	73.9	27.8	100	31	
Vert.	7386.000	PK	44.6	37.3	9.3	39.4	51.8	73.9	22.1	100	0	
Vert.	2377.000	AV	46.0	26.8	14.7	38.3	49.2	53.9	4.7	100	81	
Vert.	2390.000	AV	49.1	26.8	14.7	38.2	52.4	53.9	1.5	100	81	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Average in	Average measurement value with duty factor													
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark			
							Factor							
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]				
Hori.	3229.369	AV	43.8	28.1	6.6	41.7	0.9	37.7	53.9	16.2				
Hori.	4844.000	AV	36.4	31.2	7.9	37.1	0.9	39.3	53.9	14.6				
Hori.	7386.000	AV	35.9	37.3	9.3	39.4	0.9	44.0	53.9	9.9				
Vert.	3229.369	AV	45.9	28.1	6.6	41.7	0.9	39.8	53.9	14.1				
Vert.	4844.000	AV	35.9	31.2	7.9	37.1	0.9	38.8	53.9	15.1				
Vert.	7386.000	AV	35.6	37.3	9.3	39.4	0.9	43.7	53.9	10.2				

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

20dBc Data Sheet (RBW 100kHz, VBW 300kHz)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	2422.000	PK	91.5	26.8	14.7	38.2	94.8	-	-	
Hori.	2400.000	PK	60.0	26.8	14.7	38.2	63.3	74.8	11.5	
Vert.	2422.000	PK	92.9	26.8	14.7	38.2	96.2	-	-	
Vert.	2400.000	PK	58.4	26.8	14.7	38.2	61.7	76.2	14.5	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.3 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

January 25, 2014 Date November 26, 2013 Temperature / Humidity 25 deg.C, 42 %RH 23 deg.C , 31 %RH Tatsuya Arai Engineer Shinichi Takano

2437 MHz Mode Tx,

Tx, IEEE802.11n (HT40), CDD, PN9, worst data mode 0(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	3249.376	PK	48.9	28.1	6.6	41.7	41.9	73.9	32.0	100	144	
Hori.	4874.000	PK	44.4	31.3	7.9	37.1	46.5	73.9	27.4	100	221	
Hori.	7311.000	PK	44.9	37.2	9.1	39.4	51.8	73.9	22.1	100	0	
Vert.	3249.376	PK	51.6	28.1	6.6	41.7	44.6	73.9	29.3	100	257	
Vert.	4874.000	PK	43.7	31.3	7.9	37.1	45.8	73.9	28.1	100	34	
Vert.	7311.000	PK	45.2	37.2	9.1	39.4	52.1	73.9	21.8	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	3249.376	AV	41.7	28.1	6.6	41.7	0.9	35.6	53.9	18.3	
Hori.	4874.000	AV	35.8	31.3	7.9	37.1	0.9	38.8	53.9	15.1	
Hori.	7311.000	AV	36.3	37.2	9.1	39.4	0.9	44.1	53.9	9.8	
Vert.	3249.376	AV	46.7	28.1	6.6	41.7	0.9	40.6	53.9	13.3	
Vert.	4874.000	AV	34.8	31.3	7.9	37.1	0.9	37.8	53.9	16.1	
Vert.	7311.000	AV	36.4	37.2	9.1	39.4	0.9	44.2	53.9	9.7	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.3 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

Date November 26, 2013 January 25, 2014 25 deg.C, 42 %RH 23 deg.C , 31 %RH Temperature / Humidity Engineer Tatsuya Arai Shinichi Takano

Mode Tx, 2452 MHz

Tx, IEEE802.11n (HT40), CDD, PN9, worst data mode 0(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	2483.500	PK	60.6	26.9	14.8	38.1	64.2	73.9	9.7	100	51	
Hori.	2498.565	PK	53.6	26.9	14.8	38.1	57.2	73.9	16.7	100	51	
Hori.	3269.376	PK	47.5	28.1	6.6	41.7	40.5	73.9	33.4	100	74	
Hori.	4904.000	PK	46.0	31.5	7.8	37.0	48.3	73.9	25.6	100	285	
Hori.	7356.000	PK	46.4	37.2	9.2	39.4	53.4	73.9	20.5	107	94	
Hori.	2483.500	AV	45.9	26.9	14.8	38.1	49.5	53.9	4.4	100	51	
Hori.	2498.565	AV	45.1	26.9	14.8	38.1	48.7	53.9	5.2	100	51	
Vert.	2483.500	PK	59.9	26.9	14.8	38.1	63.5	73.9	10.4	100	359	
Vert.	2498.565	PK	55.6	26.9	14.8	38.1	59.2	73.9	14.7	100	359	
Vert.	3269.376	PK	49.1	28.1	6.6	41.7	42.1	73.9	31.8	100	277	
Vert.	4904.000	PK	45.4	31.5	7.8	37.0	47.7	73.9	26.2	100	167	
Vert.	7356.000	PK	45.7	37.2	9.2	39.4	52.7	73.9	21.2	100	0	
Vert.	2483.500	AV	47.2	26.9	14.8	38.1	50.8	53.9	3.1	100	359	
Vert.	2498.565	AV	47.1	26.9	14.8	38.1	50.7	53.9	3.2	100	359	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Average in	Average measurement value with duty factor													
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark			
							Factor							
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]				
Hori.	3269.376	AV	40.6	28.1	6.6	41.7	0.9	34.5	53.9	19.4				
Hori.	4904.000	AV	35.6	31.5	7.8	37.0	0.9	38.8	53.9	15.1				
Hori.	7356.000	AV	37.1	37.2	9.2	39.4	0.9	45.0	53.9	8.9				
Vert.	3269.376	AV	42.0	28.1	6.6	41.7	0.9	35.9	53.9	18.0				
Vert.	4904.000	AV	35.4	31.5	7.8	37.0	0.9	38.6	53.9	15.3				
Vert.	7356.000	AV	36.8	37.2	9.2	39.4	0.9	44.7	53.9	9.2				

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m) = 9.5dB

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber Test place

November 22 2013 Date November 20, 2013 November 21, 2013 20 deg.C, 40 %RH 27 deg.C, 26 %RH 25 deg.C, 39 %RH Temperature / Humidity Engineer Akio Hayashi Akio Hayashi Akio Hayashi

Mode Tx, 5745 MHz

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	11490.000	PK	45.7	40.6	9.7	39.4	56.6	73.9	17.3	100	100	
Hori.	17235.000	PK	45.5	40.8	2.6	40.6	48.3	73.9	25.6	100	0	
Vert.	11490.000	PK	45.7	40.6	9.7	39.4	56.6	73.9	17.3	100	100	
Vert.	17235.000	PK	45.1	40.8	2.6	40.6	47.9	73.9	26.0	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)
Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	11490.000	AV	36.7	40.6	9.7	39.4	0.4	48.0	53.9	5.9	
Hori.	17235.000	AV	35.4	40.8	2.6	40.6	0.4	38.6	53.9	15.3	
Vert.	11490.000	AV	36.9	40.6	9.7	39.4	0.4	48.2	53.9	5.7	
Vert.	17235.000	AV	35.5	40.8	2.6	40.6	0.4	38.7	53.9	15.2	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

(RBW 100kHz, VBW 300kHz) 20dBc Data Sheet

		(,	,						
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	5745.000	PK	89.3	32.4	17.0	40.7	98.0	-	-	
Hori.	5725.000	PK	47.9	32.4	17.0	40.7	56.6	78.0	21.4	
Vert.	5745.000	PK	88.1	32.4	17.0	40.7	96.8	-	-	
Vert.	5725.000	PK	47.7	32.4	17.0	40.7	56.4	76.8	20.4	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber Test place

November 21, 2013 November 22 2013 Date 27 deg.C, 26 %RH 25 deg.C, 39 %RH Temperature / Humidity Engineer Akio Hayashi Akio Hayashi

Mode Tx, 5785 MHz

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	11570.000	PK	47.3	40.5	9.7	39.3	58.2	73.9	15.7	100	100	
Hori.	17355.000	PK	45.0	41.9	2.8	40.6	49.1	73.9	24.8	100	0	
Vert.	11570.000	PK	46.3	40.5	9.7	39.3	57.2	73.9	16.7	100	100	
Vert.	17355.000	PK	45.1	41.9	2.8	40.6	49.2	73.9	24.7	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	11570.000	AV	37.3	40.5	9.7	39.3	0.4	48.6	53.9	5.3	
Hori.	17355.000	AV	37.0	41.9	2.8	40.6	0.4	41.5	53.9	12.4	
Vert.	11570.000	AV	37.3	40.5	9.7	39.3	0.4	48.6	53.9	5.3	
Vert.	17355.000	AV	36.5	41.9	2.8	40.6	0.4	41.0	53.9	12.9	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.3 Semi Anechoic Chamber No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber Test place

November 22 2013 Date November 20, 2013 November 21, 2013 20 deg.C, 40 %RH 27 deg.C, 26 %RH 25 deg.C, 39 %RH Temperature / Humidity Engineer Akio Hayashi Akio Hayashi Akio Hayashi

Mode Tx, 5825 MHz

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	11650.000	PK	46.8	40.4	9.8	39.3	57.7	73.9	16.2	100	100	
Hori.	17475.000	PK	45.3	42.9	2.8	40.5	50.5	73.9	23.4	100	0	
Vert.	11650.000	PK	46.5	40.4	9.8	39.3	57.4	73.9	16.5	100	100	
Vert.	17475.000	PK	44.6	42.9	2.8	40.5	49.8	73.9	24.1	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)
Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	11650.000	AV	37.5	40.4	9.8	39.3	0.4	48.8	53.9	5.1	
Hori.	17475.000	AV	35.8	42.9	2.8	40.5	0.4	41.4	53.9	12.5	
Vert.	11650.000	AV	37.1	40.4	9.8	39.3	0.4	48.4	53.9	5.5	
Vert.	17475.000	AV	35.9	42.9	2.8	40.5	0.4	41.5	53.9	12.4	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

20dBc Data Sheet (RBW 100kHz, VBW 300kHz)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	5825.000	PK	89.0	32.4	17.1	40.6	97.9	-	-	
Hori.	5850.000	PK	42.0	32.3	17.1	40.6	50.8	77.9	27.1	
Hori.	5857.875	PK	41.8	32.3	17.1	40.6	50.6	77.9	27.3	
Vert.	5825.000	PK	86.5	32.4	17.1	40.6	95.4	-	-	
Vert.	5850.000	PK	41.4	32.3	17.1	40.6	50.2	75.4	25.2	
Vert.	5857.875	PK	41.0	32.3	17.1	40.6	49.8	75.4	25.6	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

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Radiated Emission

No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber No.3 Semi Anechoic Chamber Test place

November 26, 2013 Date November 20, 2013 November 21, 2013 November 22 2013 20 deg.C, 40 %RH 27 deg.C, 26 %RH 25 deg.C, 39 %RH 25 deg.C, 42 %RH Temperature / Humidity Akio Hayashi Engineer Akio Hayashi Akio Hayashi Tatsuya Arai

Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode 0(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

5745 MHz

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	390.664	QP	34.7	16.1	9.0	32.0	27.8	46.0	18.2	100	92	
Hori.	11490.000	PK	46.0	40.6	9.7	39.4	56.9	73.9	17.0	100	100	
Hori.	17235.000	PK	44.4	40.8	2.6	40.6	47.2	73.9	26.7	100	0	
Vert.	80.355	QP	56.4	6.3	7.4	32.1	38.0	40.0	2.0	100	2	
Vert.	119.051	QP	48.4	12.9	7.2	32.1	36.4	43.5	7.1	100	211	
Vert.	151.217	QP	41.7	14.6	7.7	32.1	31.9	43.5	11.6	100	171	
Vert.	390.664	QP	33.7	16.1	9.0	32.0	26.8	46.0	19.2	122	176	
Vert.	11490.000	PK	45.8	40.6	9.7	39.4	56.7	73.9	17.2	100	100	
Vert.	17235.000	PK	44.2	40.8	2.6	40.6	47.0	73.9	26.9	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

Tx,

Average measurement value with duty factor

Mode

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	11490.000	AV	36.7	40.6	9.7	39.4	0.4	48.0	53.9	5.9	
Hori.	17235.000	AV	35.4	40.8	2.6	40.6	0.4	38.6	53.9	15.3	
Vert.	11490.000	AV	37.4	40.6	9.7	39.4	0.4	48.7	53.9	5.2	
Vert.	17235.000	AV	35.6	40.8	2.6	40.6	0.4	38.8	53.9	15.1	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m) = 9.5dB

20dBc Data Sheet (RBW 100kHz, VBW 300kHz)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	5745.000	PK	92.2	32.4	17.0	40.7	100.9	-	-	
Hori.	5725.000	PK	55.8	32.4	17.0	40.7	64.5	80.9	16.4	
Vert.	5745.000	PK	92.8	32.4	17.0	40.7	101.5	-	-	
Vert.	5725.000	PK	57.1	32.4	17.0	40.7	65.8	81.5	15.7	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber Test place

November 22 2013 Date November 21, 2013 27 deg.C, 26 %RH 25 deg.C, 39 %RH Temperature / Humidity Akio Hayashi Engineer Akio Hayashi

Mode Tx, 5785 MHz

Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode 0(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	11570.000	PK	46.7	40.5	9.7	39.3	57.6	73.9	16.3	100	100	
Hori.	17335.000	PK	45.8	41.7	2.8	40.6	49.7	73.9	24.2	100	0	
Vert.	11570.000	PK	48.7	40.5	9.7	39.3	59.6	73.9	14.3	100	100	
Vert.	17335.000	PK	46.4	41.7	2.8	40.6	50.3	73.9	23.6	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	11570.000	AV	37.5	40.5	9.7	39.3	0.4	48.8	53.9	5.1	
Hori.	17335.000	AV	36.2	41.7	2.8	40.6	0.4	40.5	53.9	13.4	
Vert.	11570.000	AV	37.7	40.5	9.7	39.3	0.4	49.0	53.9	4.9	
Vert.	17335.000	AV	35.9	41.7	2.8	40.6	0.4	40.2	53.9	13.7	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m) = 9.5dB

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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Radiated Emission

No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber Test place

November 22 2013 Date November 20, 2013 November 21, 2013 20 deg.C, 40 %RH 27 deg.C, 26 %RH 25 deg.C, 39 %RH Temperature / Humidity Engineer Akio Hayashi Akio Hayashi Akio Hayashi

Mode Tx, 5825 MHz

Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode 0(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	11650.000	PK	46.7	40.4	9.8	39.3	57.6	73.9	16.3	100	110	
Hori.	17475.000	PK	45.0	42.9	2.8	40.5	50.2	73.9	23.7	100	0	
Vert.	11650.000	PK	46.8	40.4	9.8	39.3	57.7	73.9	16.2	100	100	
Vert.	17475.000	PK	45.5	42.9	2.8	40.5	50.7	73.9	23.2	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)
Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	11650.000	AV	37.4	40.4	9.8	39.3	0.4	48.7	53.9	5.2	
Hori.	17475.000	AV	36.1	42.9	2.8	40.5	0.4	41.7	53.9	12.2	
Vert.	11650.000	AV	37.3	40.4	9.8	39.3	0.4	48.6	53.9	5.3	
Vert.	17475.000	AV	35.8	42.9	2.8	40.5	0.4	41.4	53.9	12.5	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

(RBW 100kHz, VBW 300kHz) 20dBc Data Sheet

	****	(,	,						
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	5825.000	PK	92.0	32.4	17.1	40.6	100.9	-	-	
Hori.	5850.000	PK	46.6	32.3	17.1	40.6	55.4	80.9	25.5	
Vert.	5825.000	PK	90.6	32.4	17.1	40.6	99.5	-	-	
Vert.	5850.000	PK	47.3	32.3	17.1	40.6	56.1	79.5	23.4	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

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Radiated Emission

No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber Test place

November 22 2013 Date November 20, 2013 November 21, 2013 20 deg.C, 40 %RH 27 deg.C, 26 %RH 25 deg.C, 39 %RH Temperature / Humidity Engineer Akio Hayashi Akio Hayashi Akio Hayashi

Mode Tx, 5755 MHz

Tx, IEEE802.11n (HT40), CDD, PN9, worst data mode 0(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	11510.000	PK	46.1	40.5	9.7	39.4	56.9	73.9	17.0	100	100	
Hori.	17265.000	PK	45.2	41.1	2.7	40.6	48.4	73.9	25.5	100	0	
Vert.	11510.000	PK	45.5	40.5	9.7	39.4	56.3	73.9	17.6	100	100	
Vert.	17265.000	PK	44.9	41.1	2.7	40.6	48.1	73.9	25.8	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)
Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	11510.000	AV	36.7	40.5	9.7	39.4	0.9	48.4	53.9	5.5	
Hori.	17265.000	AV	35.7	41.1	2.7	40.6	0.9	39.8	53.9	14.1	
Vert.	11510.000	AV	36.7	40.5	9.7	39.4	0.9	48.4	53.9	5.5	
Vert.	17265.000	AV	35.9	41.1	2.7	40.6	0.9	40.0	53.9	13.9	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

(RBW 100kHz, VBW 300kHz) 20dBc Data Sheet

		(
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark		
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]			
Hori.	5755.000	PK	92.3	32.4	17.1	40.6	101.2	-	-			
Hori.	5725.000	PK	60.0	32.4	17.0	40.7	68.7	81.2	12.5			
Vert.	5755.000	PK	90.6	32.4	17.1	40.6	99.5	-	-			
Vert.	5725.000	PK	60.3	32.4	17.0	40.7	69.0	79.5	10.5			

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

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Radiated Emission

No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber No.2 Semi Anechoic Chamber Test place

November 22 2013 Date November 20, 2013 November 21, 2013 20 deg.C, 40 %RH 27 deg.C, 26 %RH 25 deg.C, 39 %RH Temperature / Humidity Engineer Akio Hayashi Akio Hayashi Akio Hayashi

Mode Tx, 5795 MHz

Tx, IEEE802.11n (HT40), CDD, PN9, worst data mode 0(MCS)

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Height	Angle	Remark
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	[cm]	[deg]	
Hori.	11590.000	PK	47.3	40.4	9.7	39.3	58.1	73.9	15.8	100	100	
Hori.	17385.000	PK	44.8	42.1	2.8	40.6	49.1	73.9	24.8	100	0	
Vert.	11590.000	PK	46.3	40.4	9.7	39.3	57.1	73.9	16.8	100	100	
Vert.	17385.000	PK	45.1	42.1	2.8	40.6	49.4	73.9	24.5	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)
Distance factor: 15GHz - 40GHz: 20log(3.0m/1.0m)= 9.5dB

Average measurement value with duty factor

Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Duty	Result	Limit	Margin	Remark
							Factor				
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]	
Hori.	11590.000	AV	37.6	40.4	9.7	39.3	0.9	49.3	53.9	4.6	
Hori.	17385.000	AV	36.0	42.1	2.8	40.6	0.9	41.2	53.9	12.7	
Vert.	11590.000	AV	37.5	40.4	9.7	39.3	0.9	49.2	53.9	4.7	
Vert.	17385.000	AV	36.2	42.1	2.8	40.6	0.9	41.4	53.9	12.5	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier) + Duty factor Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

(RBW 100kHz, VBW 300kHz) 20dBc Data Sheet

		(=== \(\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \										
Polarity	Frequency	Detector	Reading	Ant.Fac.	Loss	Gain	Result	Limit	Margin	Remark		
	[MHz]		[dBuV]	[dB/m]	[dB]	[dB]	[dBuV/m]	[dBuV/m]	[dB]			
Hori.	5850.000	PK	44.4	32.3	17.1	40.6	53.2	-	-			
Hori.	5795.000	PK	88.4	32.4	17.1	40.6	97.3	33.2	-64.1			
Vert.	5850.000	PK	49.3	32.3	17.1	40.6	58.1	-	-			
Vert.	5795.000	PK	90.3	32.4	17.1	40.6	99.2	38.1	-61.1			

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor: 15GHz -40GHz: 20log(3.0m/1.0m)= 9.5dB

UL Japan, Inc. Shonan EMC Lab.

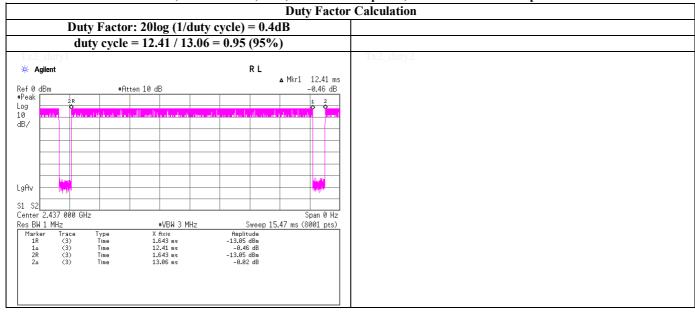
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date December 16, 2013
Temperature / Humidity 27deg.C , 43%RH
Engineer Shinichi Takano

Duty Factor Calculation chart

Tx, IEEE802.11b, PN9, worst antenna port 0, worst data mode 1Mbps



UL Japan, Inc. Shonan EMC Lab.

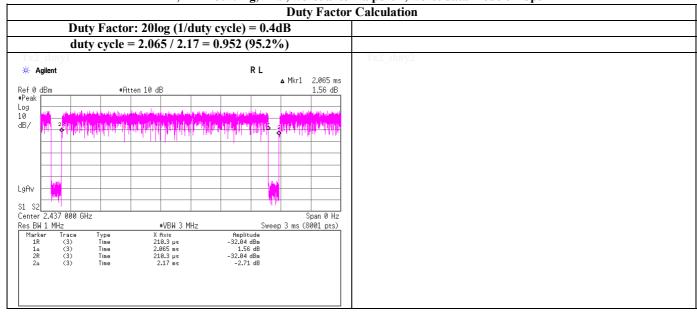
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Duty Factor Calculation chart

Tx, IEEE802.11g, PN9, worst antenna port 1, worst data mode 6Mbps



UL Japan, Inc. Shonan EMC Lab.

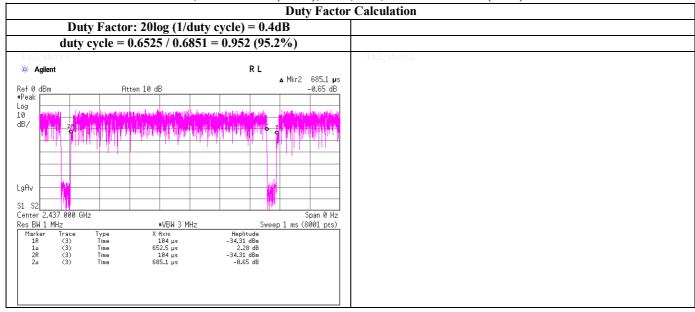
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date December 16, 2013
Temperature / Humidity 27deg.C , 43%RH
Engineer Shinichi Takano

Duty Factor Calculation chart

Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode 2(MCS)



UL Japan, Inc. Shonan EMC Lab.

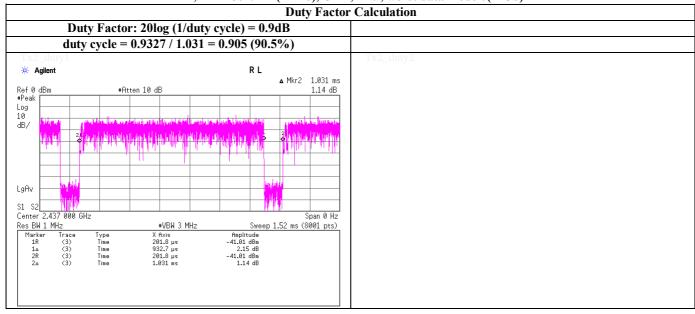
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date December 16, 2013
Temperature / Humidity 27deg.C , 43%RH
Engineer Shinichi Takano

Duty Factor Calculation chart

Tx, IEEE802.11n (HT40), CDD, PN9, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

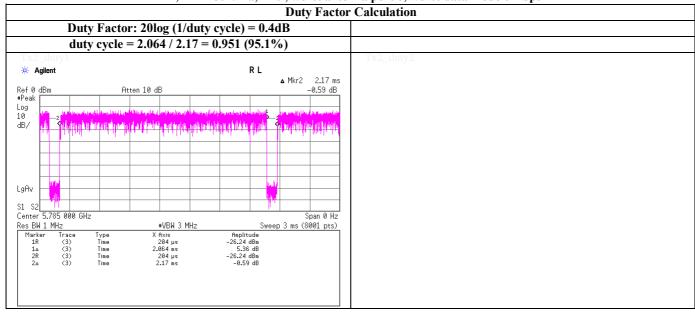
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Duty Factor Calculation chart

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc. Shonan EMC Lab.

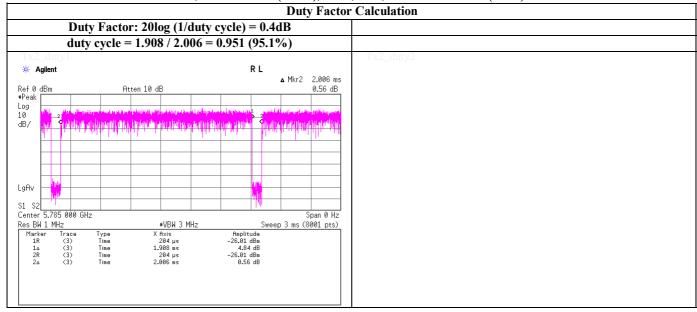
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Duty Factor Calculation chart

Tx, IEEE802.11n (HT20), CDD, PN9, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

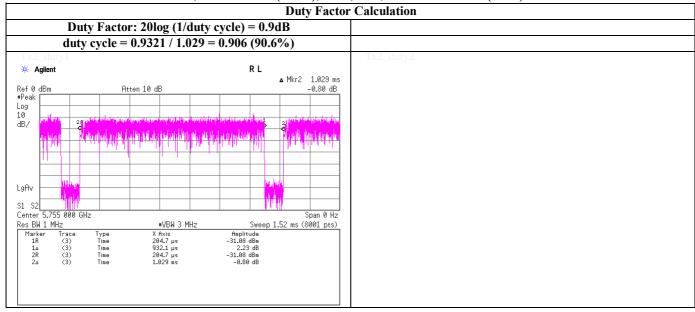
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Duty Factor Calculation chart

Tx, IEEE802.11n (HT40), CDD, PN9, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

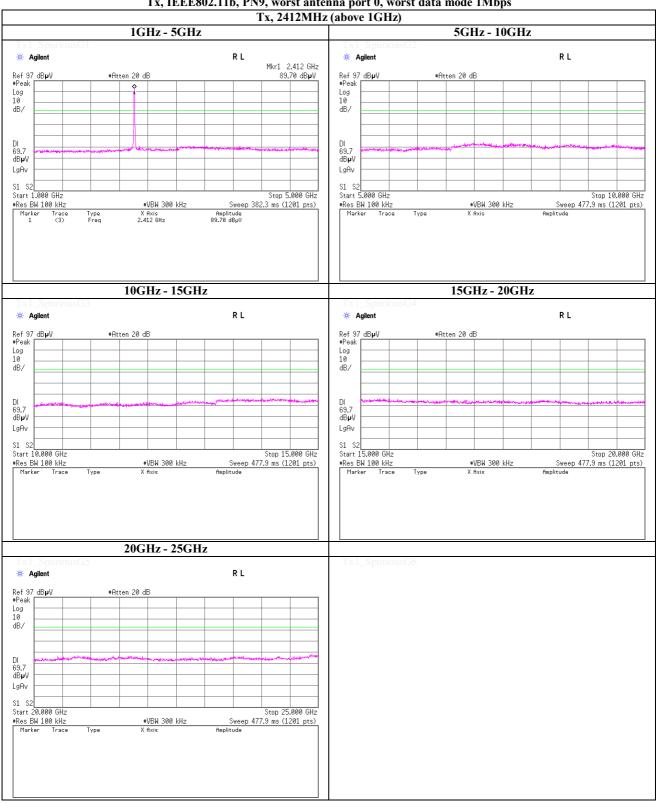
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013 Temperature / Humidity 22deg.C , 31%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11b, PN9, worst antenna port 0, worst data mode 1Mbps



UL Japan, Inc.

Shonan EMC Lab.

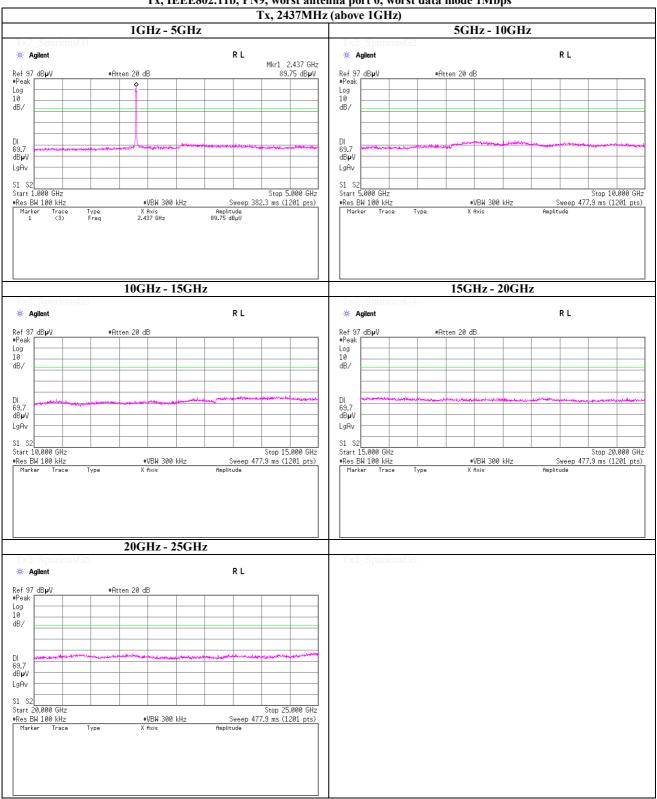
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013
Temperature / Humidity 22deg.C , 31%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11b, PN9, worst antenna port 0, worst data mode 1Mbps



UL Japan, Inc. Shonan EMC Lab.

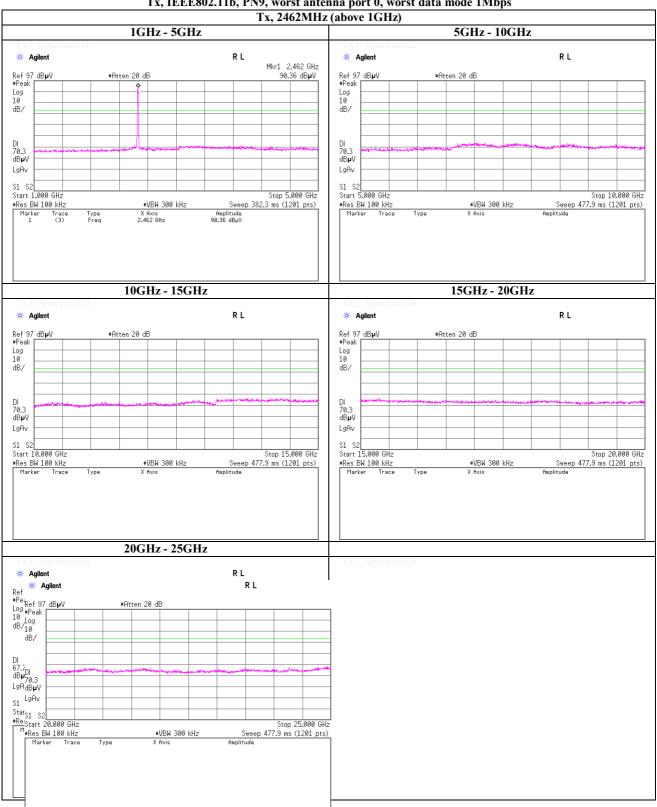
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013 Temperature / Humidity 22deg.C , 31%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11b, PN9, worst antenna port 0, worst data mode 1Mbps



UL Japan, Inc.

Shonan EMC Lab.

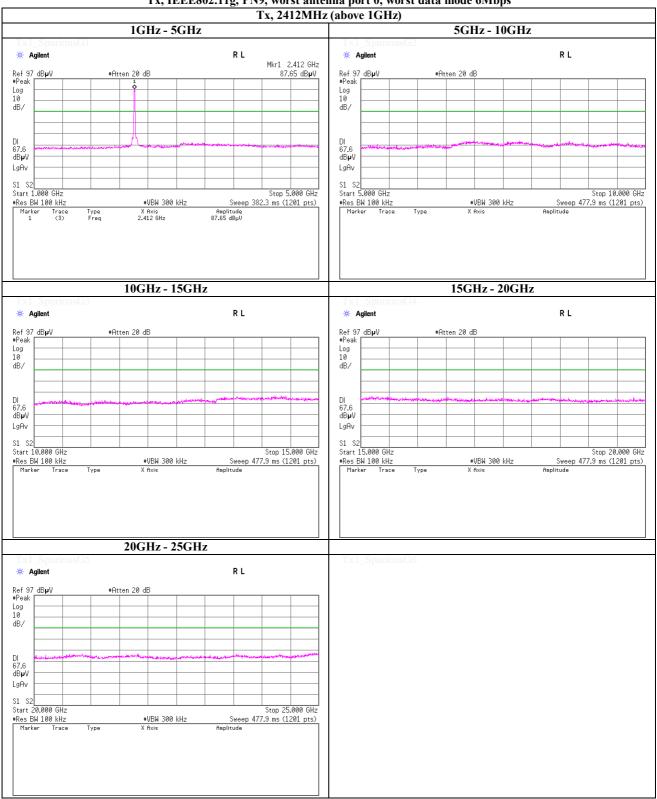
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013
Temperature / Humidity 22deg.C , 31%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11g, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc.

Shonan EMC Lab.

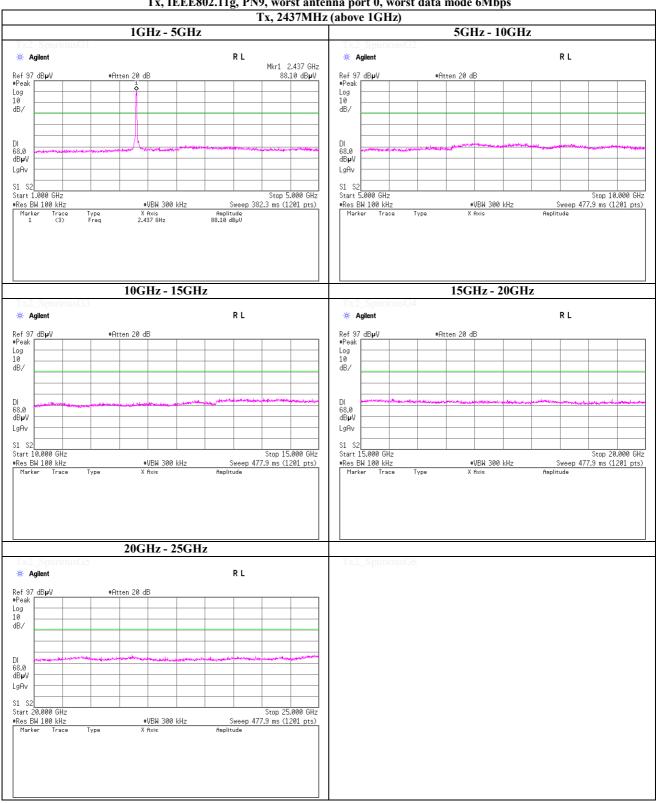
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013 Temperature / Humidity 22deg.C , 31%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11g, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc.

Shonan EMC Lab.

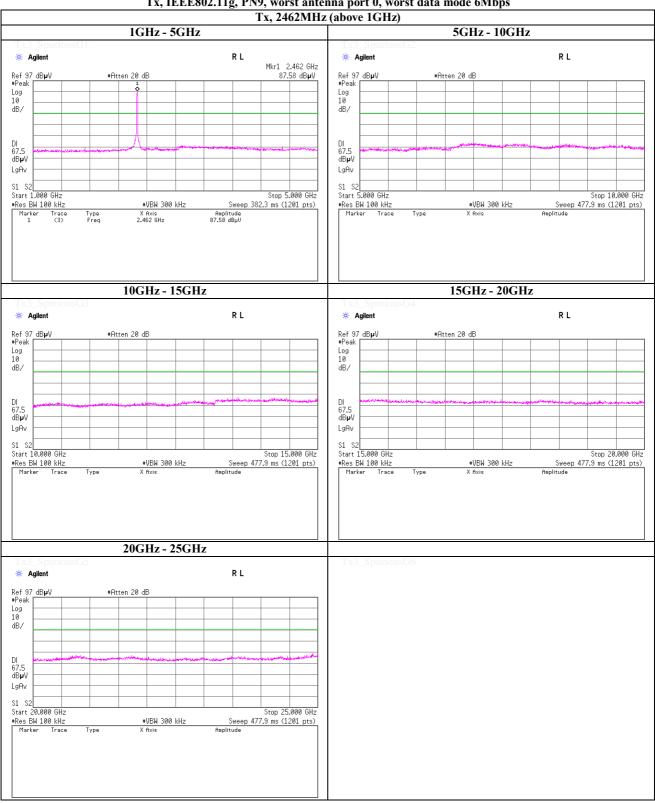
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013 Temperature / Humidity 22deg.C , 31%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11g, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc.

Shonan EMC Lab.

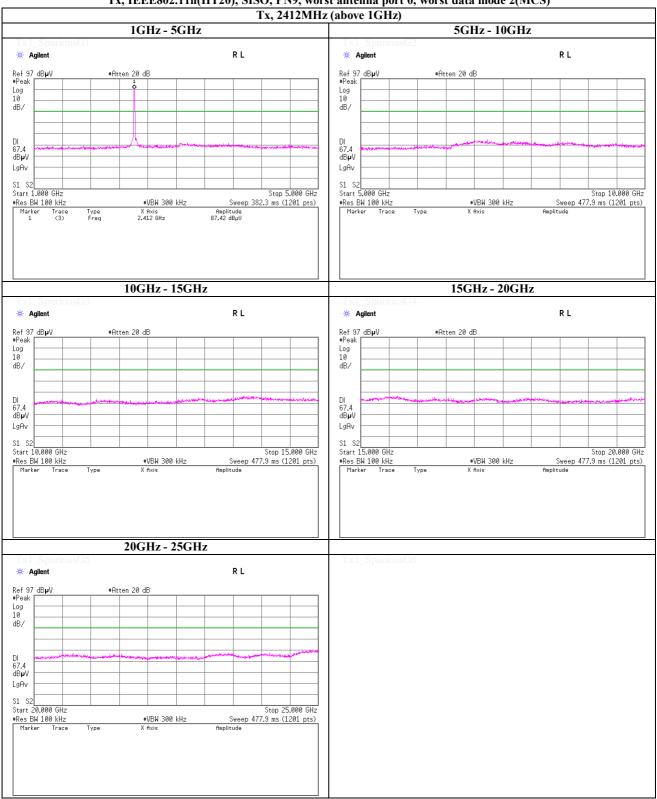
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n(HT20), SISO, PN9, worst antenna port 0, worst data mode 2(MCS)



UL Japan, Inc.

Shonan EMC Lab.

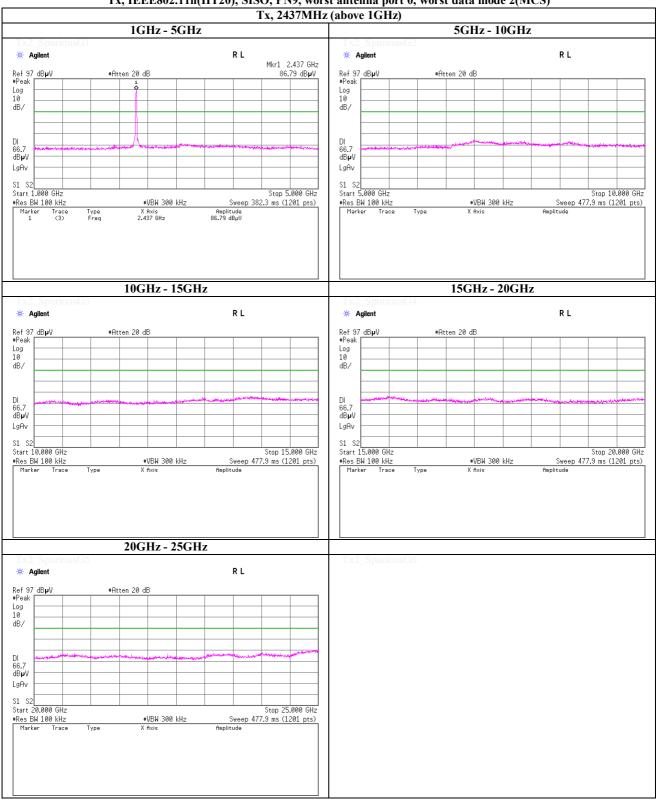
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n(HT20), SISO, PN9, worst antenna port 0, worst data mode 2(MCS)



UL Japan, Inc.

Shonan EMC Lab.

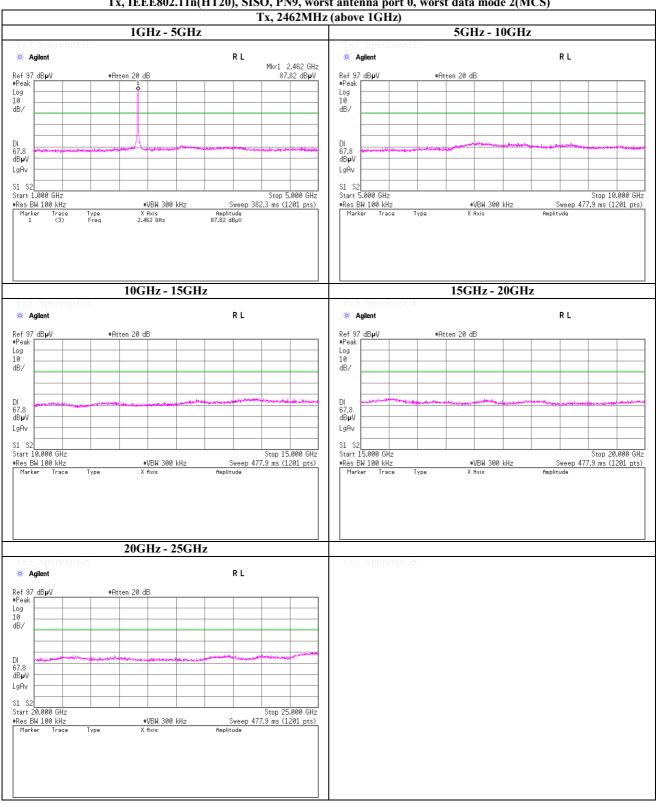
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Shinichi Takano Engineer

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Tx, IEEE802.11n(HT20), SISO, PN9, worst antenna port 0, worst data mode 2(MCS)



UL Japan, Inc.

Shonan EMC Lab.

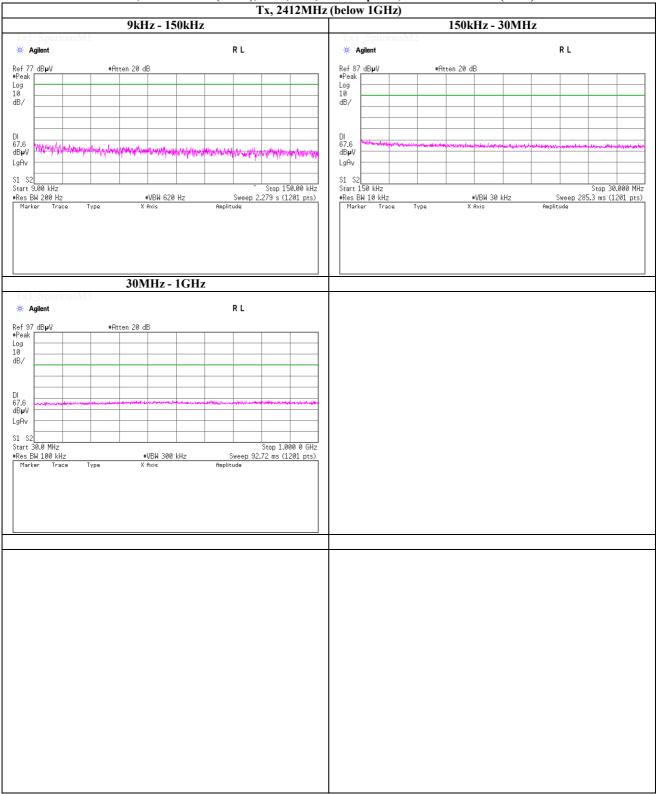
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

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Date January 31, 2014
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Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 2(MCS)



UL Japan, Inc.

Shonan EMC Lab.

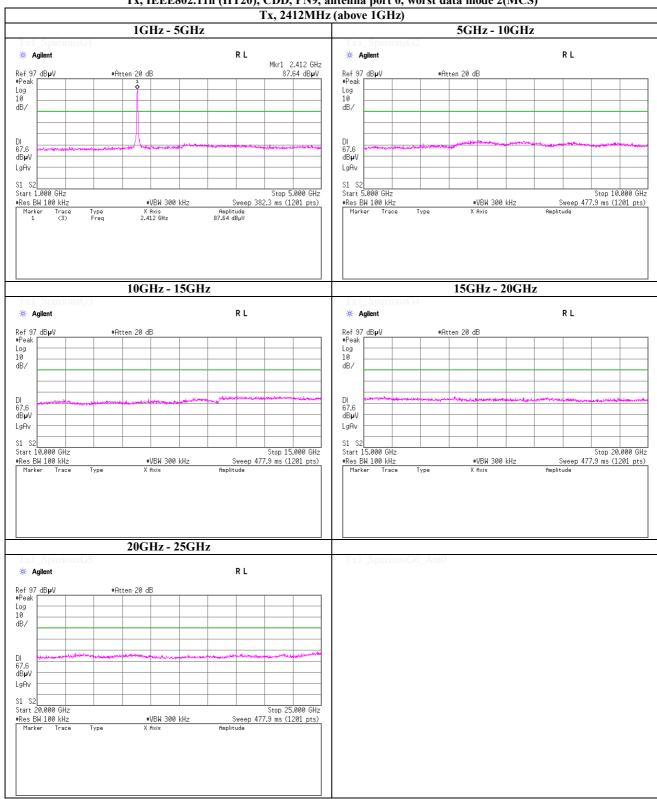
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

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UL Japan, Inc.

Shonan EMC Lab.

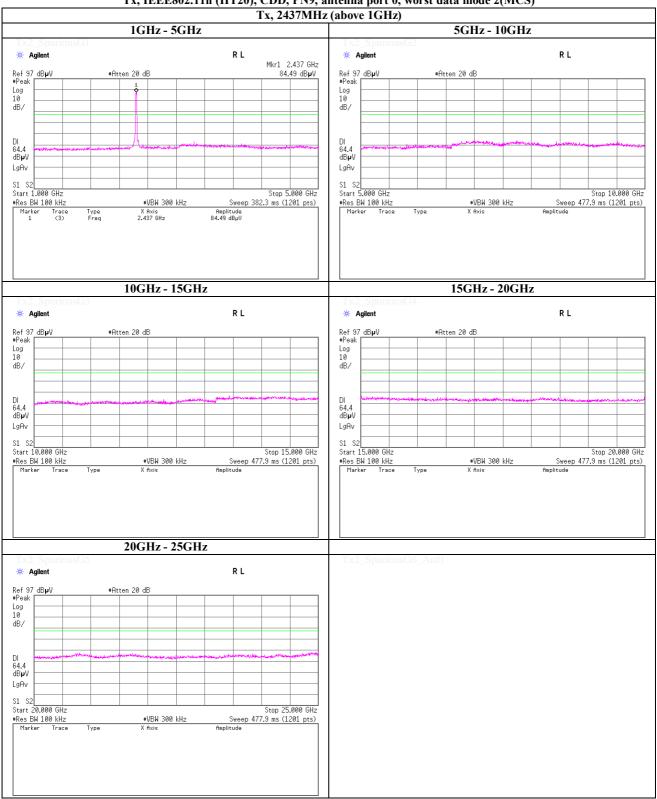
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

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Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 2(MCS)



UL Japan, Inc. Shonan EMC Lab.

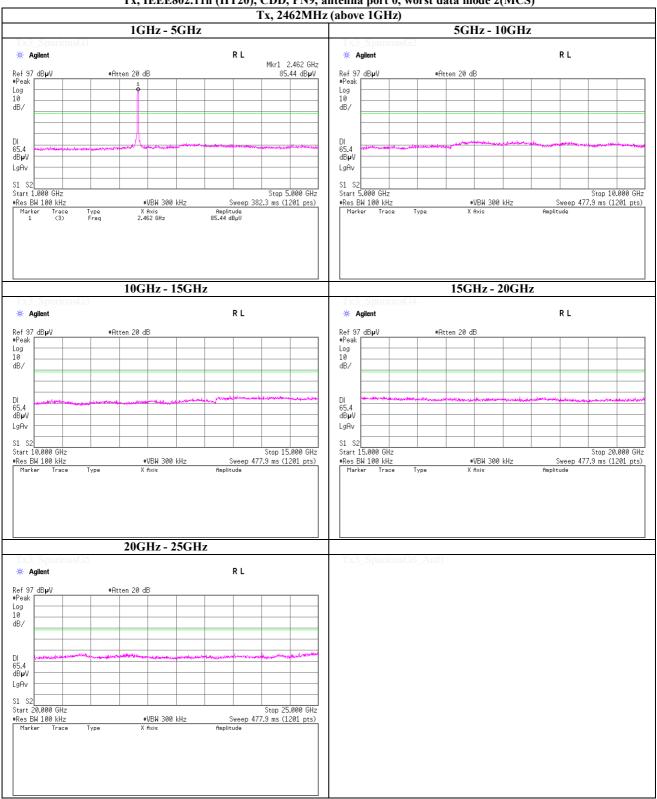
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 2(MCS)



UL Japan, Inc.

Shonan EMC Lab.

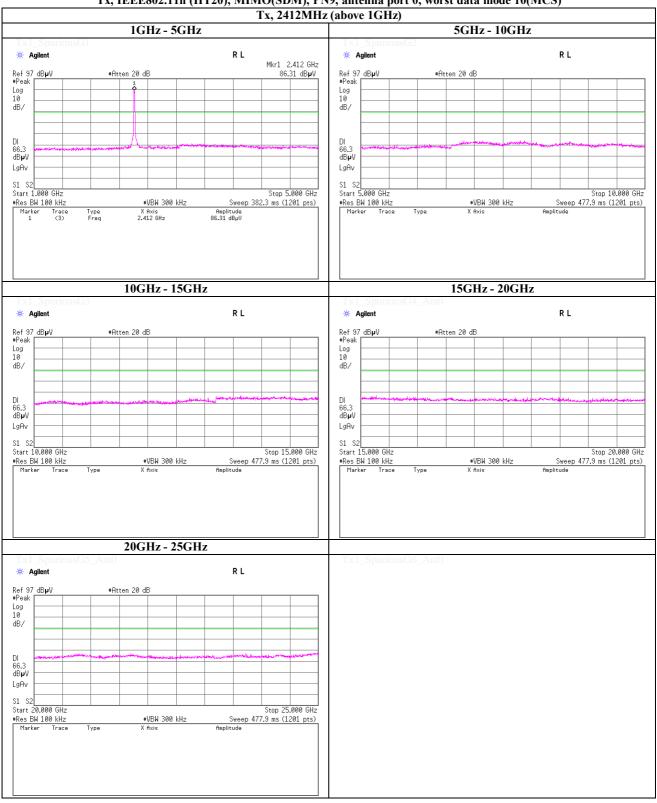
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 10(MCS)



UL Japan, Inc.

Shonan EMC Lab.

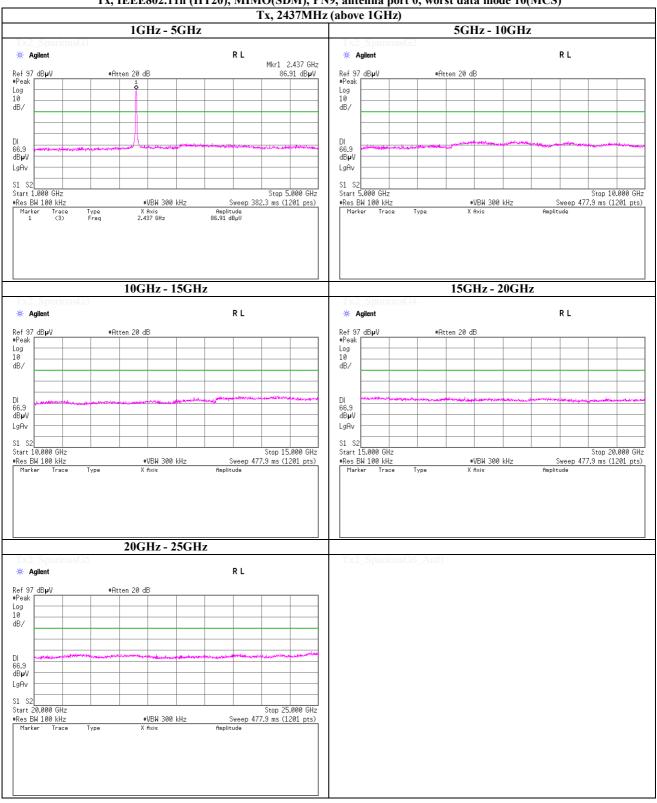
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 10(MCS)



UL Japan, Inc.

Shonan EMC Lab.

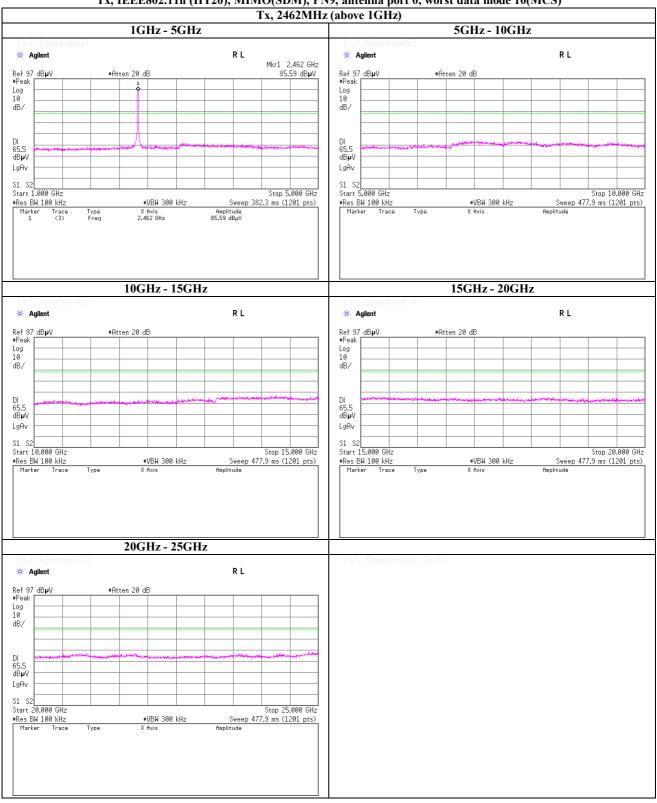
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 10(MCS)



UL Japan, Inc.

Shonan EMC Lab.

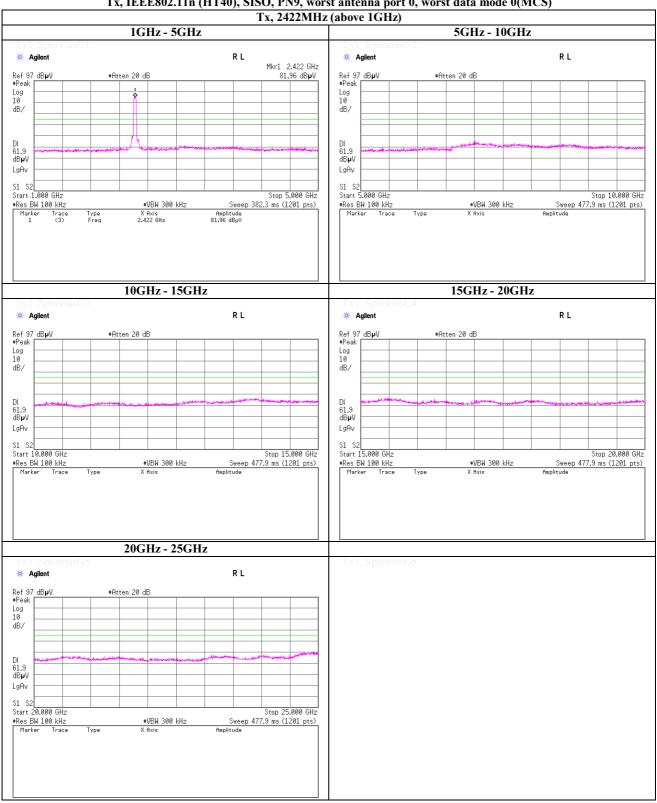
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

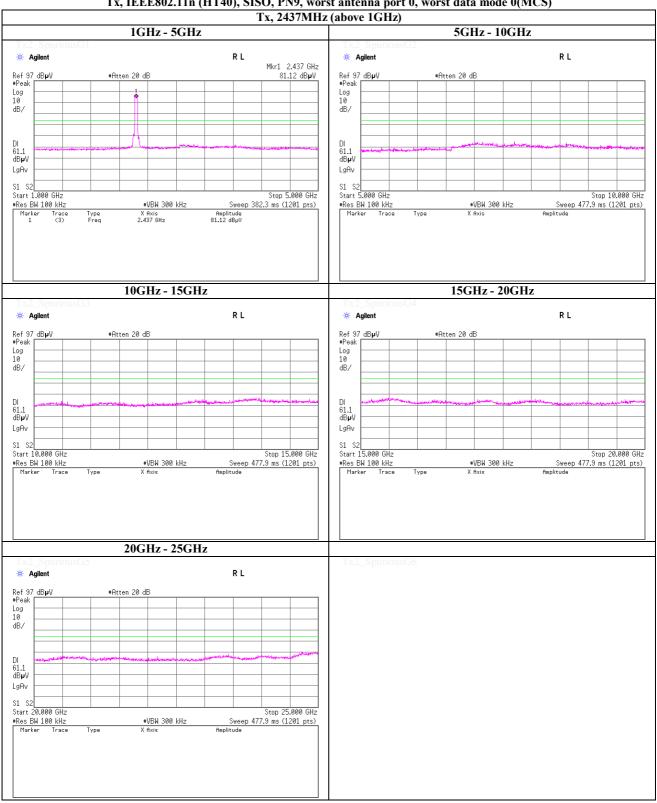
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

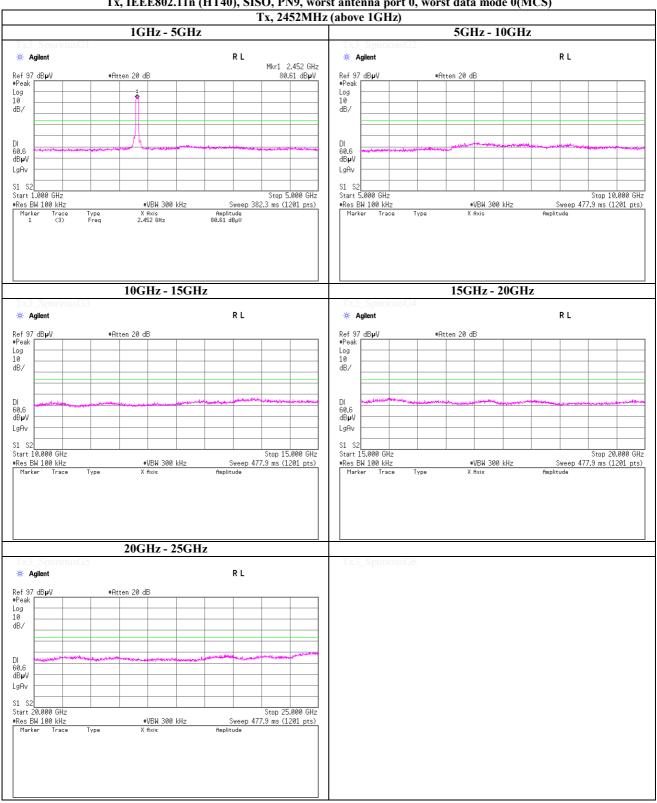
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

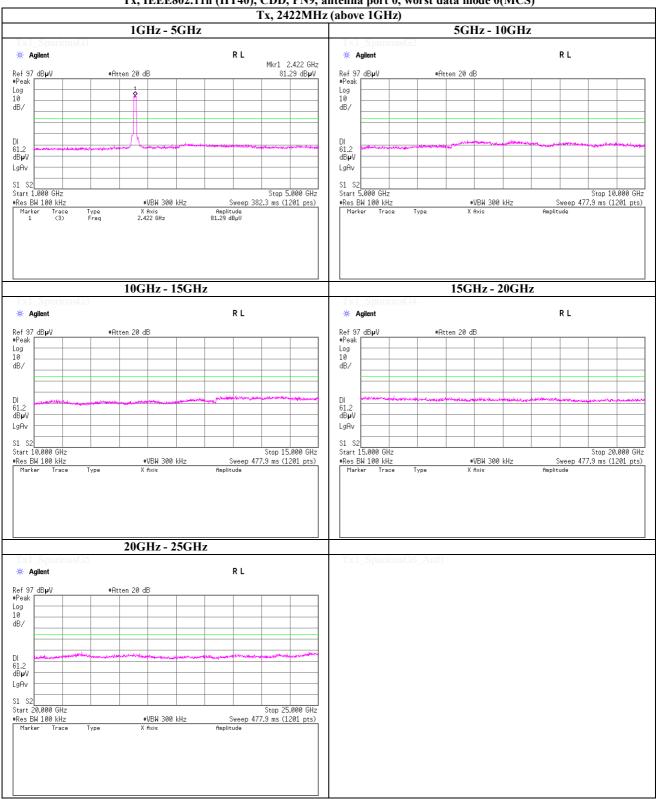
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

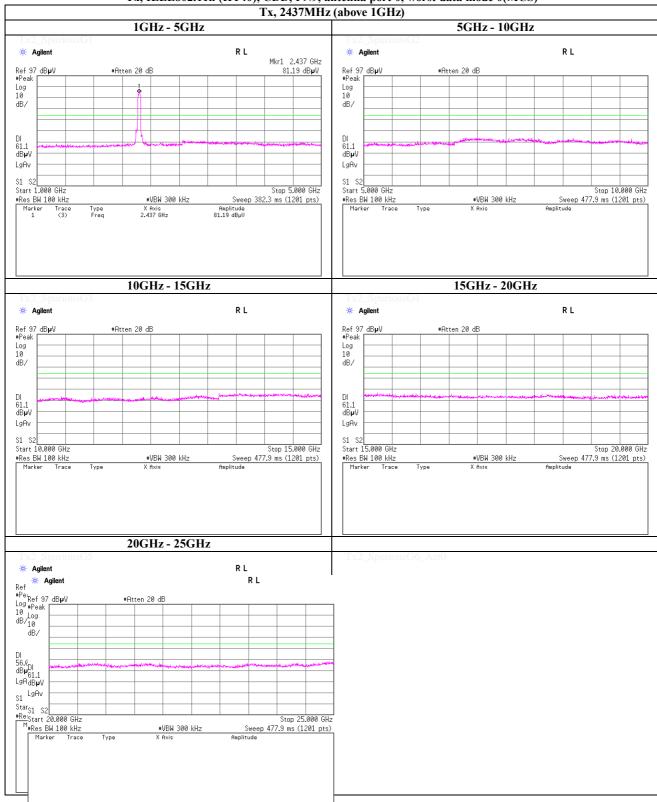
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

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Date January 31, 2014
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Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

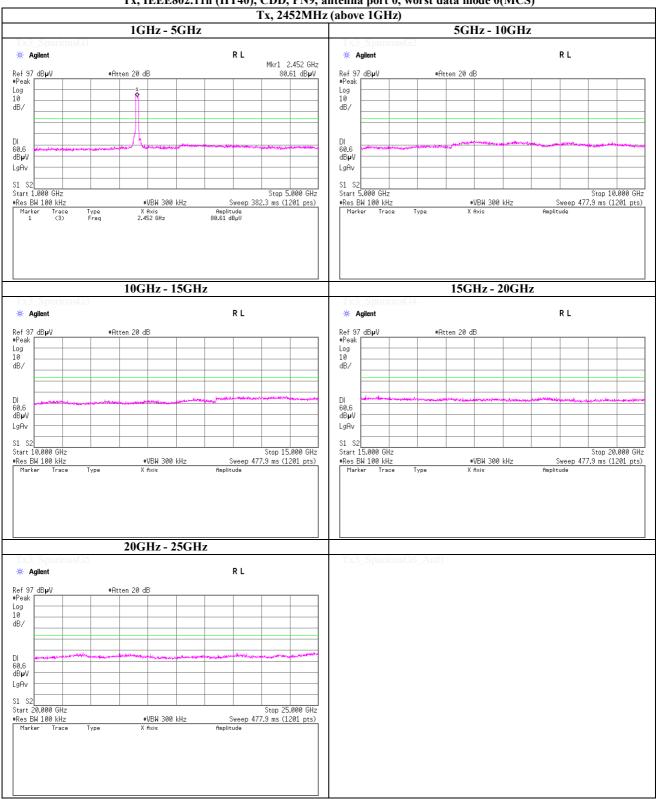
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

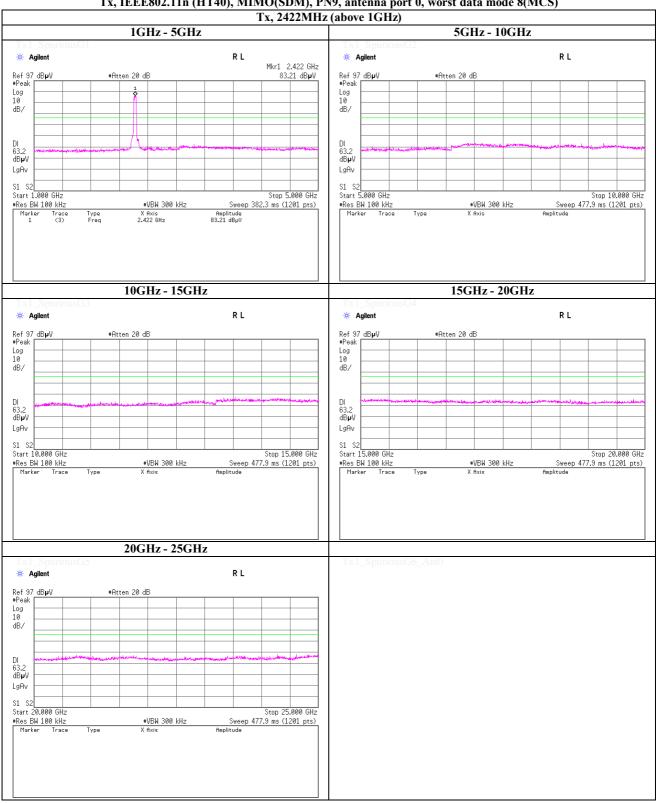
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

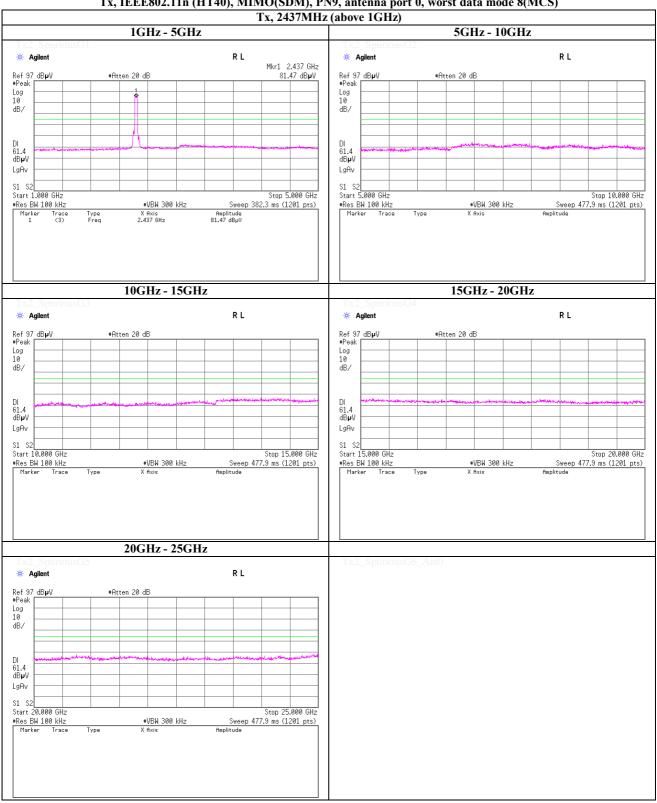
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

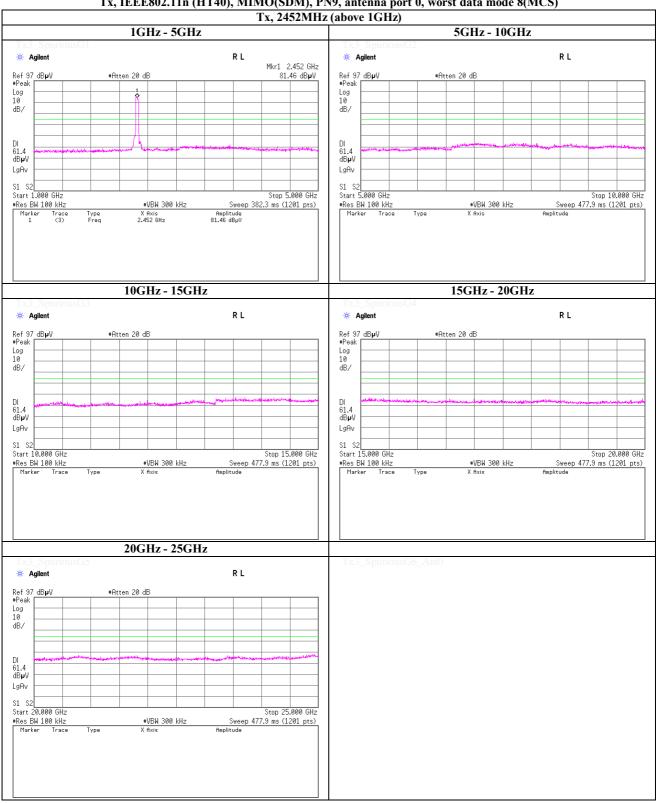
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014 Temperature / Humidity 26deg.C , 44%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

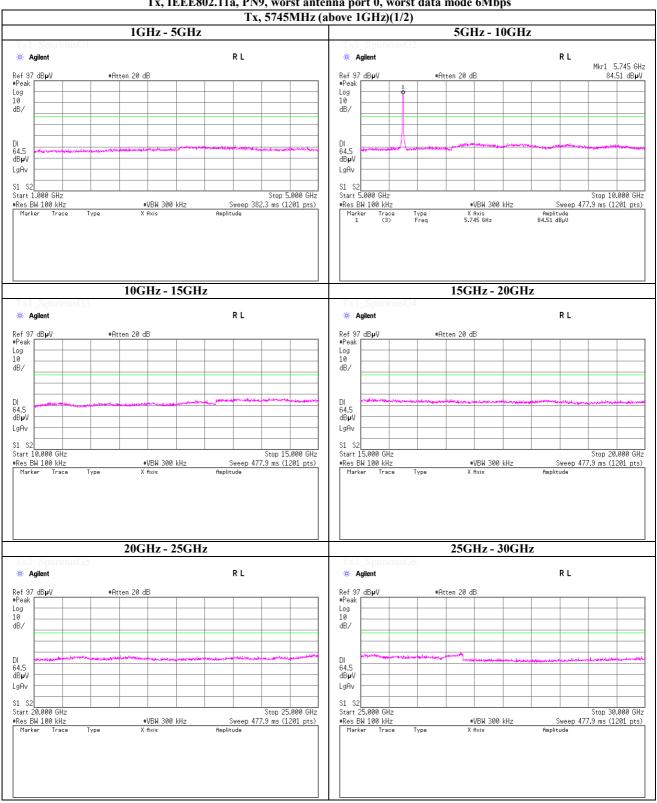
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

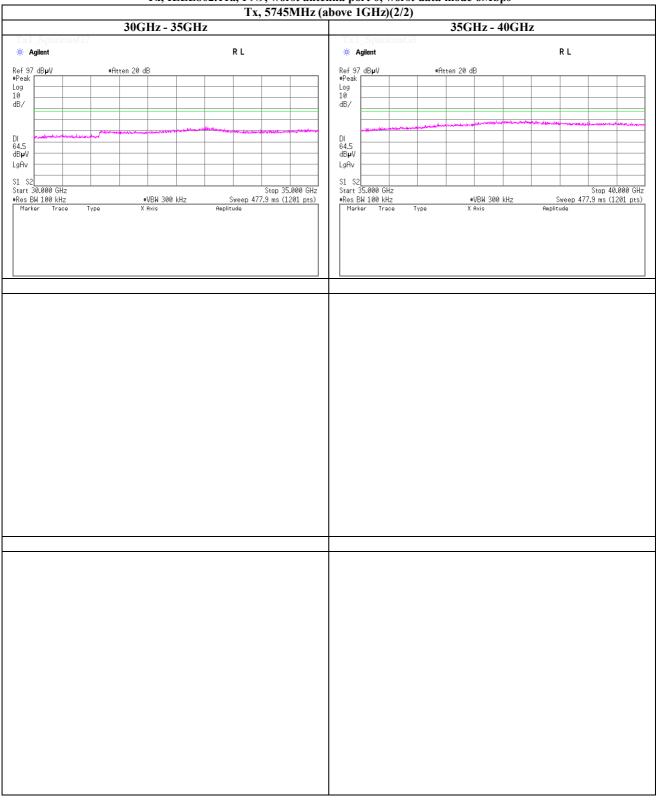
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc. Shonan EMC Lab.

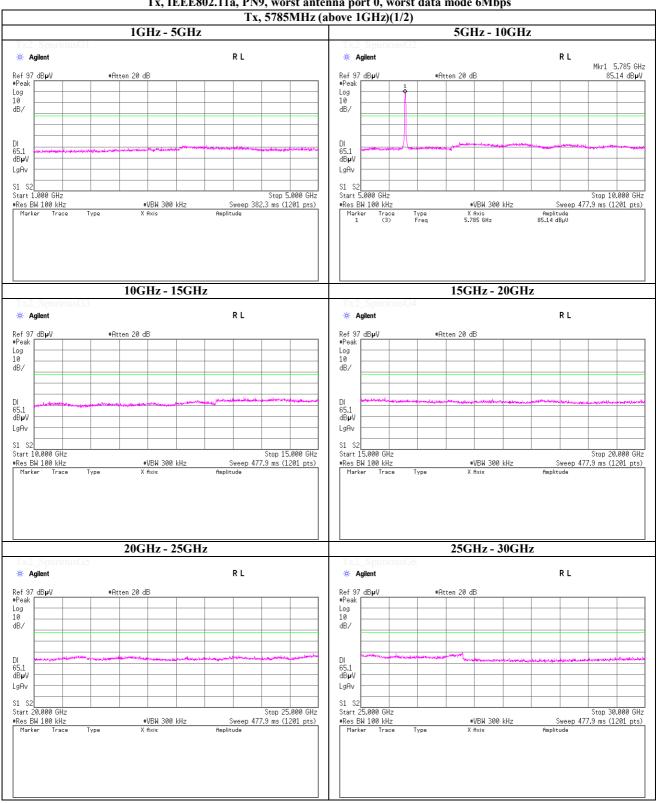
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

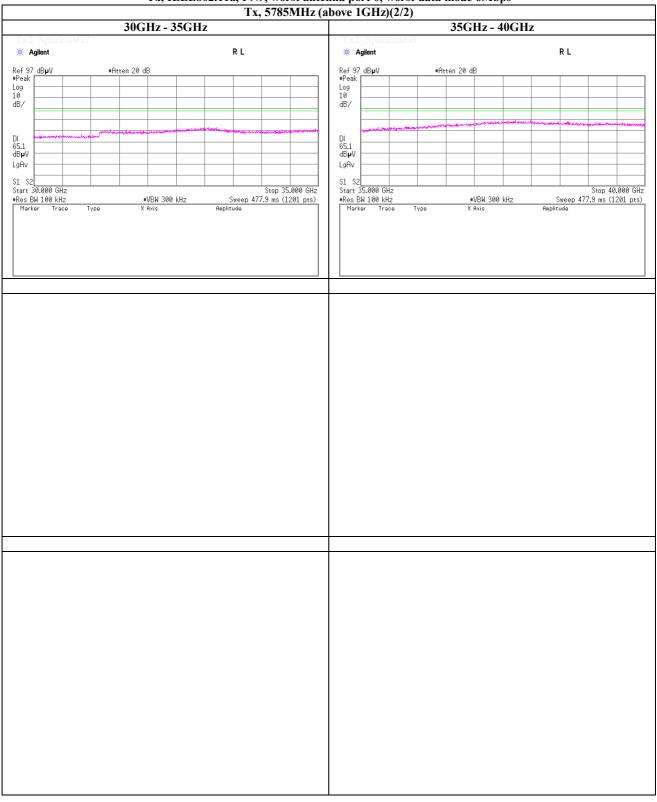
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc.

Shonan EMC Lab.

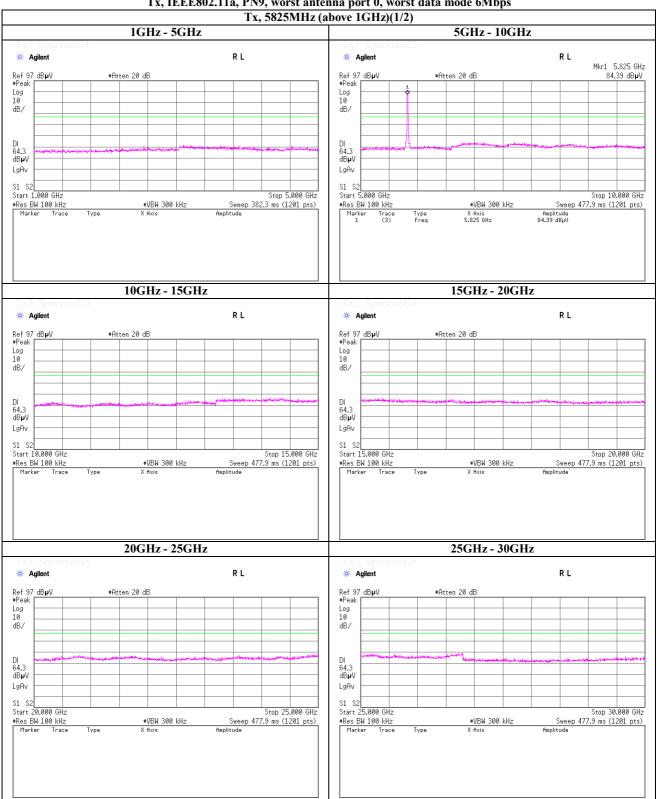
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

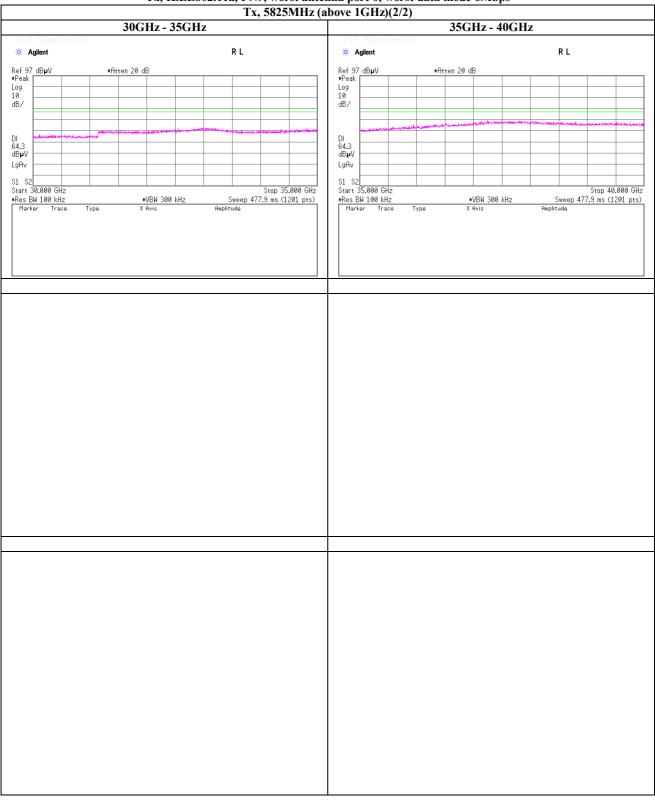
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11a, PN9, worst antenna port 0, worst data mode 6Mbps



UL Japan, Inc.

Shonan EMC Lab.

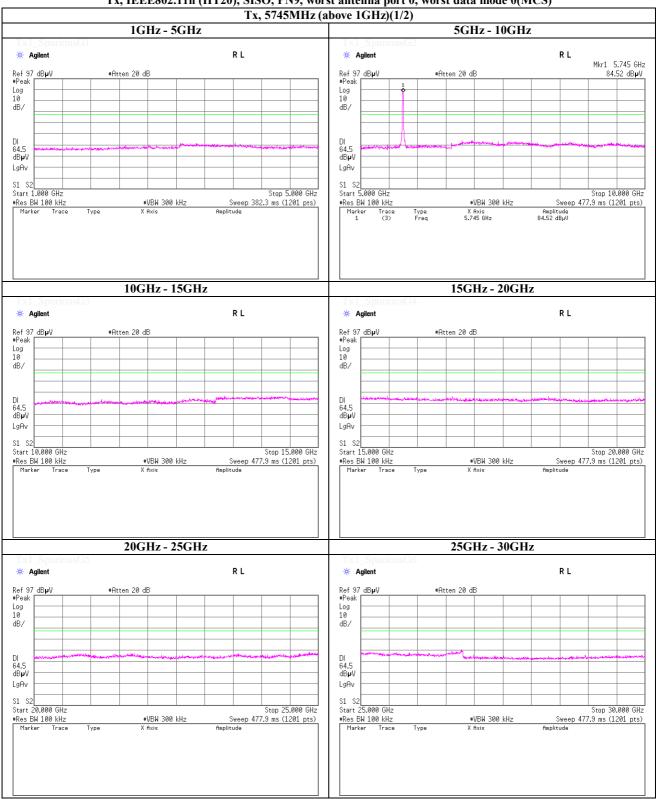
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

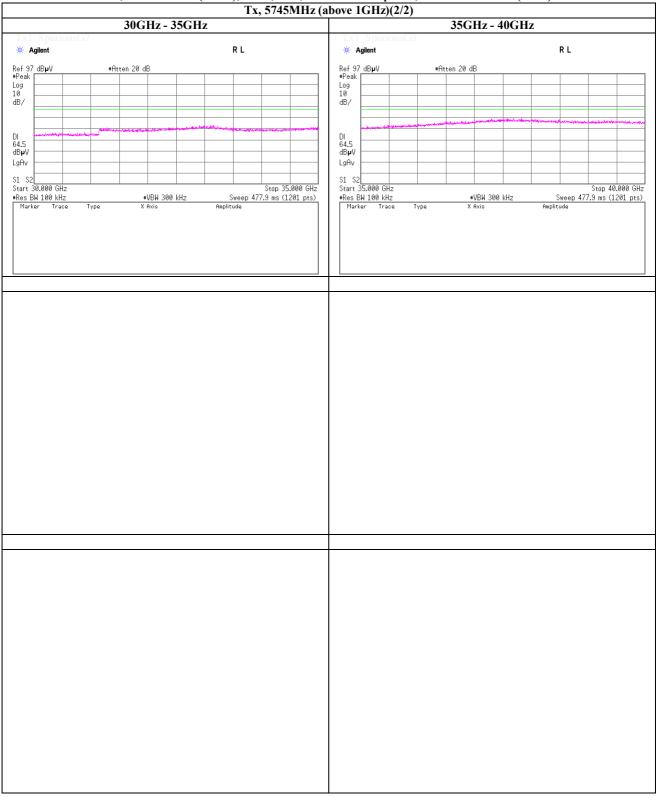
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

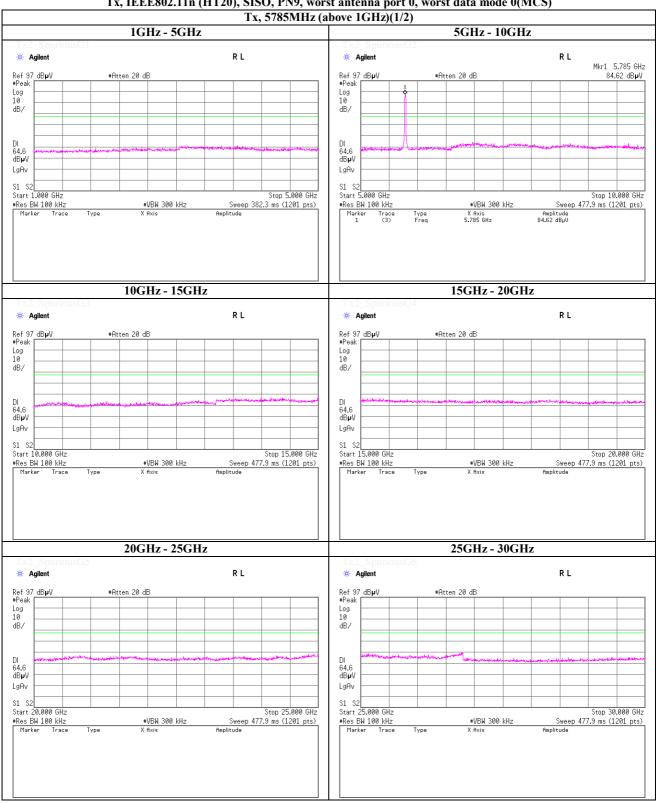
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

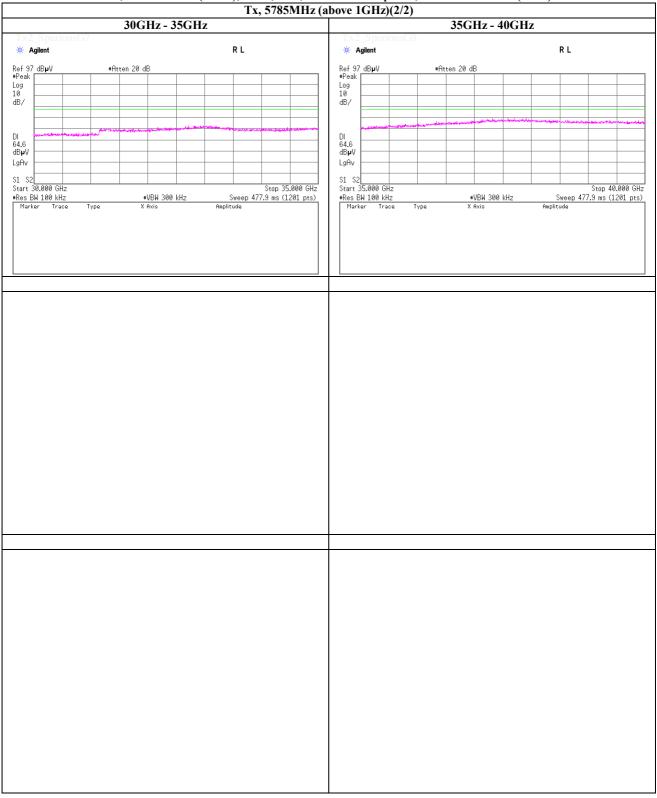
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

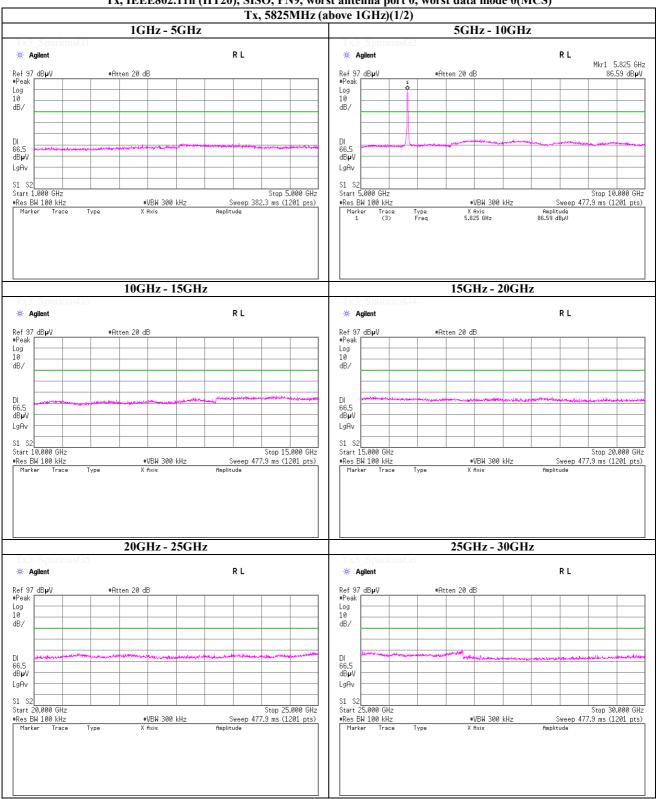
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

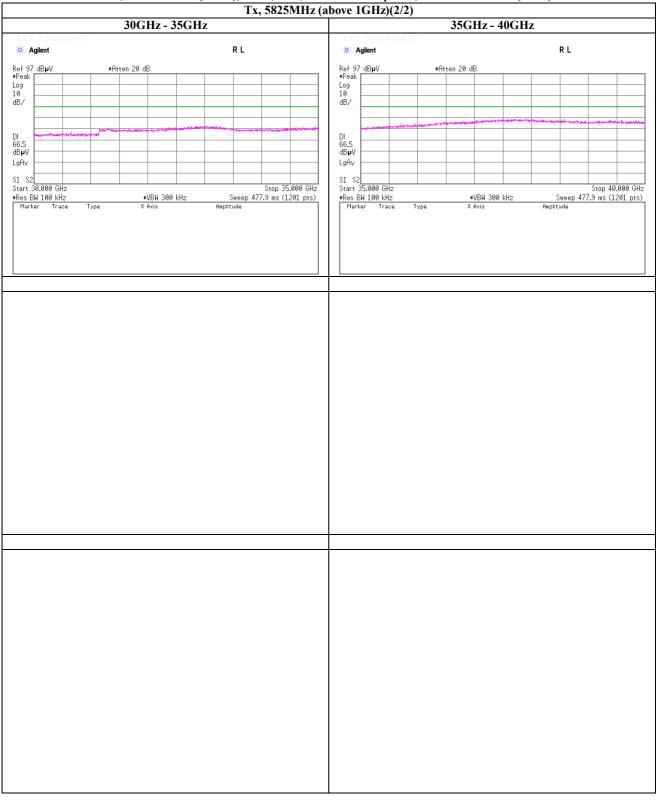
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

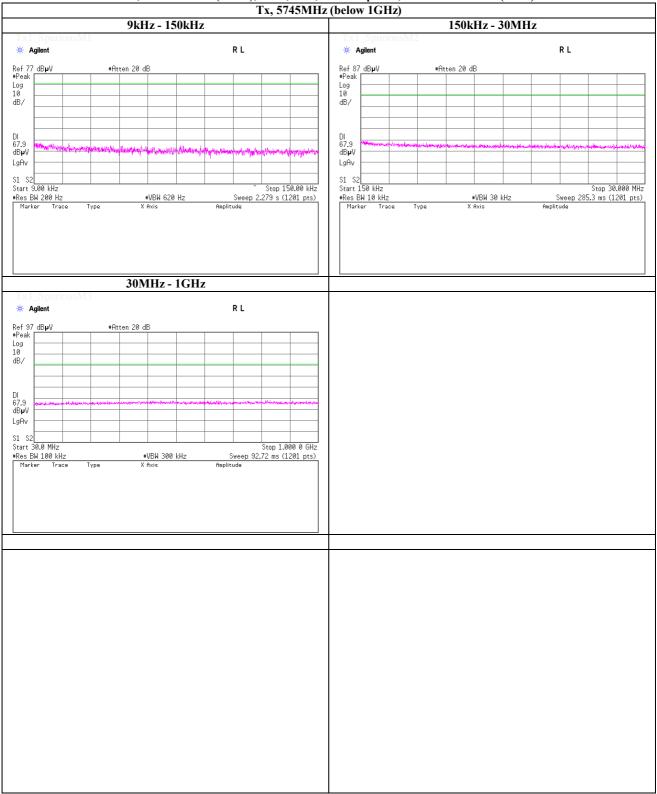
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

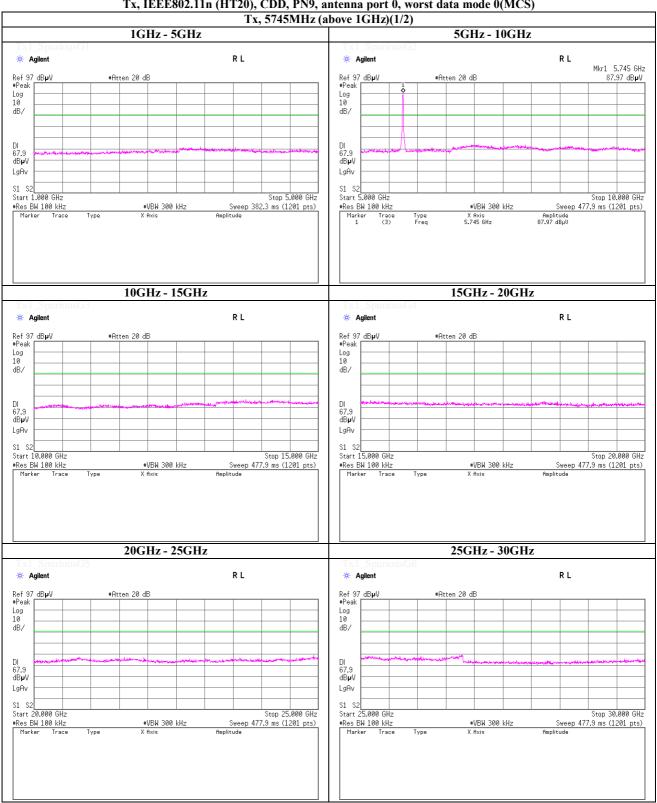
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

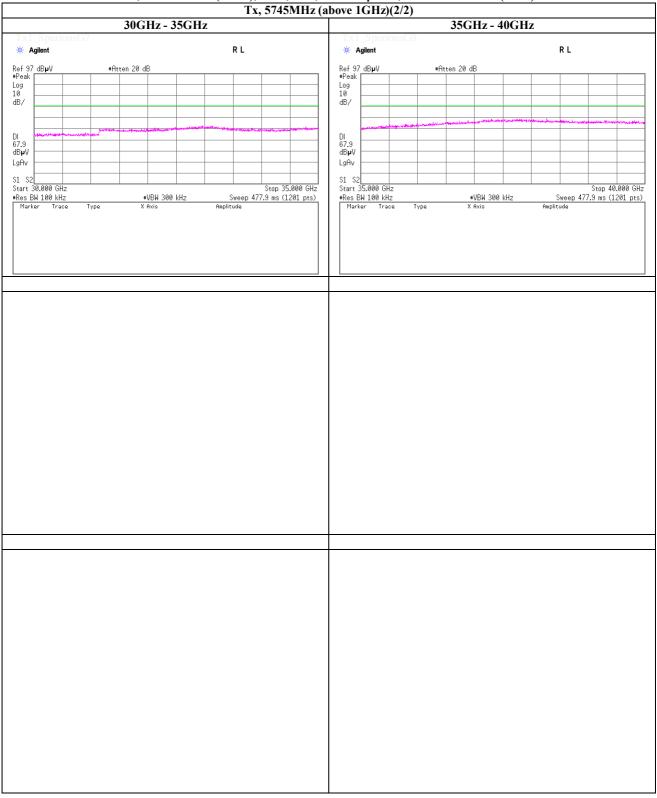
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

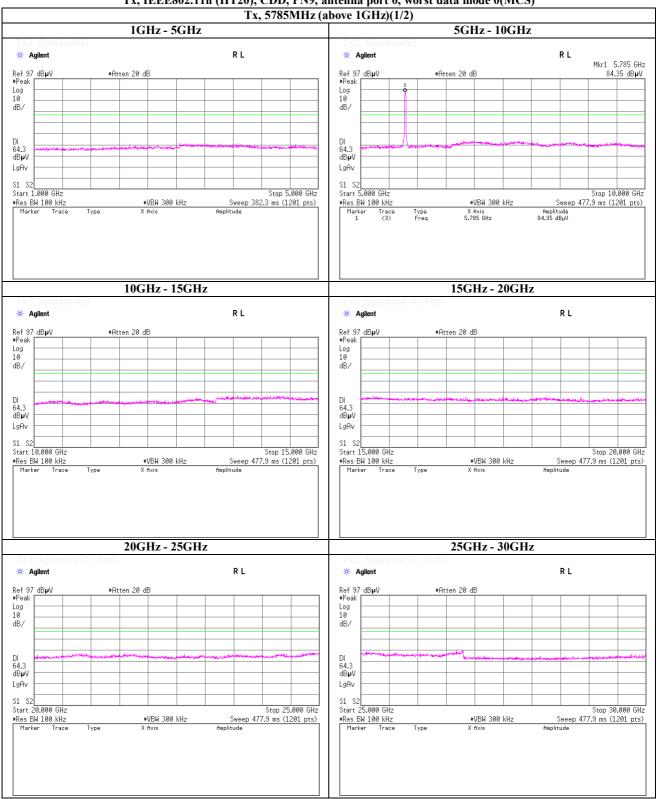
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

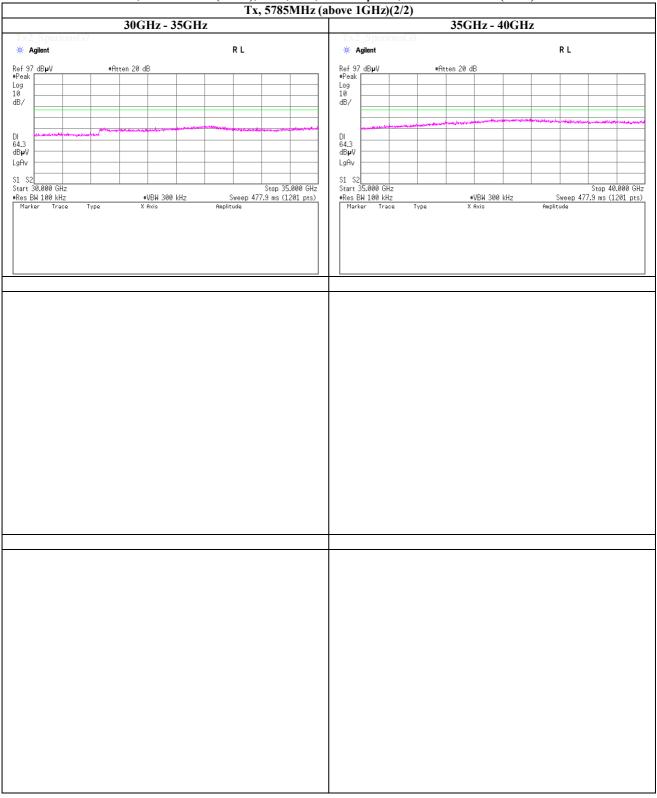
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

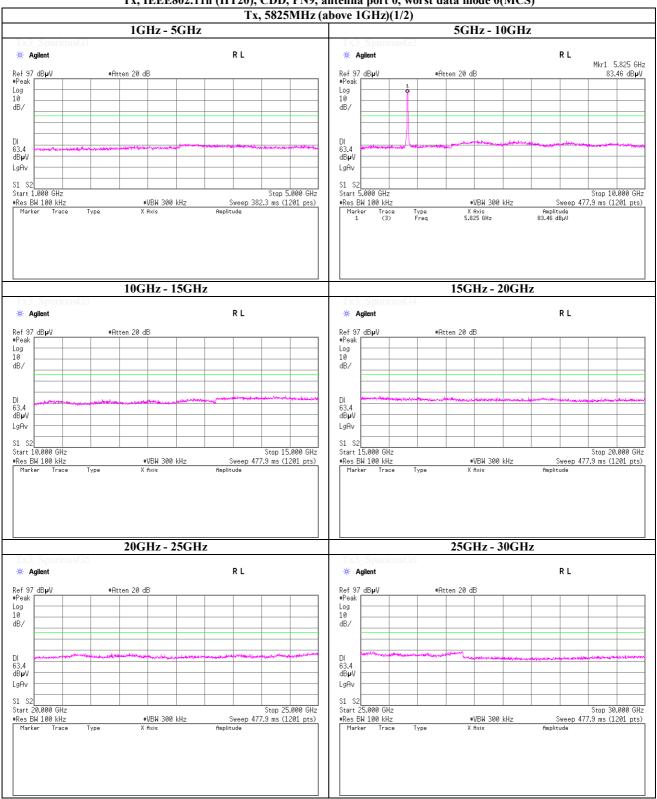
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

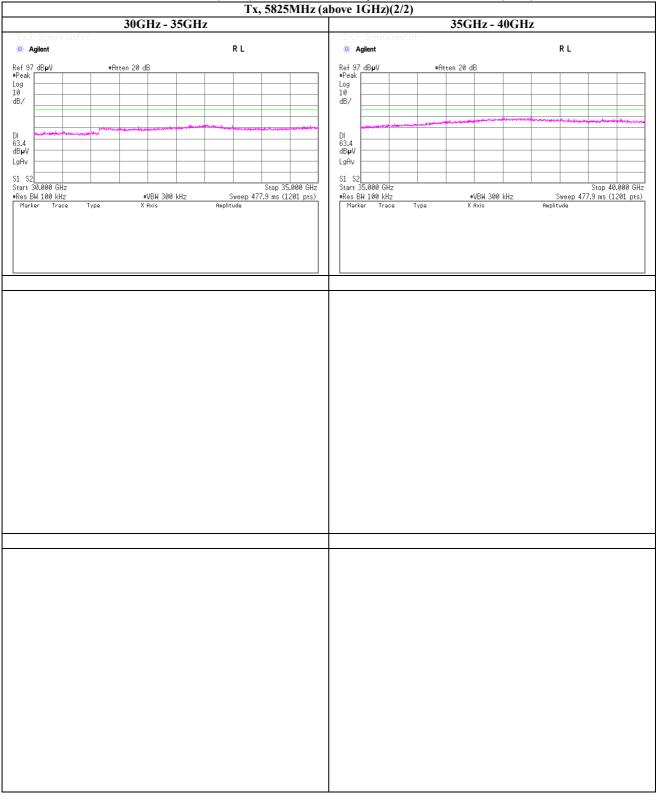
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

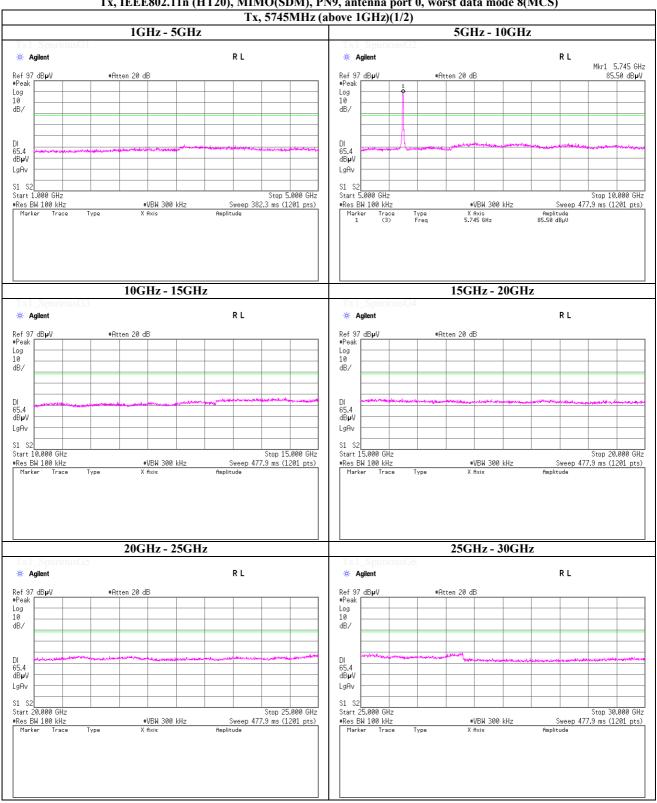
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

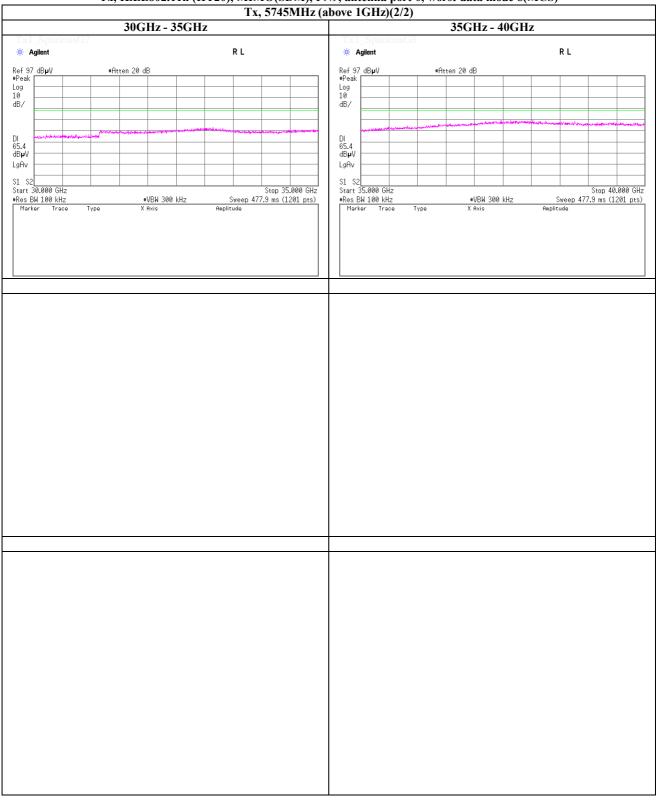
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

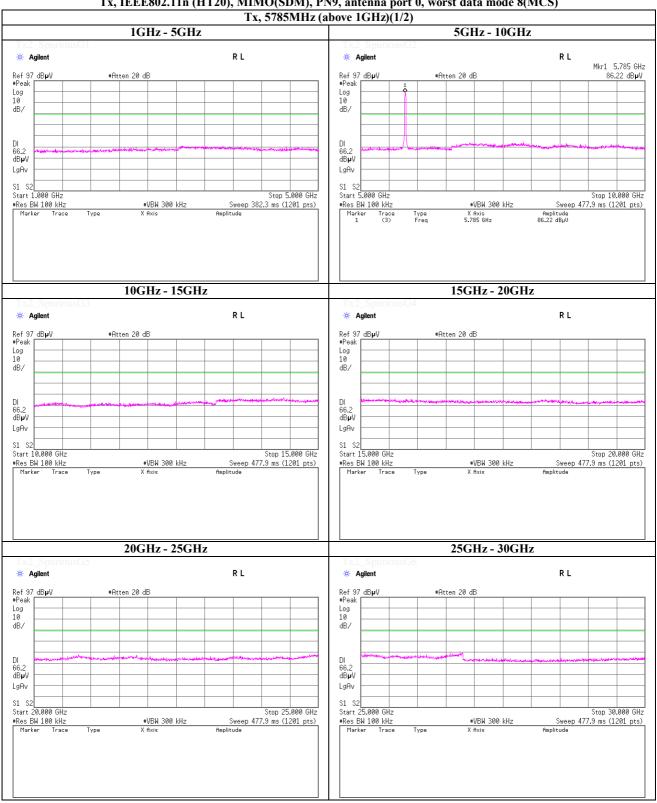
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

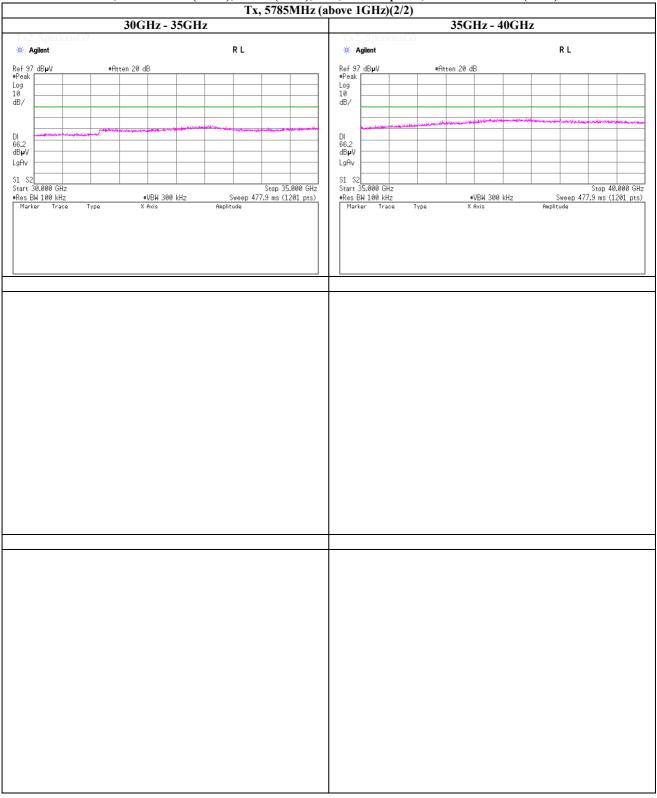
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

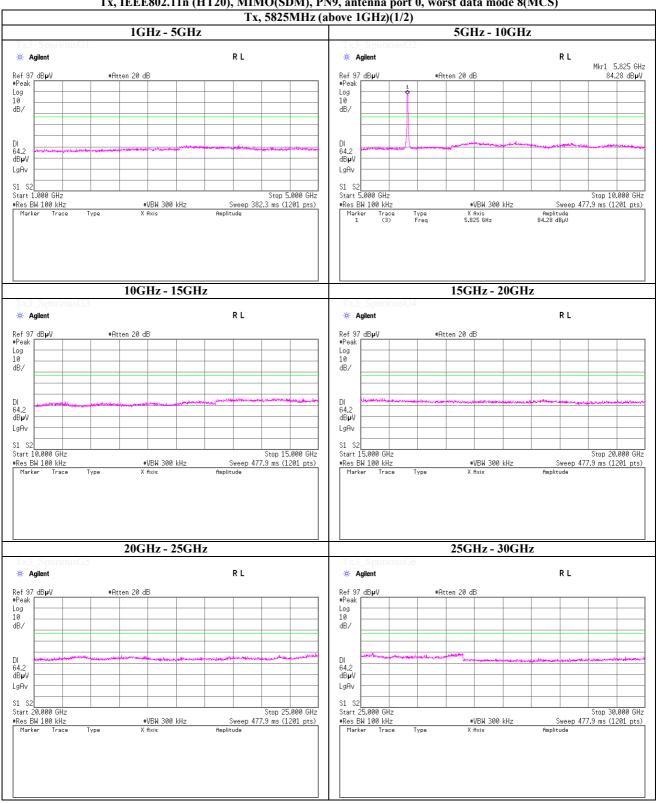
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

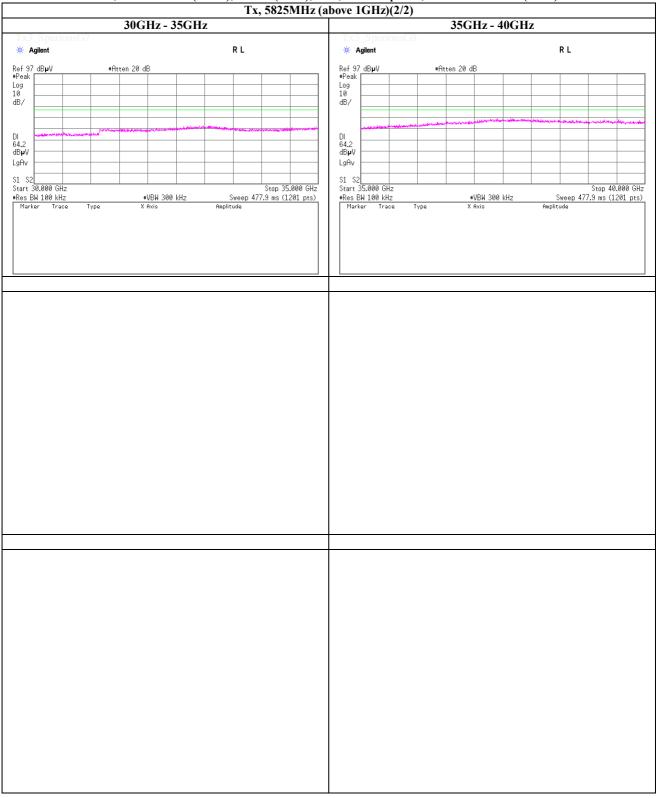
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT20), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

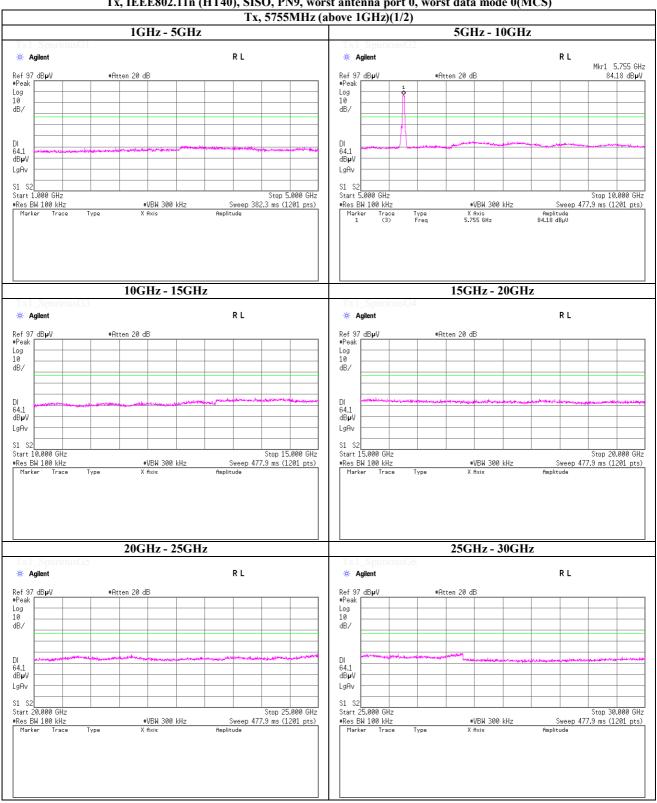
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

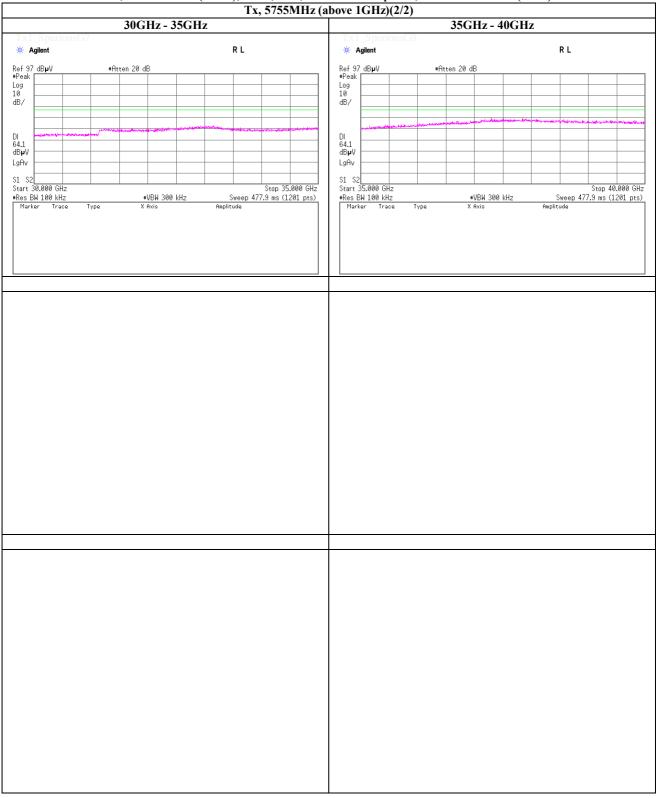
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

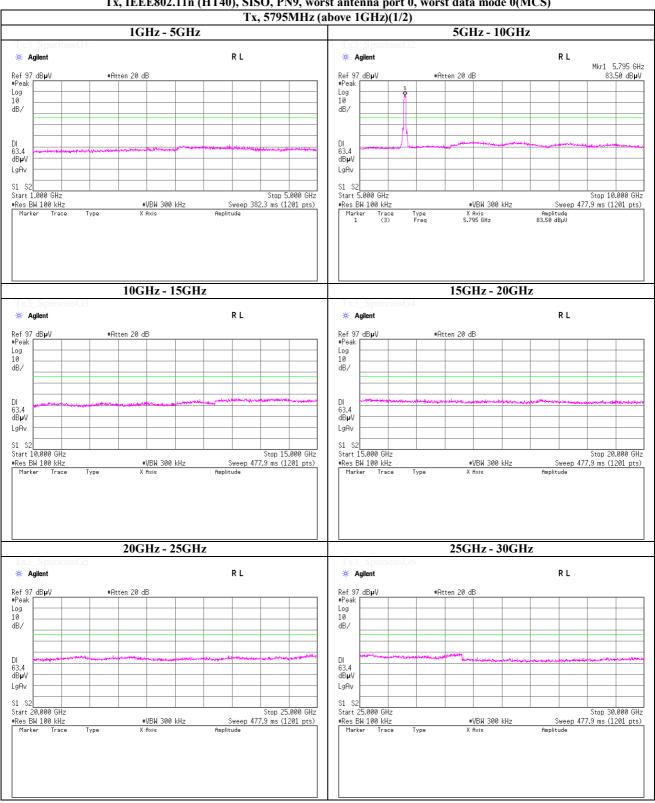
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

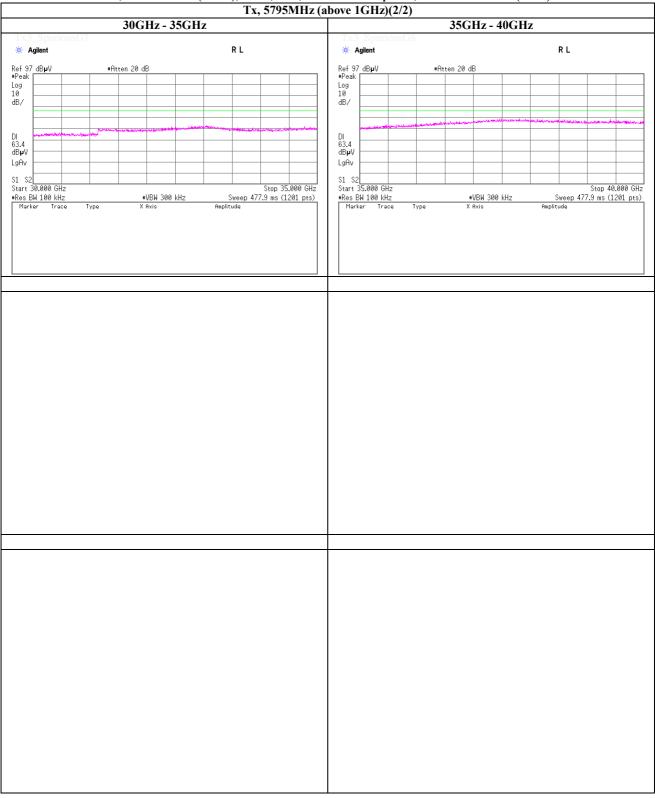
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
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Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), SISO, PN9, worst antenna port 0, worst data mode 0(MCS)



UL Japan, Inc.

Shonan EMC Lab.

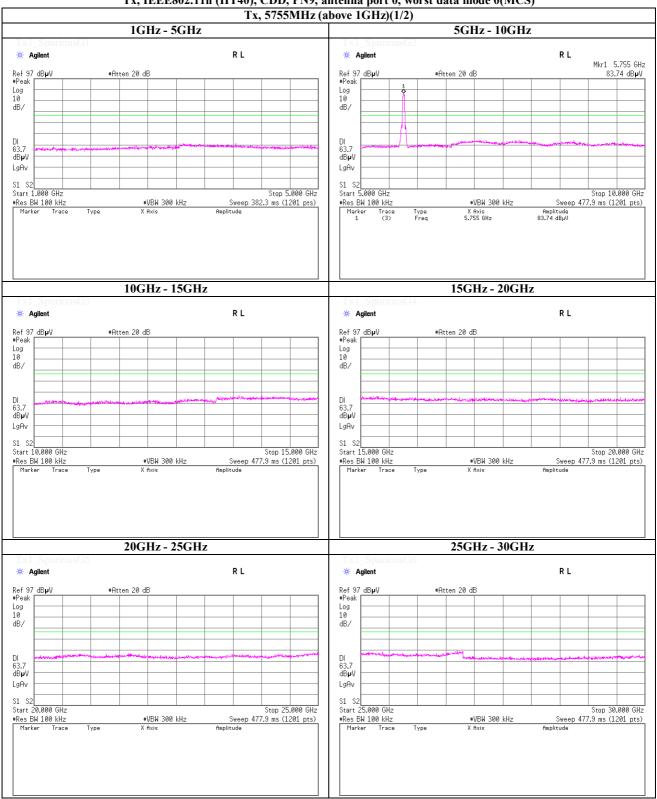
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

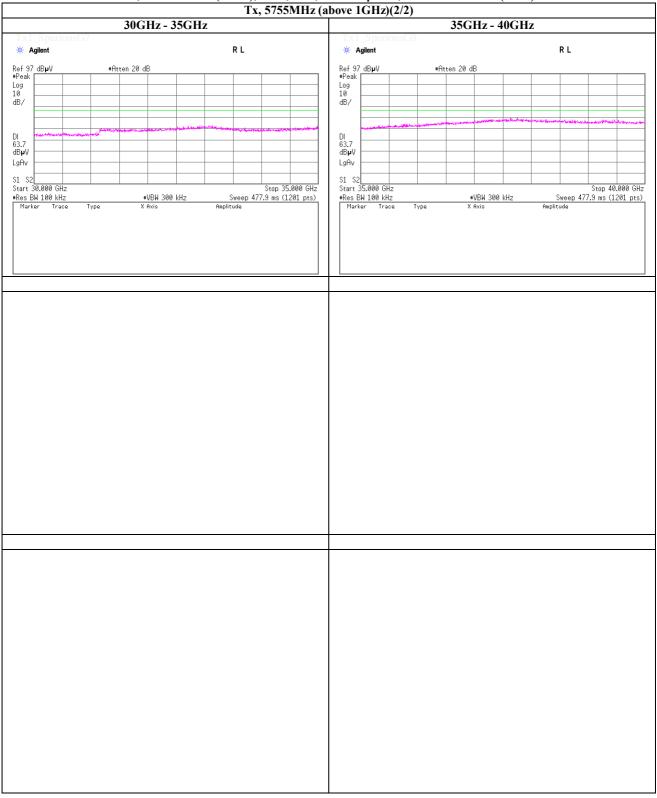
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
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Tx, IEEE802.11n (HT40), CDD, PN9, antenna port 0, worst data mode 0(MCS)



UL Japan, Inc. Shonan EMC Lab.

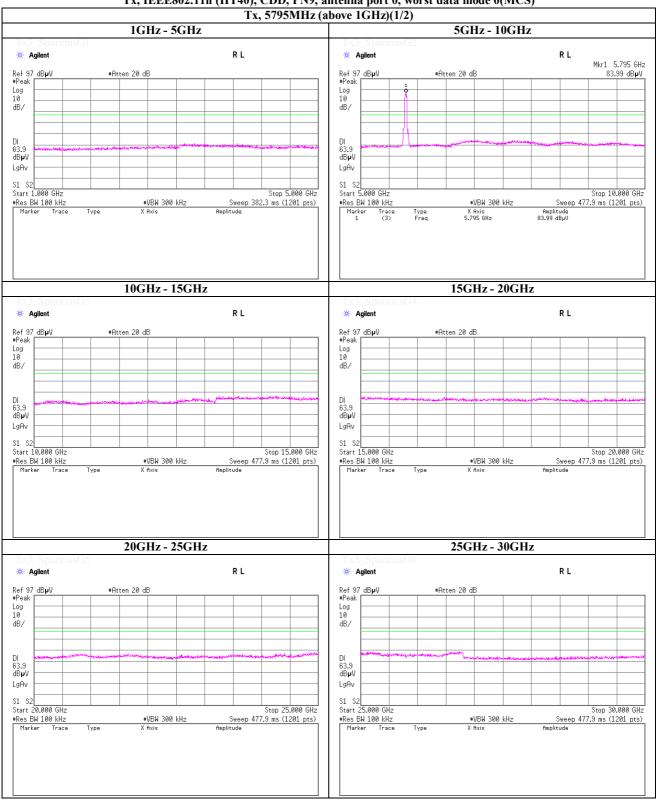
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
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UL Japan, Inc. Shonan EMC Lab.

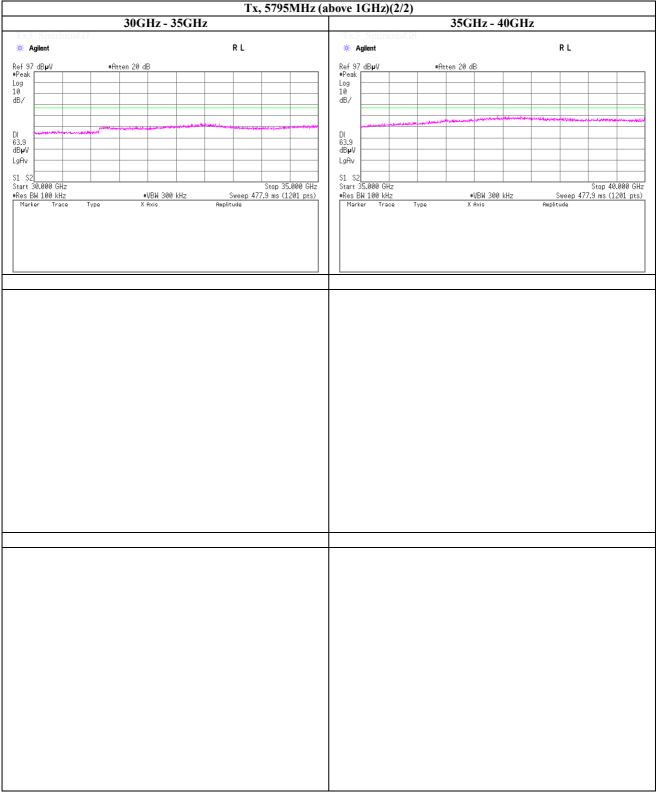
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

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UL Japan, Inc. Shonan EMC Lab.

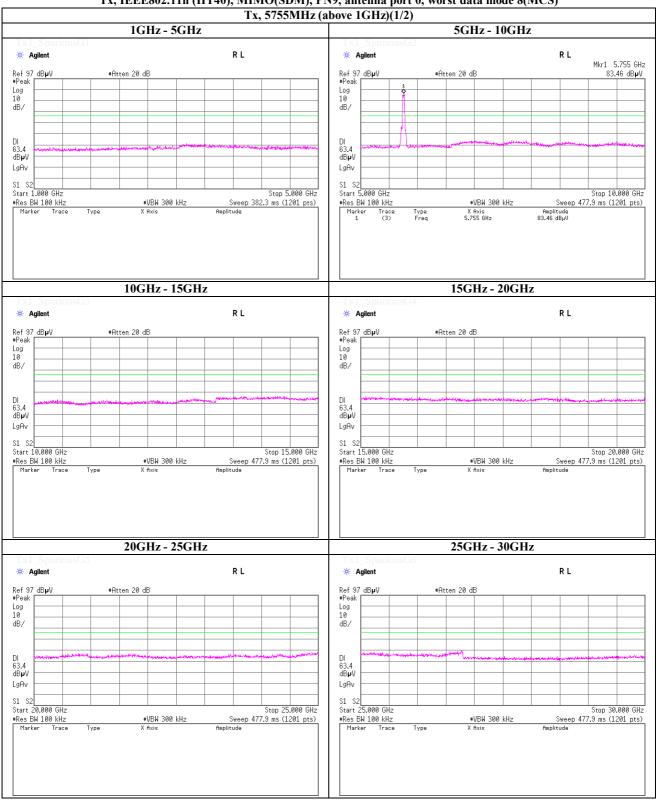
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

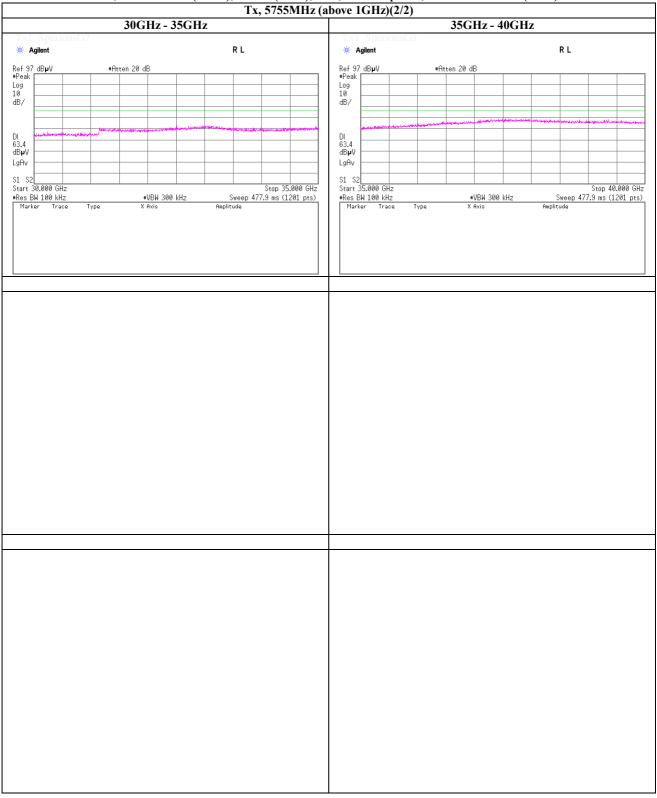
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
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UL Japan, Inc. Shonan EMC Lab.

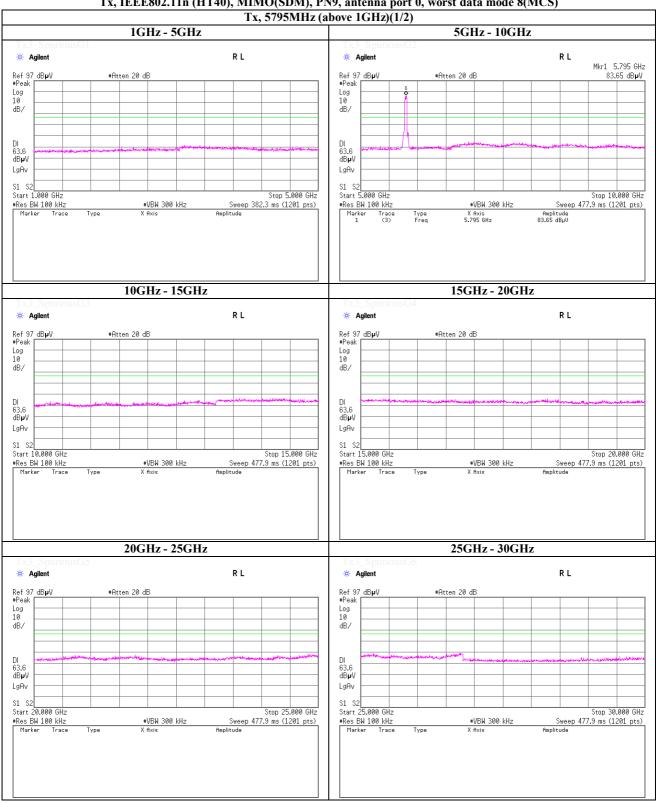
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013 Temperature / Humidity 23deg.C , 38%RH Shinichi Takano Engineer

Spurious emission (Conducted)

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UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

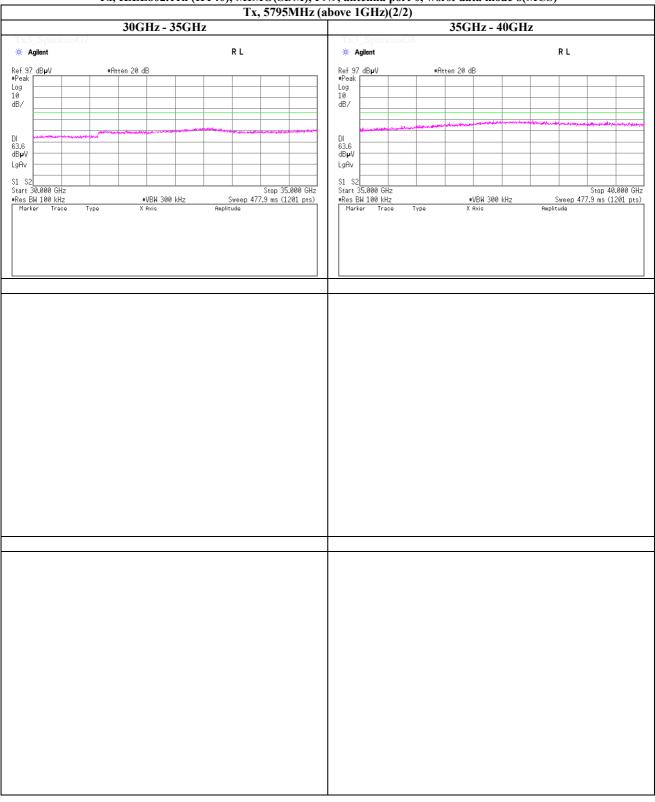
: +81 463 50 6400 **Telephone Facsimile** : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Tx, IEEE802.11n (HT40), MIMO(SDM), PN9, antenna port 0, worst data mode 8(MCS)



UL Japan, Inc.

Shonan EMC Lab.

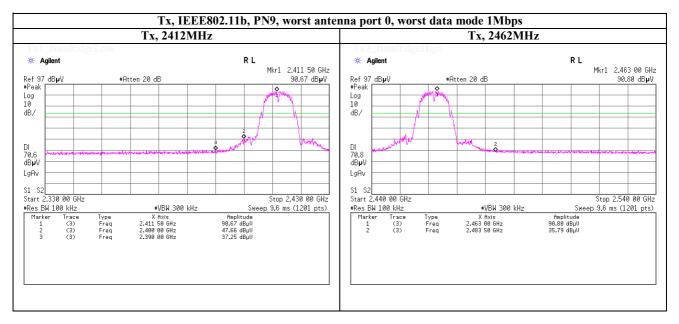
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013
Temperature / Humidity 22deg.C , 31%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Band Edge compliance



UL Japan, Inc. Shonan EMC Lab.

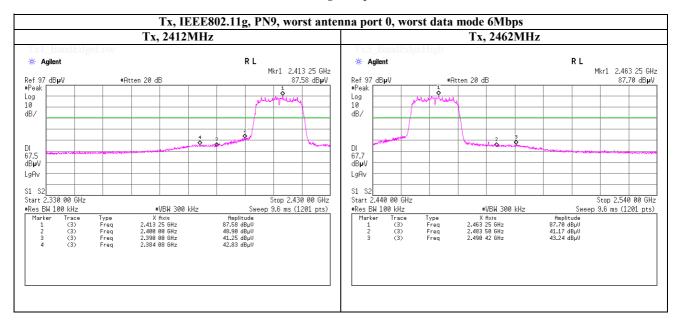
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date February 7, 2013
Temperature / Humidity 22deg.C , 31%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Band Edge compliance



UL Japan, Inc. Shonan EMC Lab.

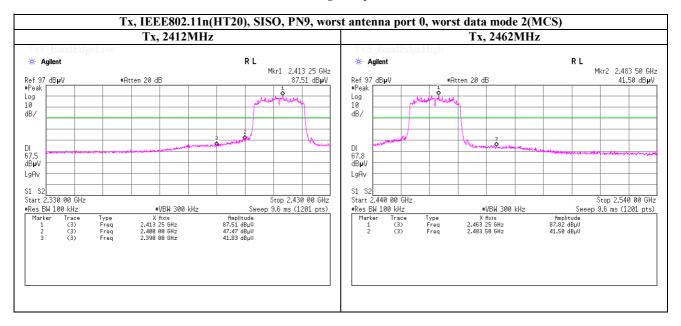
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Band Edge compliance



UL Japan, Inc. Shonan EMC Lab.

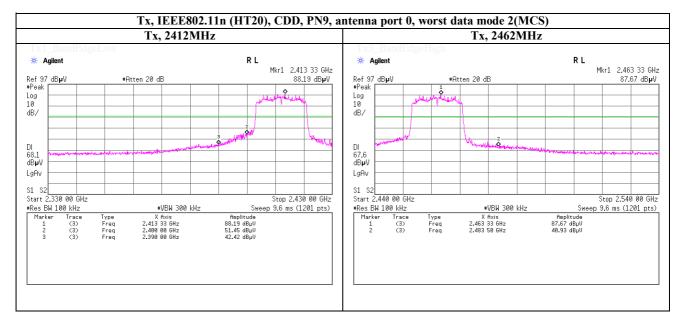
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Band Edge compliance



UL Japan, Inc. Shonan EMC Lab.

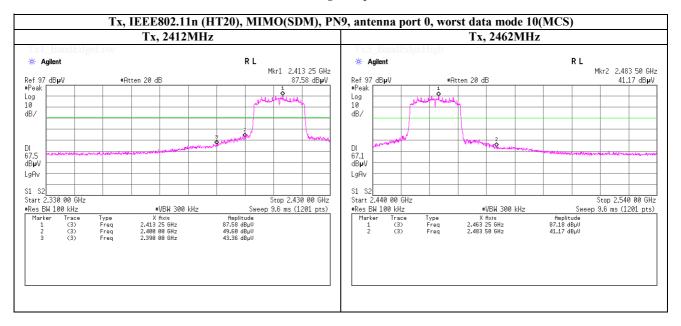
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Band Edge compliance



UL Japan, Inc. Shonan EMC Lab.

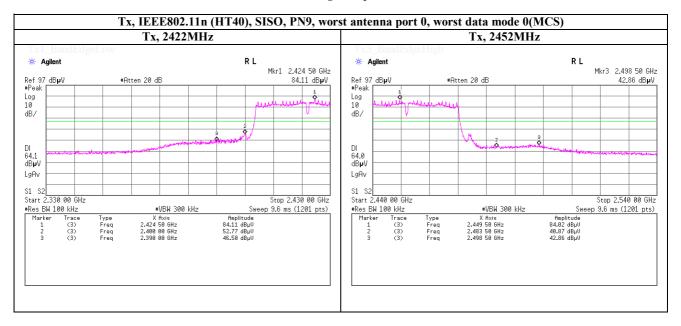
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Test place UL Japan, Inc. Shonan EMC Lab. No.5 Shielded Room

Date January 31, 2014
Temperature / Humidity 26deg.C , 44%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Band Edge compliance



UL Japan, Inc. Shonan EMC Lab.

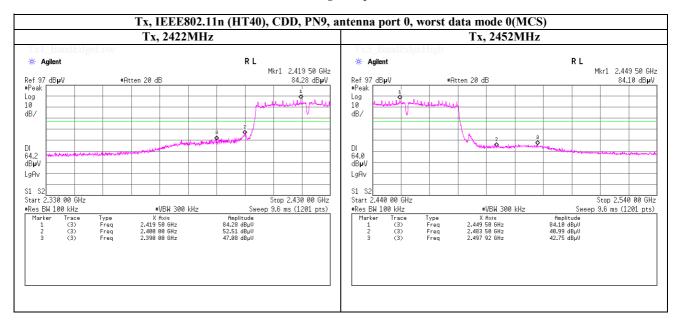
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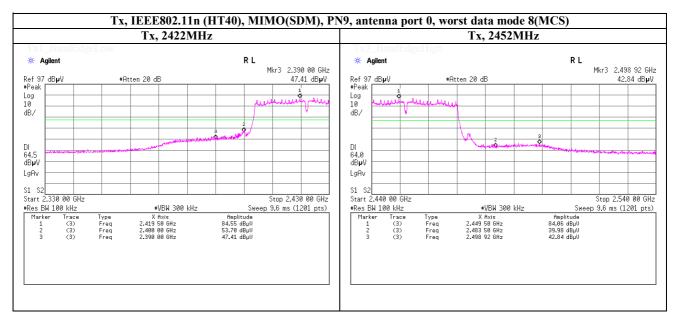
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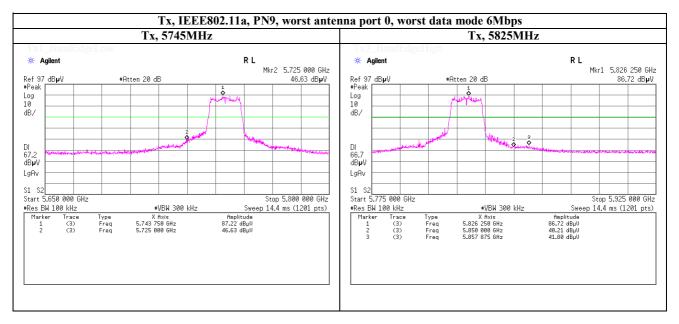
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Date November 12, 2013
Temperature / Humidity 23deg.C , 38%RH
Engineer Shinichi Takano

Spurious emission (Conducted)

Band Edge compliance



UL Japan, Inc. Shonan EMC Lab.

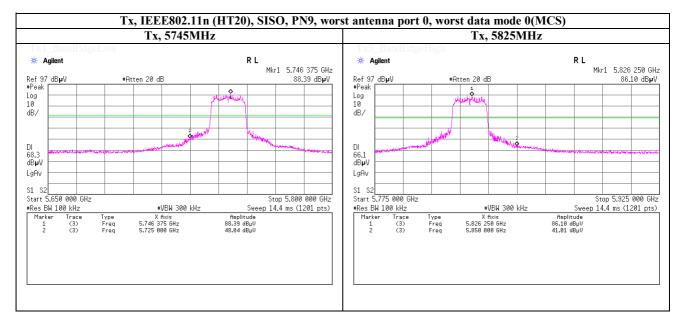
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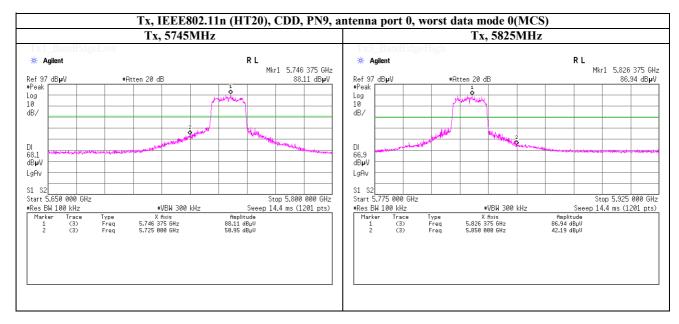
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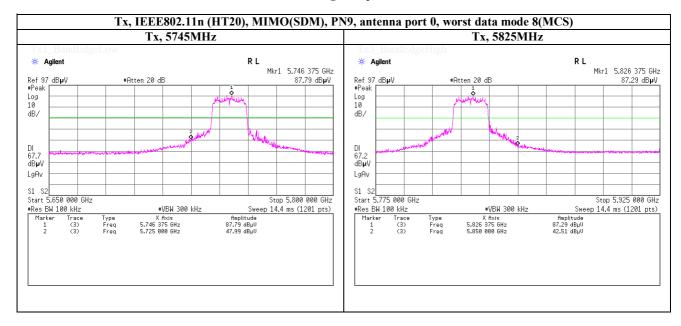
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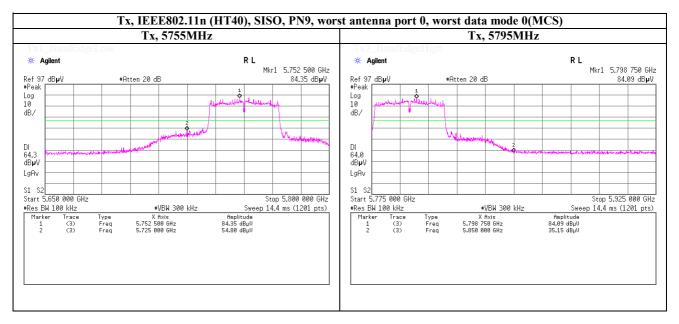
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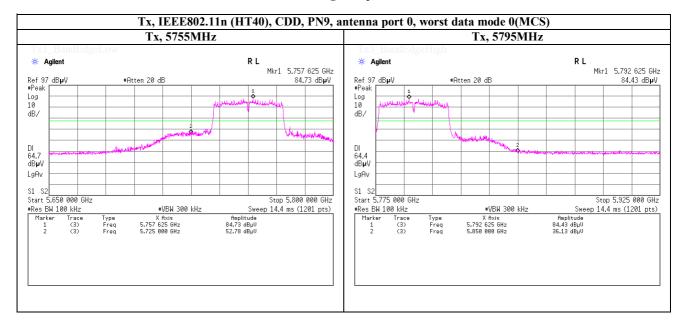
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